

Ionization

The Townsend (symbol Td) is a physical unit of the reduced electric field (ratio E/N), where E is electric field and N is concentration of neutral particles. It is named after John Sealy Townsend, who conducted early research into gas ionization.

Energy levels He

Grotrian diagram He

Ionization energy He

24.46eV

24.46eV \rightarrow $\sim 198400 \text{ cm}^{-1}$ \rightarrow $\sim 50 \text{ nm}$
vacuum ultraviolet

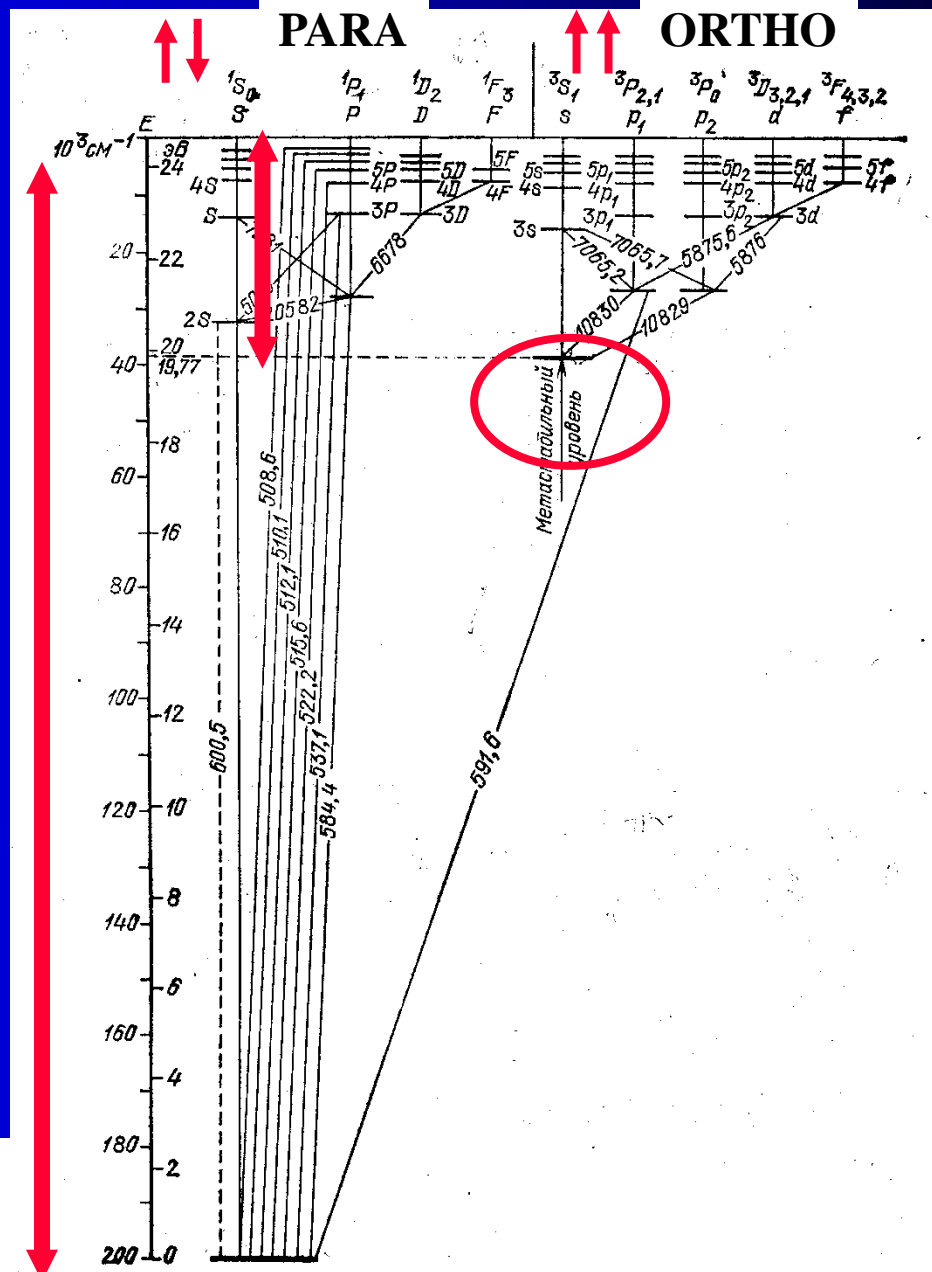


Рис. 3.8. Схема уровней атома He

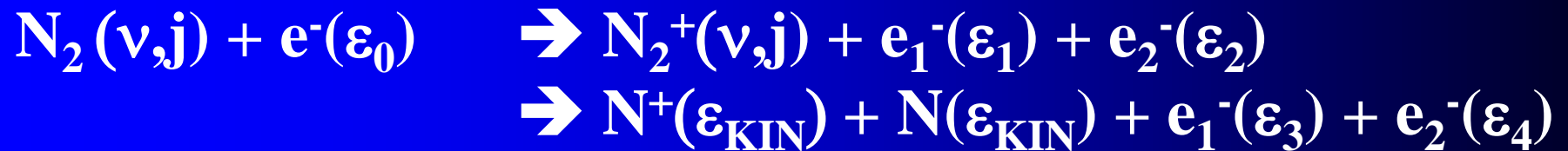
Ionization cross section

Ionization by electron impact

Atoms



Molecules

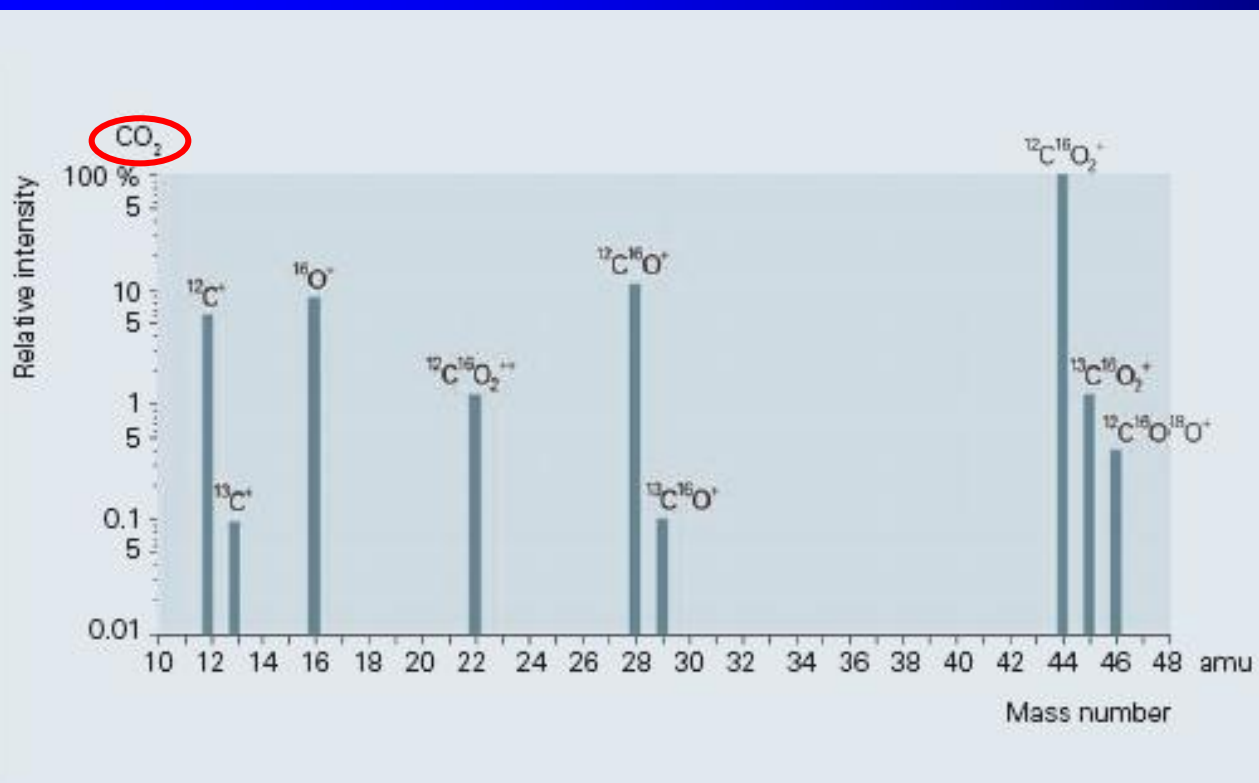


Ionization by electron impact

Interaction of electrons with atoms and molecules

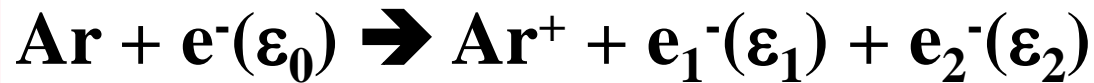
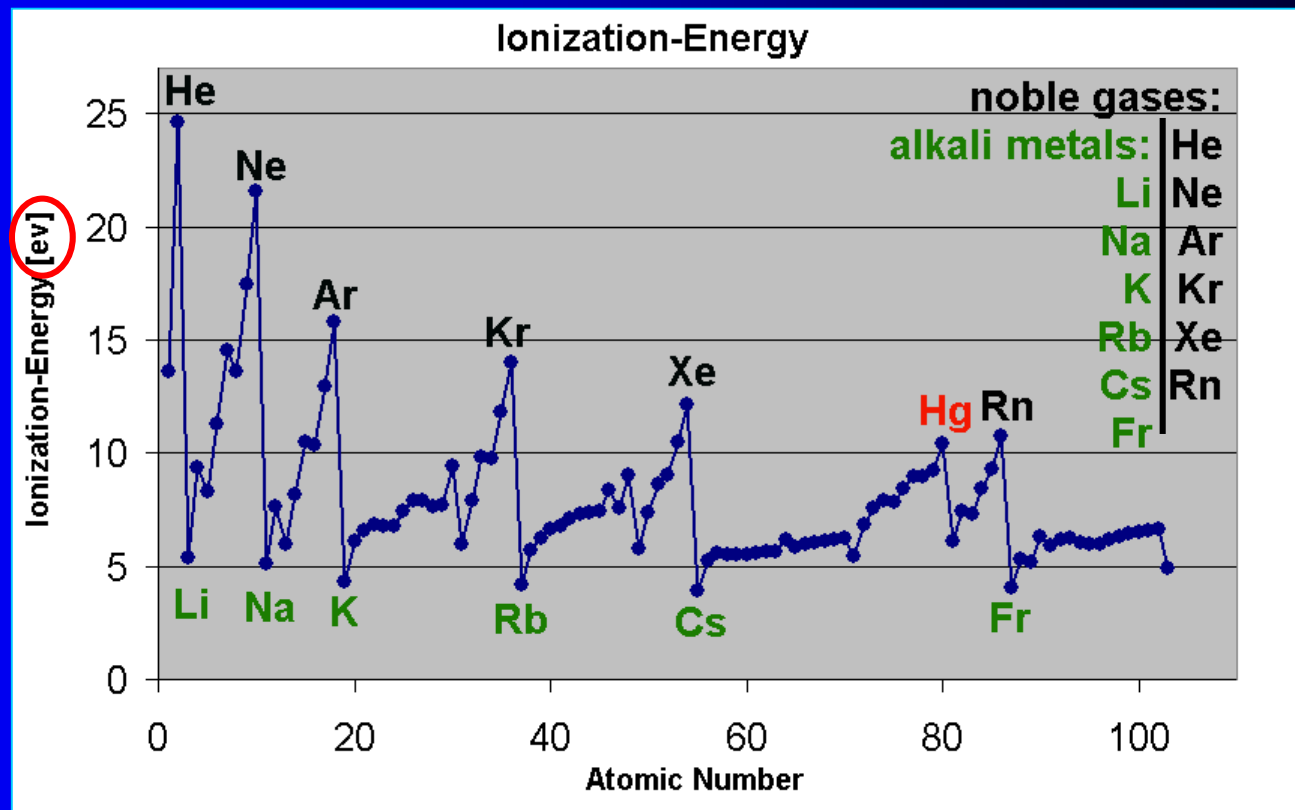
Ionization by electron impact

Excitation by electron impact

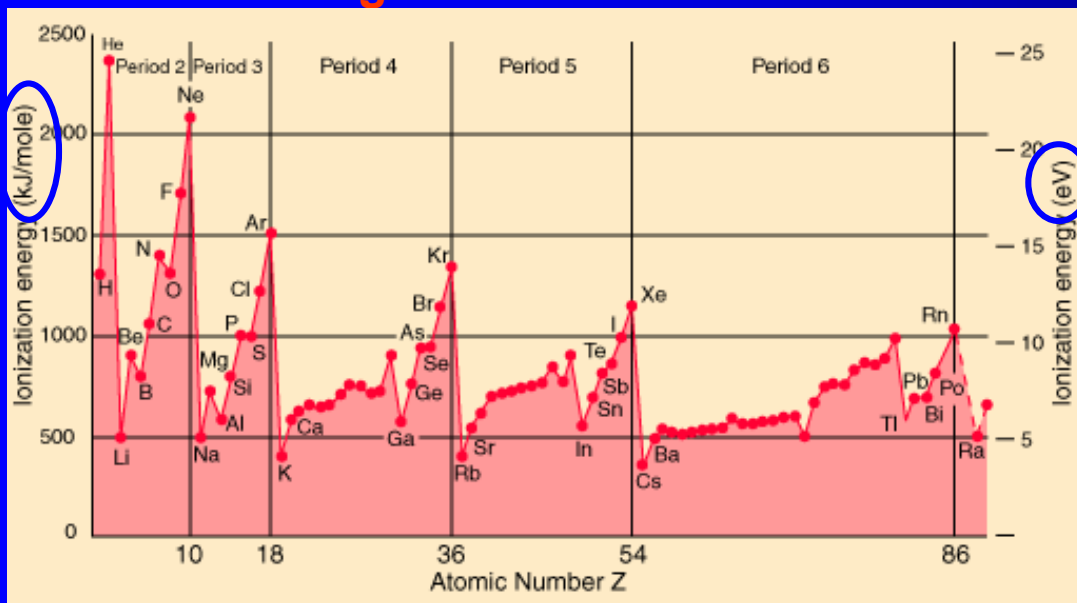


N_2	28.0062
CO	27.9949
C_2H_4	28.0312

Ionization energies



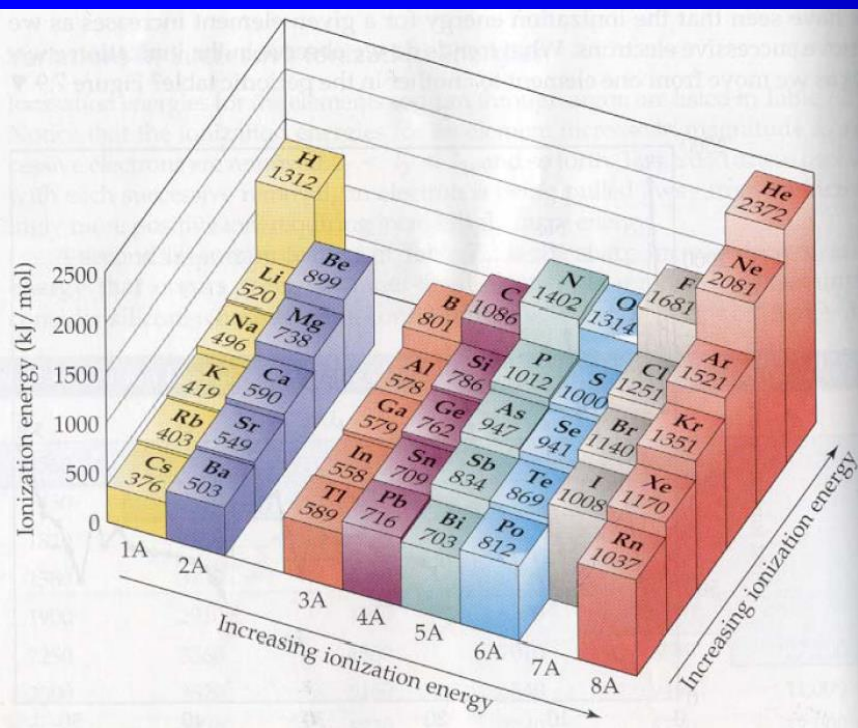
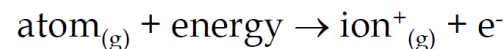
Ionization energies



Ionization Energy

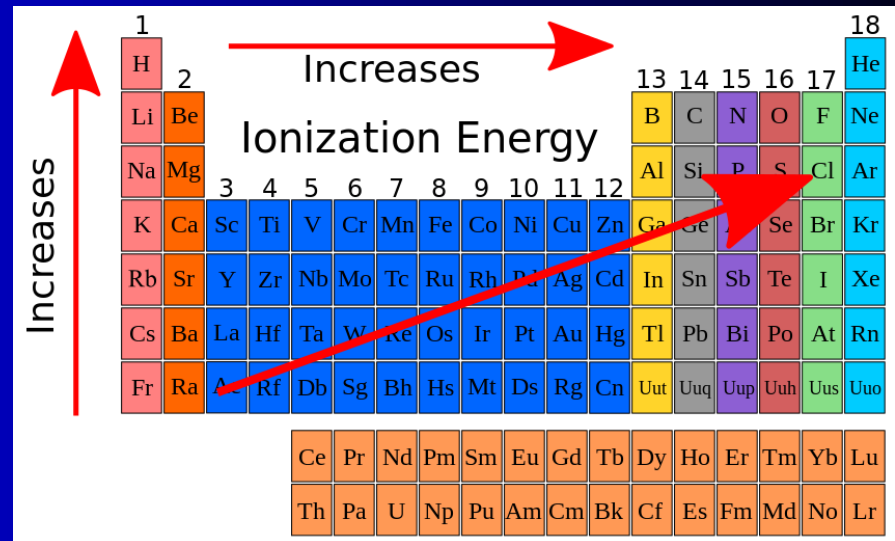
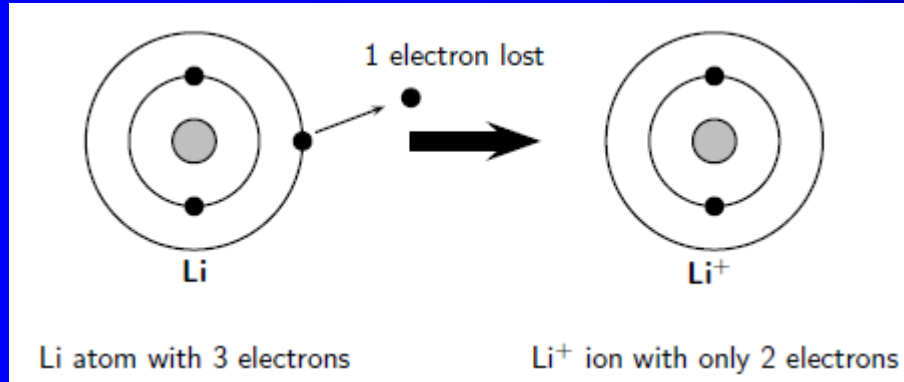
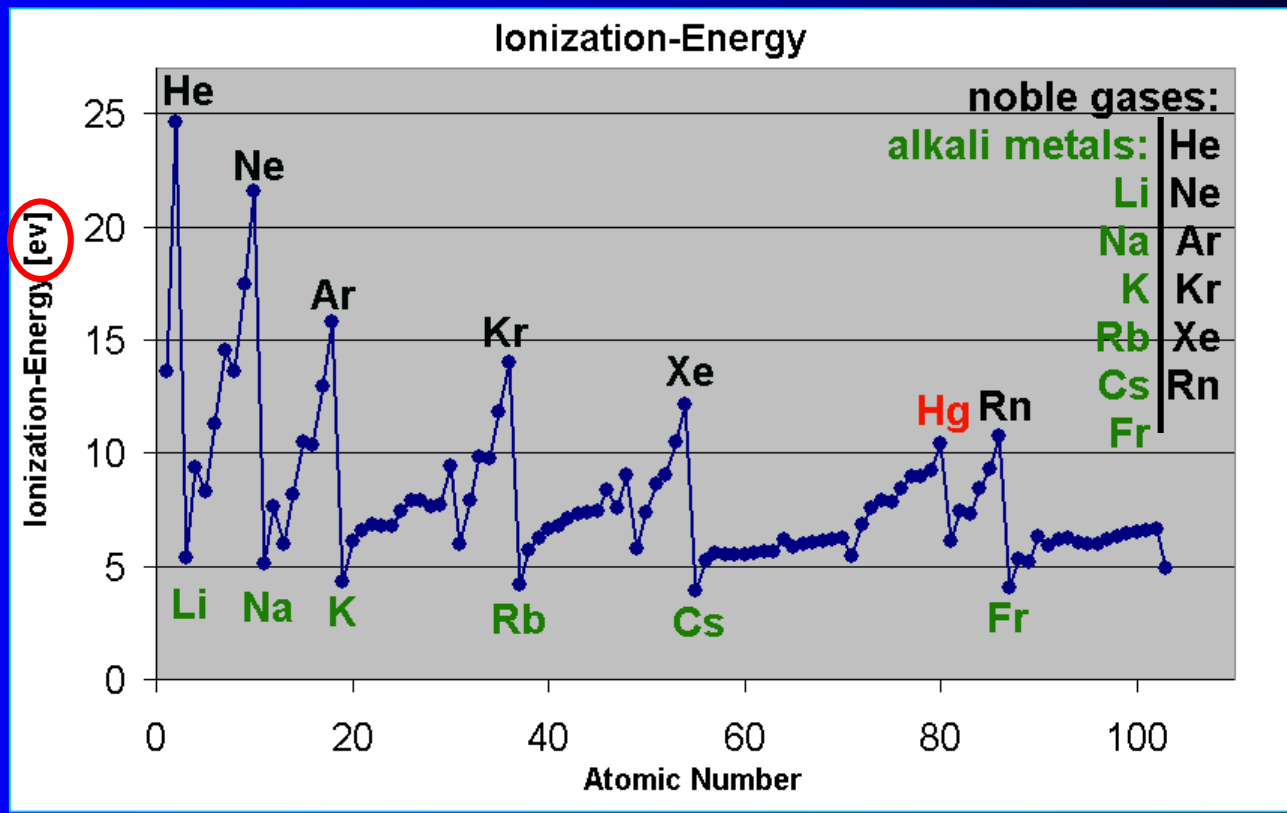
- **First ionization energy (IE₁)**

The minimum amount of energy required to remove the most loosely bound electron from an isolated gaseous atom to form a 1+ ion.

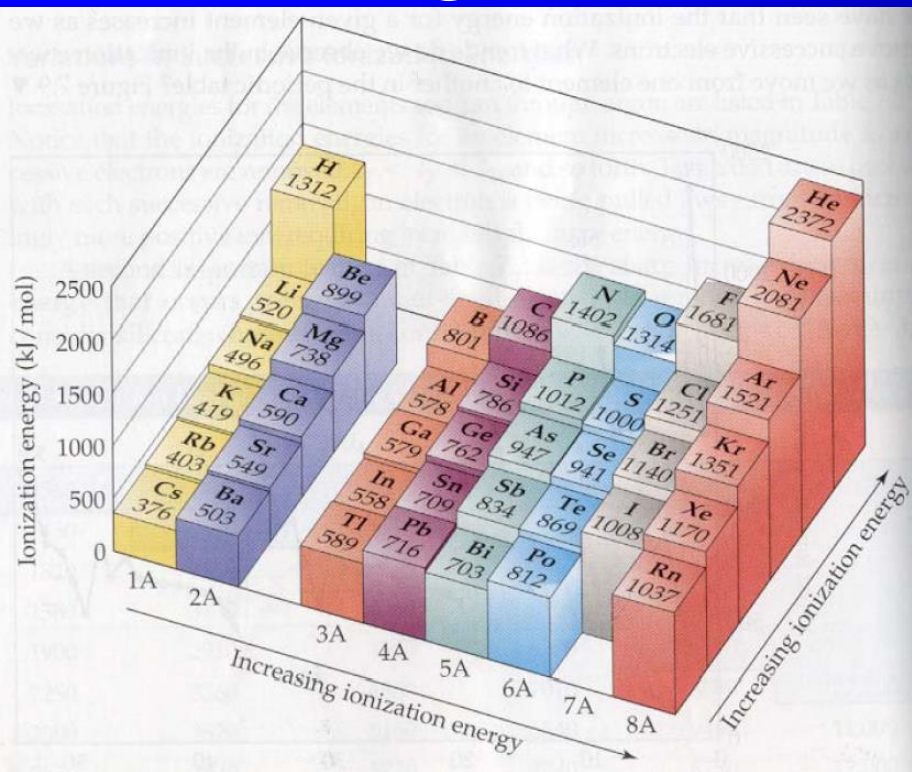


Element/Compound	Ionization Potential (Volts or eV)
He	24.6
Ar	15.8
H ₂	15.4
N ₂	15.6
O ₂	12.1
CO ₂	13.8
CO	14.1
C	11.3
Si	8.2
Fe	7.9
Ni	7.6
Na	5.1
K	4.3
Cs	3.9

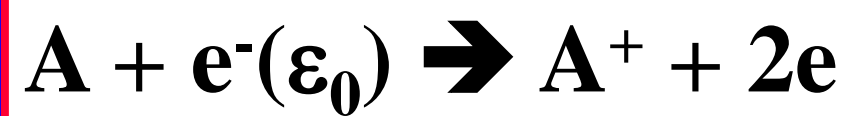
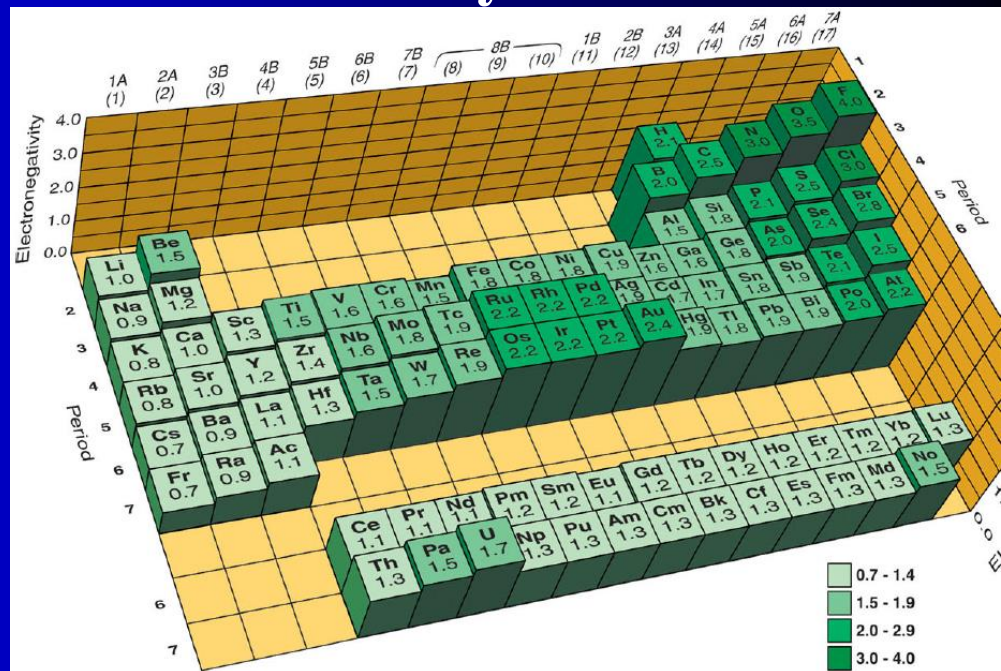
Ionization energies



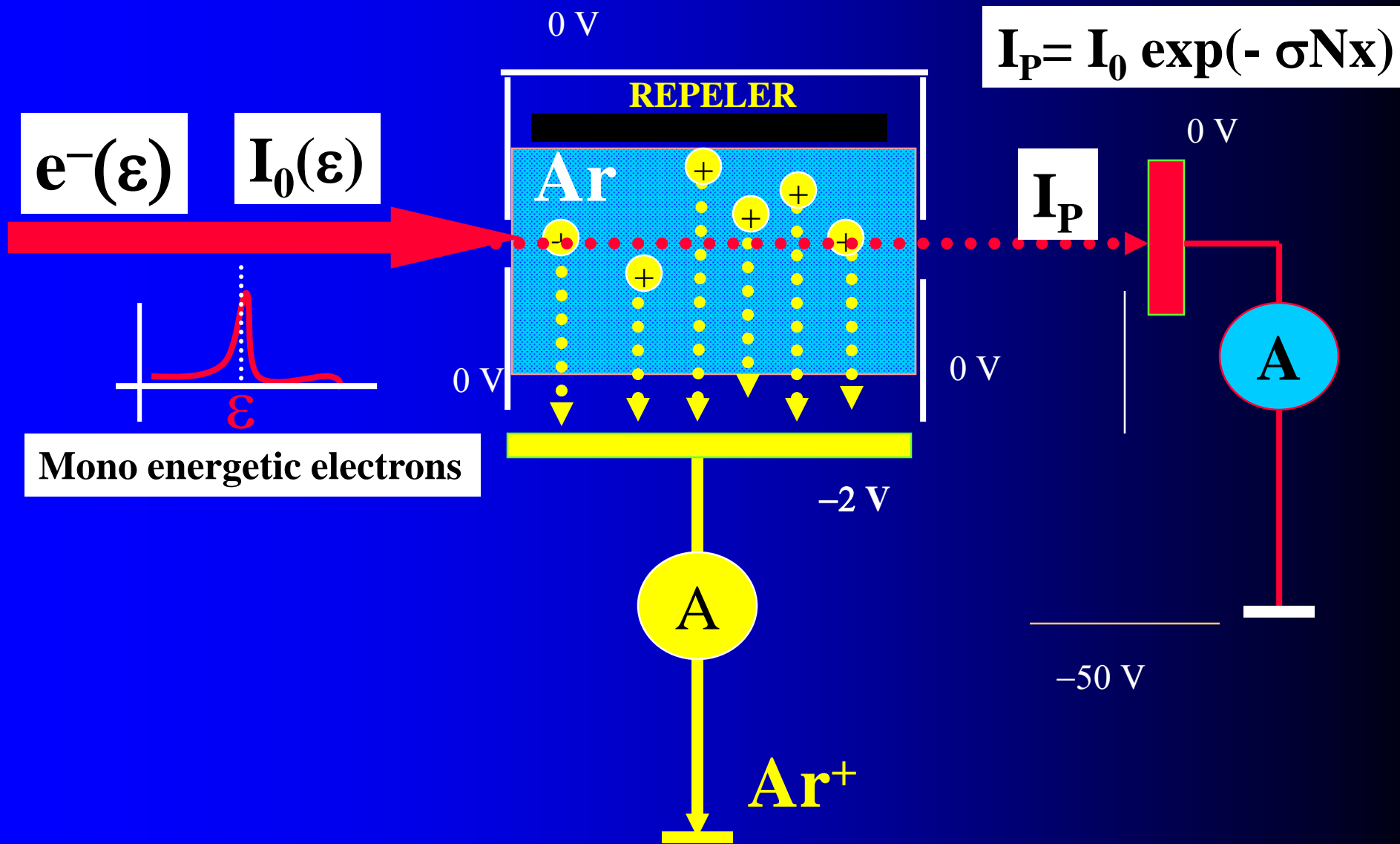
Ionization energies



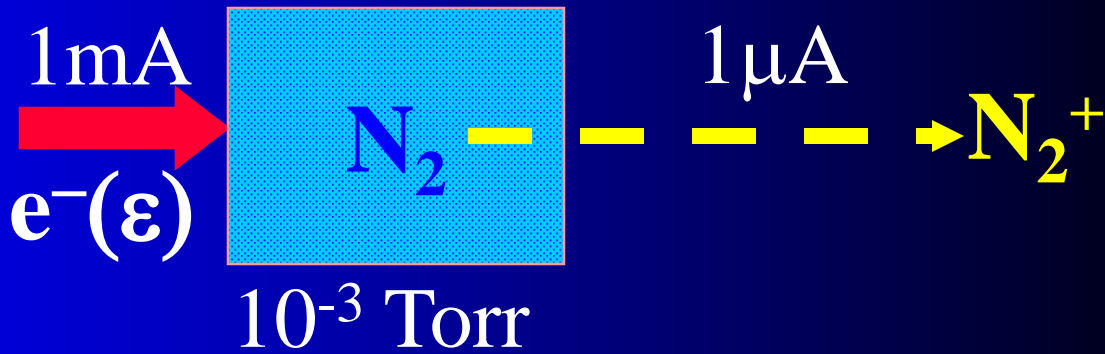
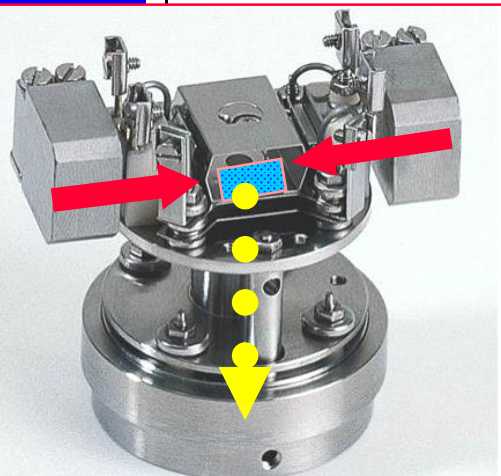
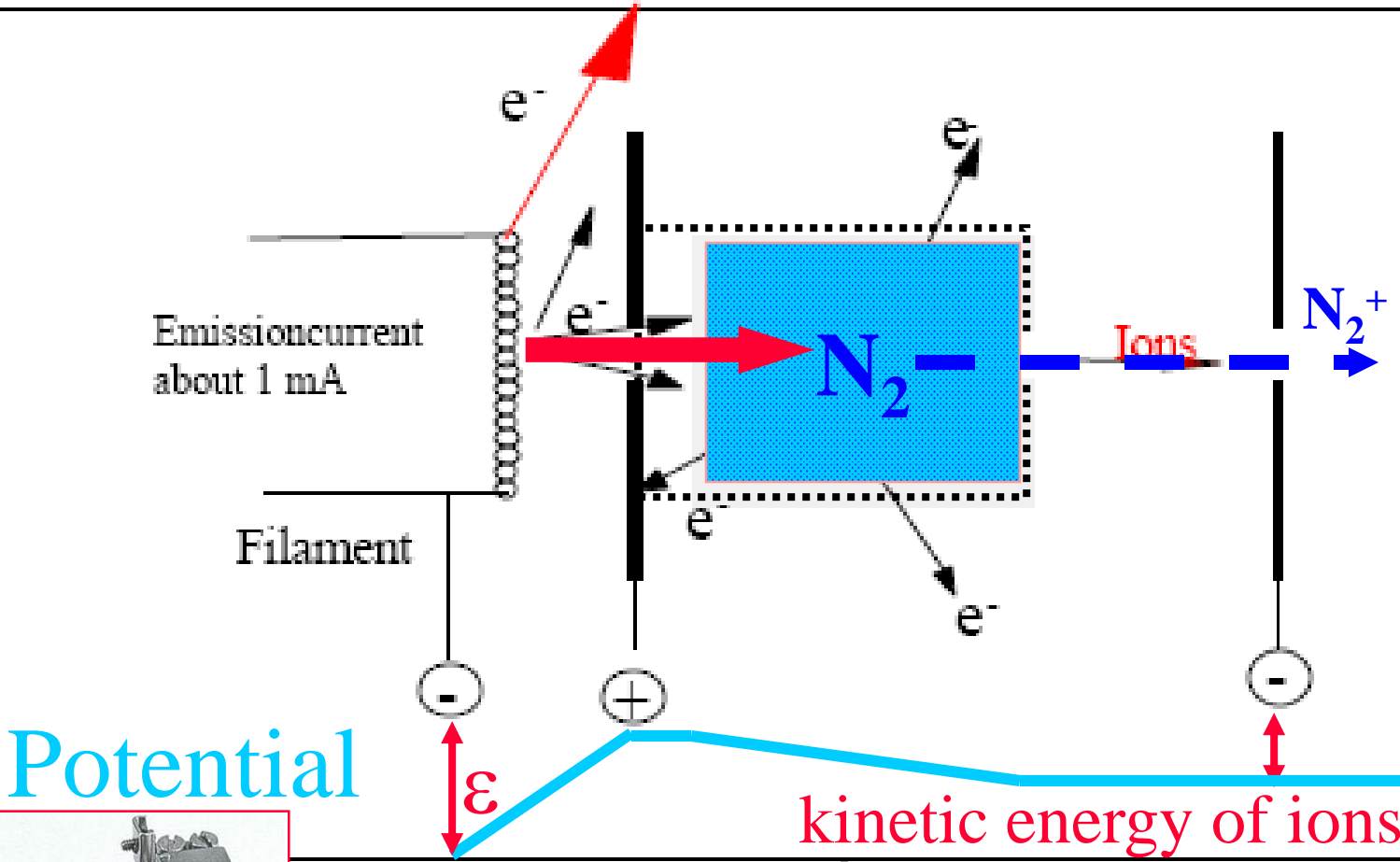
Electron affinity



Ionization cross section – idea of experiment



Electron impact ion source – ion source of mass spectrometer



Electron impact ionization

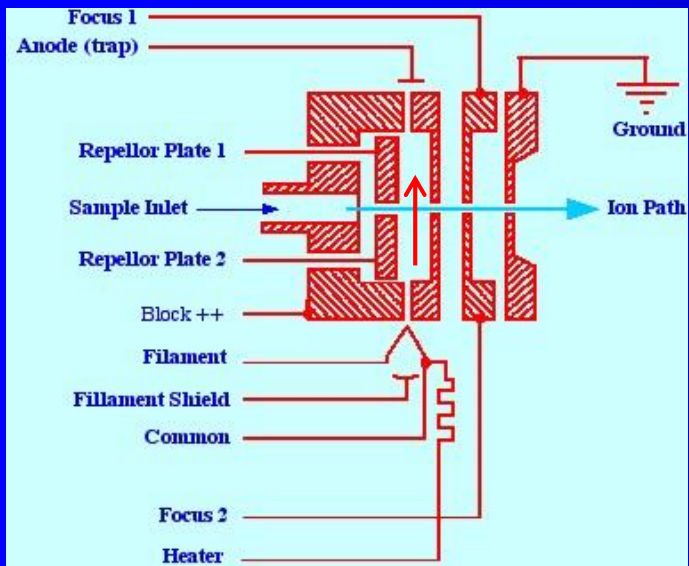
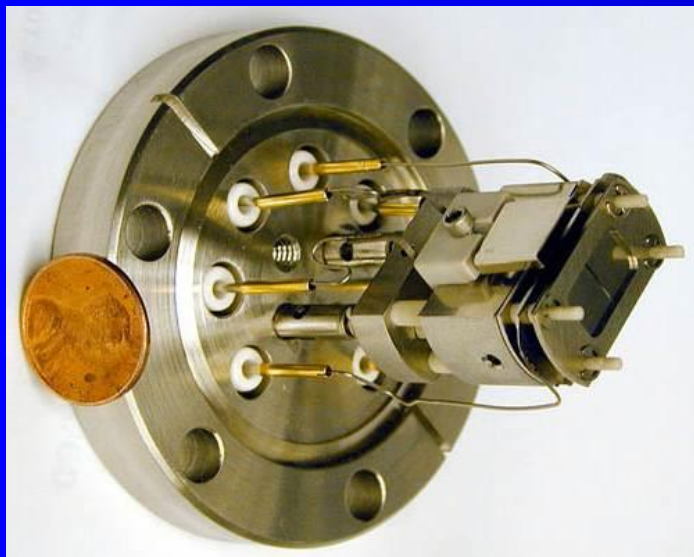
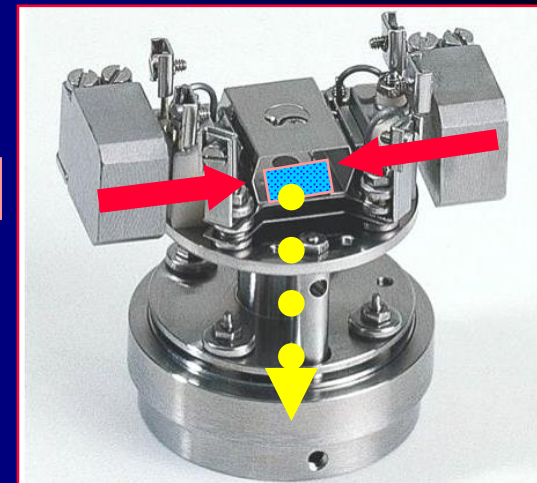
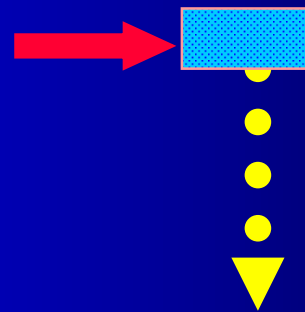


Figure 3. Cross Section of an Electron Impact Source



He + e⁻

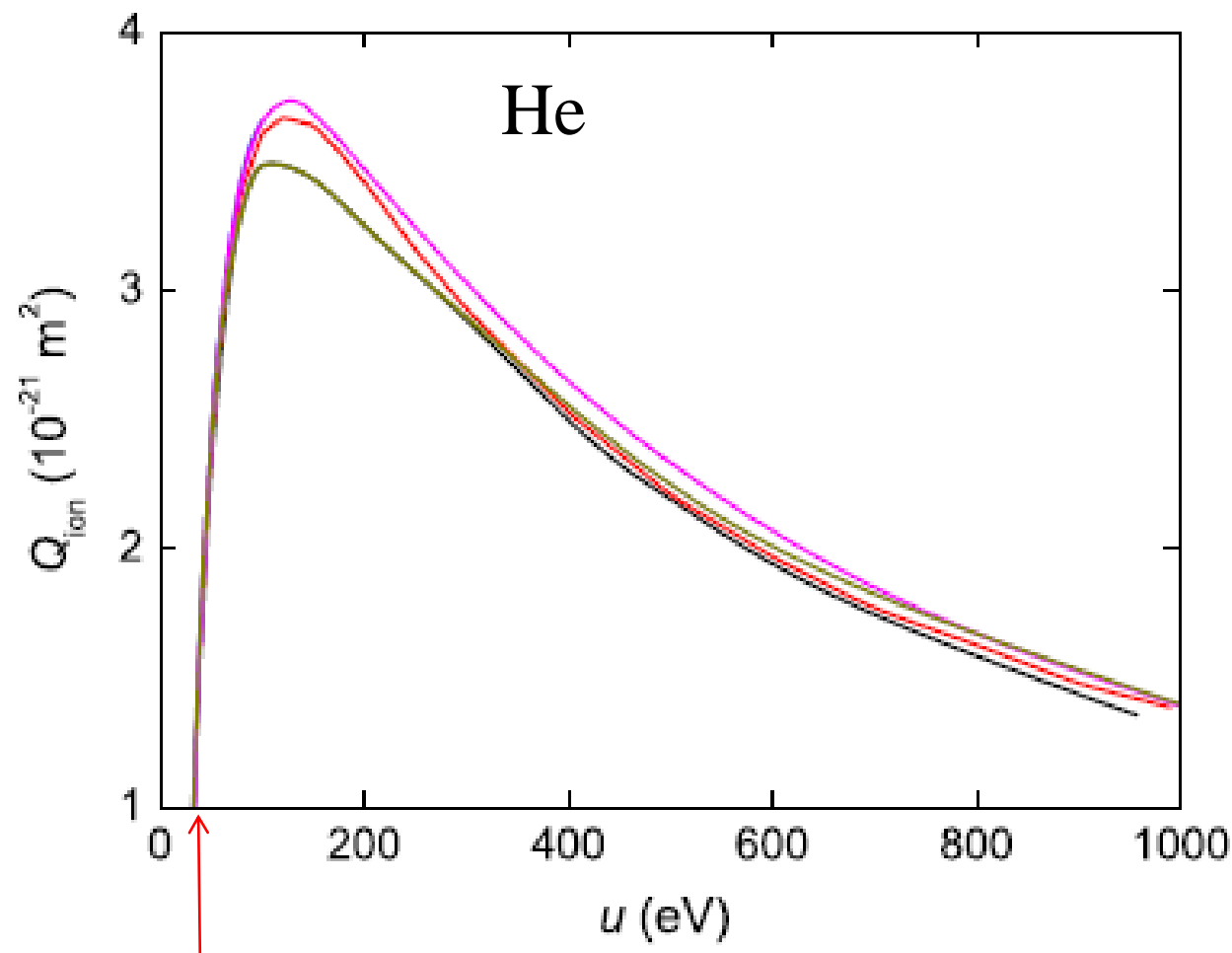
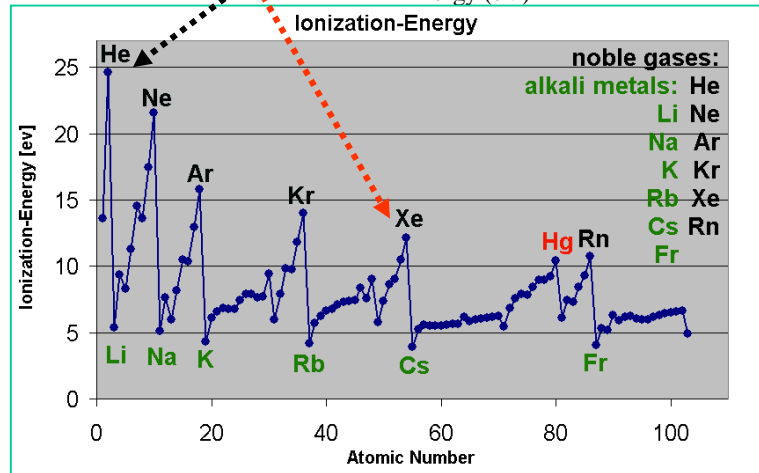
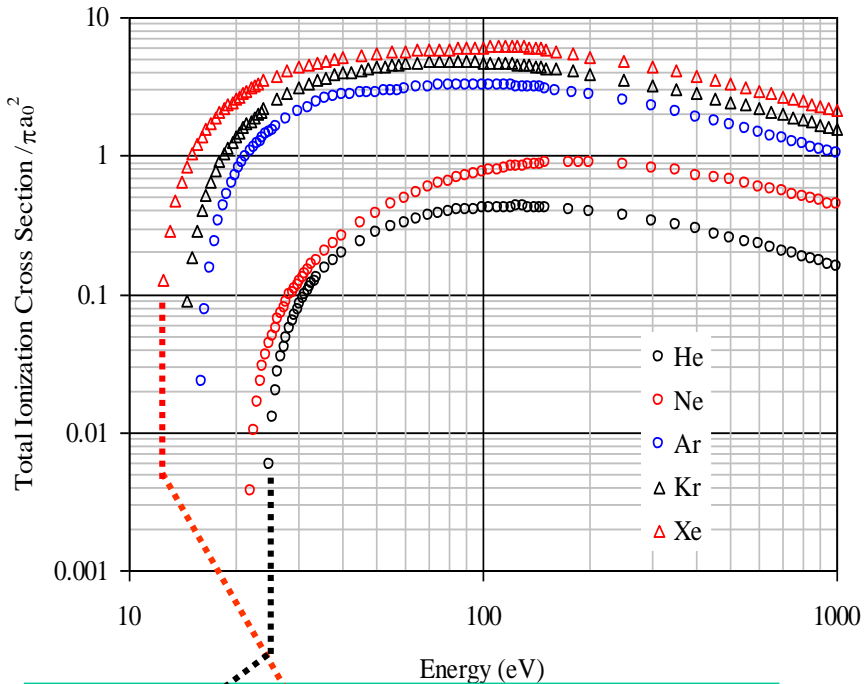


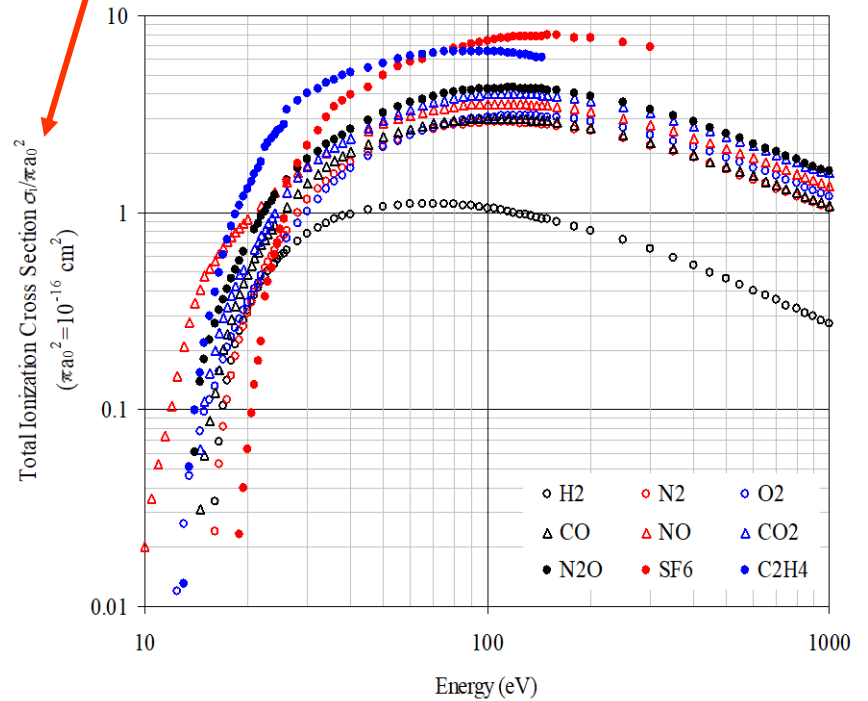
Figure 4. Ionization cross sections versus electron energy in helium, from the different databases: BIAGI-v8.9 (—), BIAGI-v7.1 (—), IST-LISBON (—), MORGAN (—), PHELPS (—).

Standard definition cross section σ (in units $\sim \dots \text{cm}^{-3}$)

Experimental results. Rare gases.

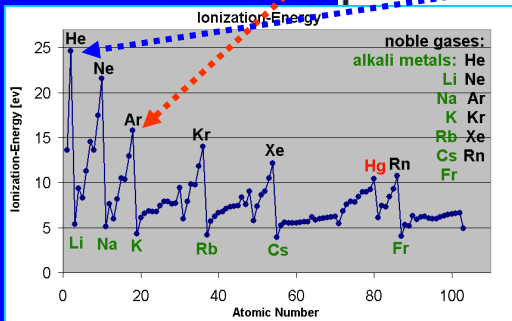
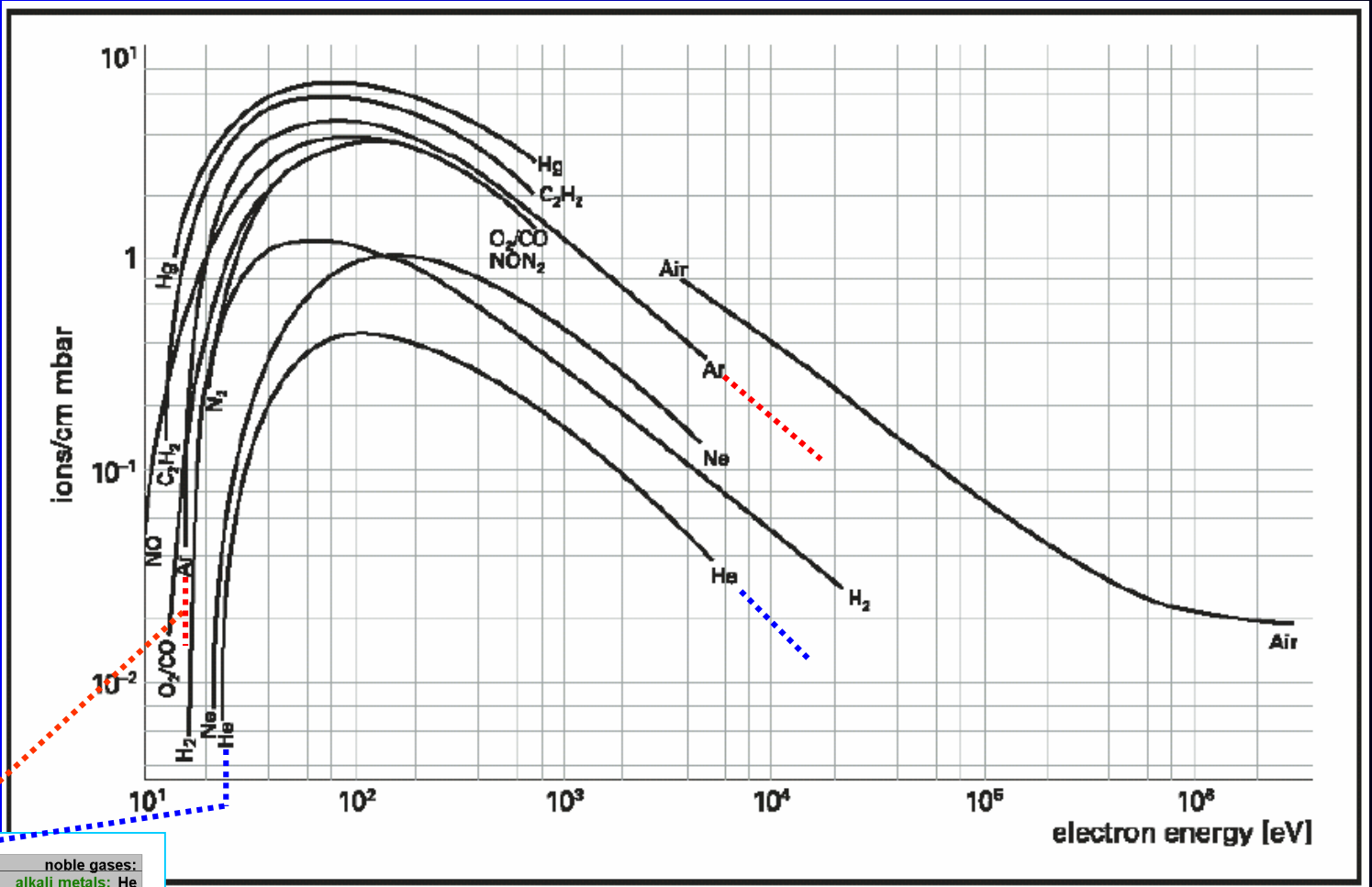


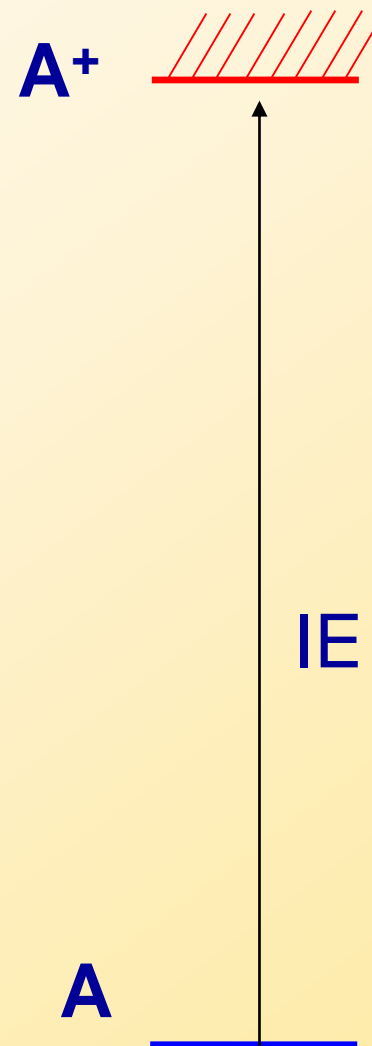
Experimental results. Diatomic molecules.



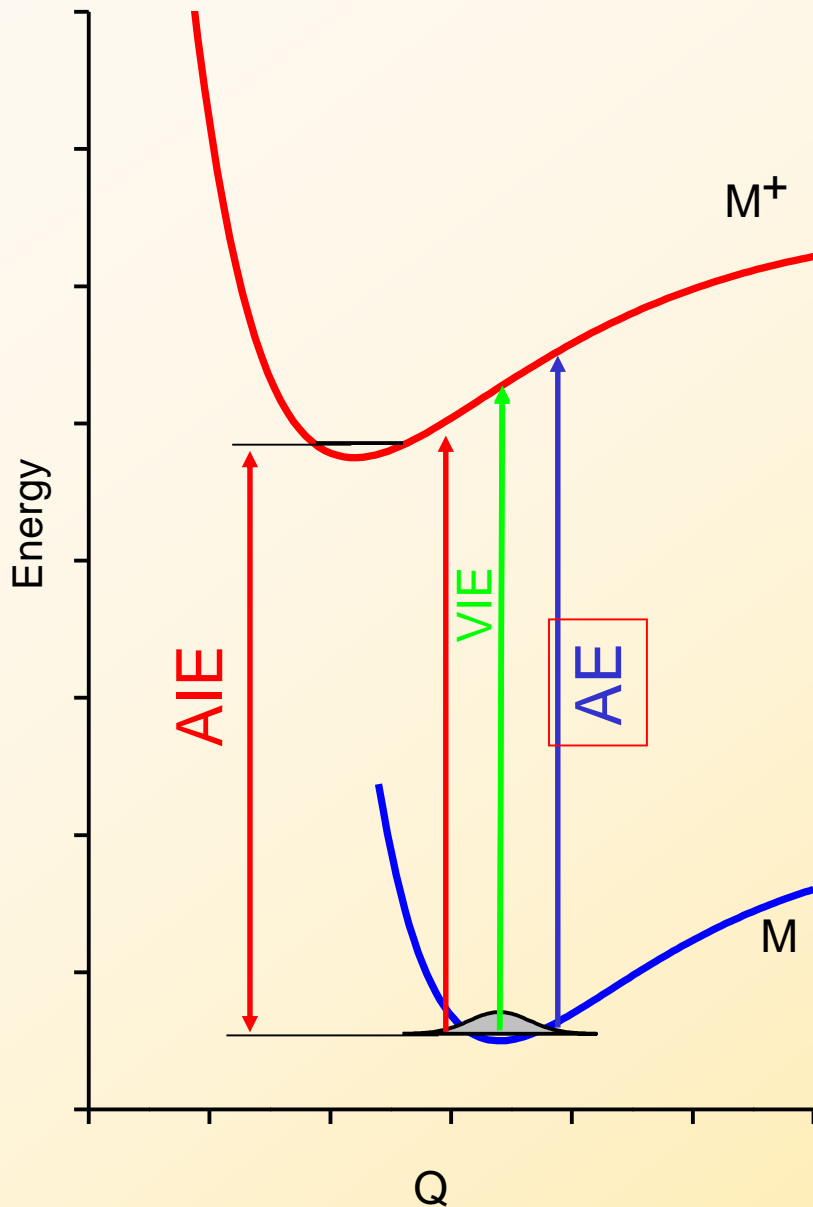
Steinar Stapnes

Ionization by electron impact





In case of atoms we have simple situation, the atom in the ground state and the ground state of the ion. The ionization energy is defined as a difference between this two states.



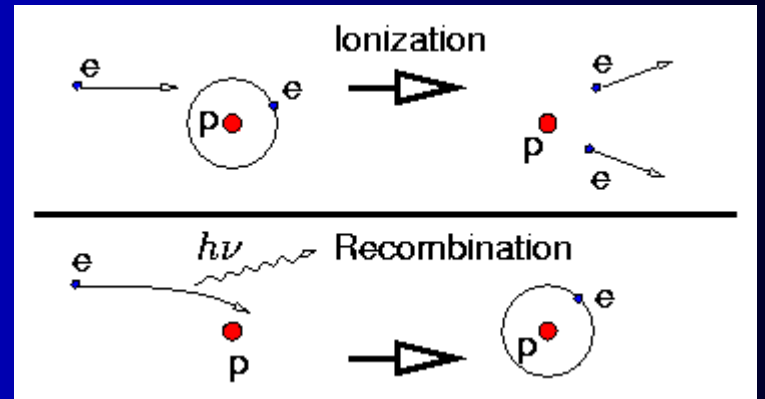
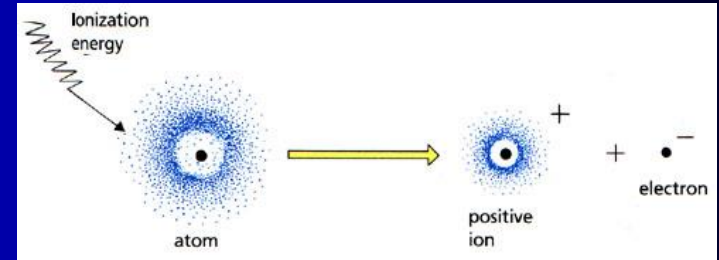
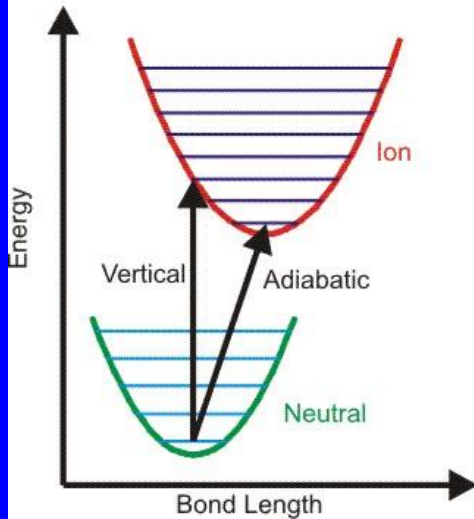
In the molecules is the situation more difficult. We have to work with potential curves or potential energy surfaces and thus the IE depends on the initial geometry of the molecules. For molecule usually two ionization energies are given, vertical IE and adiabatic IE.

Vertical VIE is defined as the energy necessary to ionise the molecule in the equilibrium geometry

Adiabatic AIE is defined as the energy difference between the energies of the ion and molecule in its ground states

The experiments are sensitive on the lowest energy necessary to ionize molecule and this is called **appearance energy**. This corresponds to the ionization energy at low distances. As the geometry changes in the molecule and the molecular ion are only moderate, often is the AE very close to the AIE.

Potential Energy diagram for diatomic molecule.



Ionization Energy, E_i

increasing 1st Ionization Energy

increasing 1st Ionization Energy

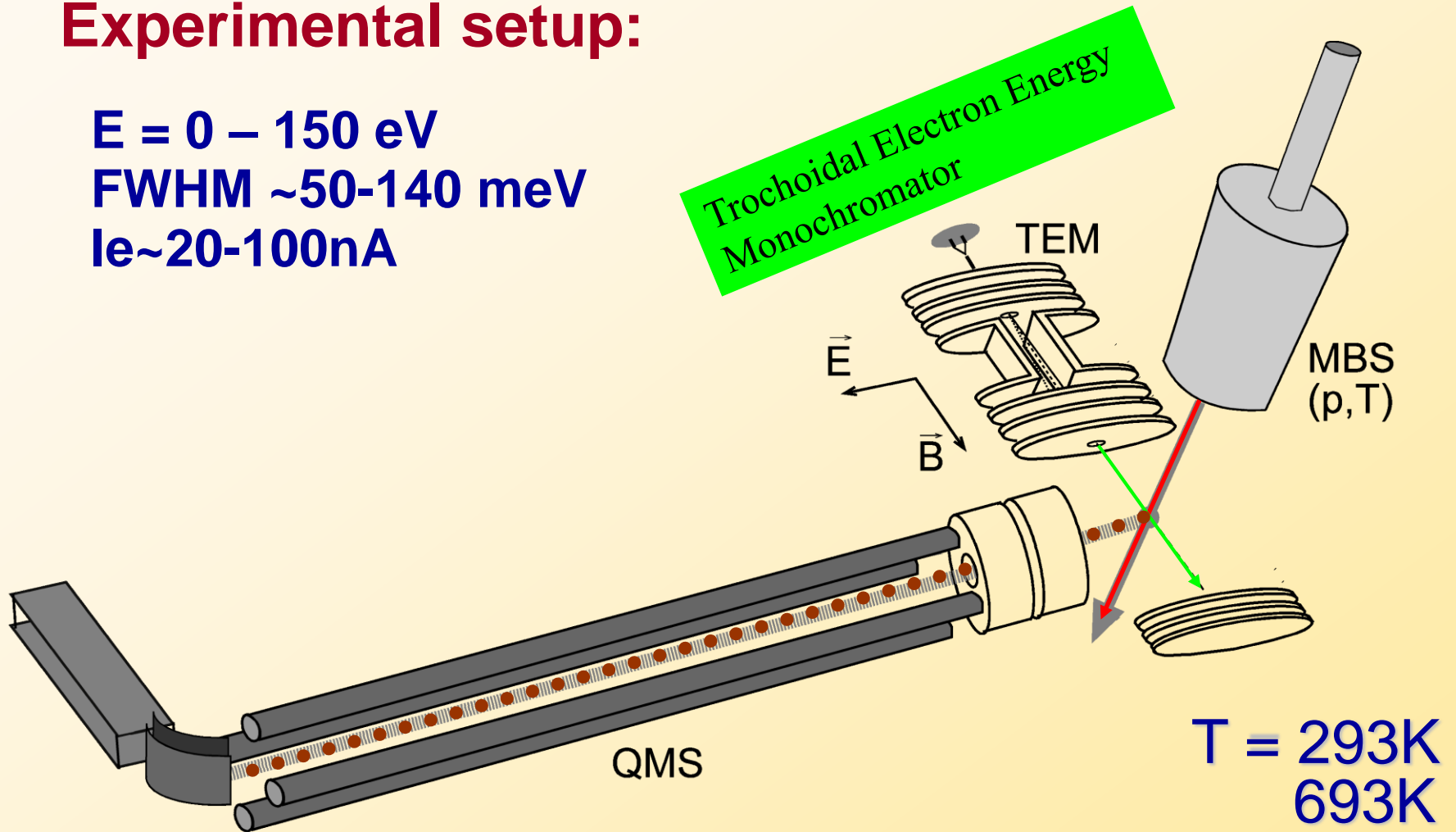
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1	H	2	He	13	Al	14	Si	15	P	16	S	17	Cl	18	Ar																				
2	Li	Be	3	B	4	C	5	N	6	O	7	F	8	Ne																					
2	Li	Be	3	B	4	C	5	N	6	O	7	F	8	Ne																					
3	Na	Mg	11	Al	12	Si	13	P	14	S	15	Cl	16	Ar																					
3	Na	Mg	11	Al	12	Si	13	P	14	S	15	Cl	16	Ar																					
4	K	Ca	19	Sc	20	Ti	21	V	22	Cr	23	Mn	24	Fe	25	Cu	26	Zn	27	Ga	28	Ge	29	As	30	Se	31	Br	32	Kr					
4	K	Ca	19	Sc	20	Ti	21	V	22	Cr	23	Mn	24	Fe	25	Cu	26	Zn	27	Ga	28	Ge	29	As	30	Se	31	Br	32	Kr					
5	Rb	Sr	37	Y	38	Zr	39	Nb	40	Mo	41	Tc	42	Ru	43	Rh	44	Pd	45	Ag	46	Cd	47	In	48	Sn	49	Sb	50	Te	51	I	52	Xe	
5	Rb	Sr	37	Y	38	Zr	39	Nb	40	Mo	41	Tc	42	Ru	43	Rh	44	Pd	45	Ag	46	Cd	47	In	48	Sn	49	Sb	50	Te	51	I	52	Xe	
6	Cs	Ba	55	La	56	Ce	57	Pr	58	Nd	59	Pm	60	Sm	61	Eu	62	Gd	63	Tb	64	Dy	65	Ho	66	Er	67	Tm	68	Yb	69	Lu			
6	Cs	Ba	55	La	56	Ce	57	Pr	58	Nd	59	Pm	60	Sm	61	Eu	62	Gd	63	Tb	64	Dy	65	Ho	66	Er	67	Tm	68	Yb	69	Lu			
7	Fr	Ra	87	Ac	88	Th	89	Pa	90	U	91	Np	92	Pu	93	Am	94	Cm	95	Bk	96	Cf	97	Es	98	Fm	99	Mn	100	101	102	103	104	105	106
7	Fr	Ra	87	Ac	88	Th	89	Pa	90	U	91	Np	92	Pu	93	Am	94	Cm	95	Bk	96	Cf	97	Es	98	Fm	99	Mn	100	101	102	103	104	105	106
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Experimental setup:

$E = 0 - 150 \text{ eV}$

FWHM $\sim 50-140 \text{ meV}$

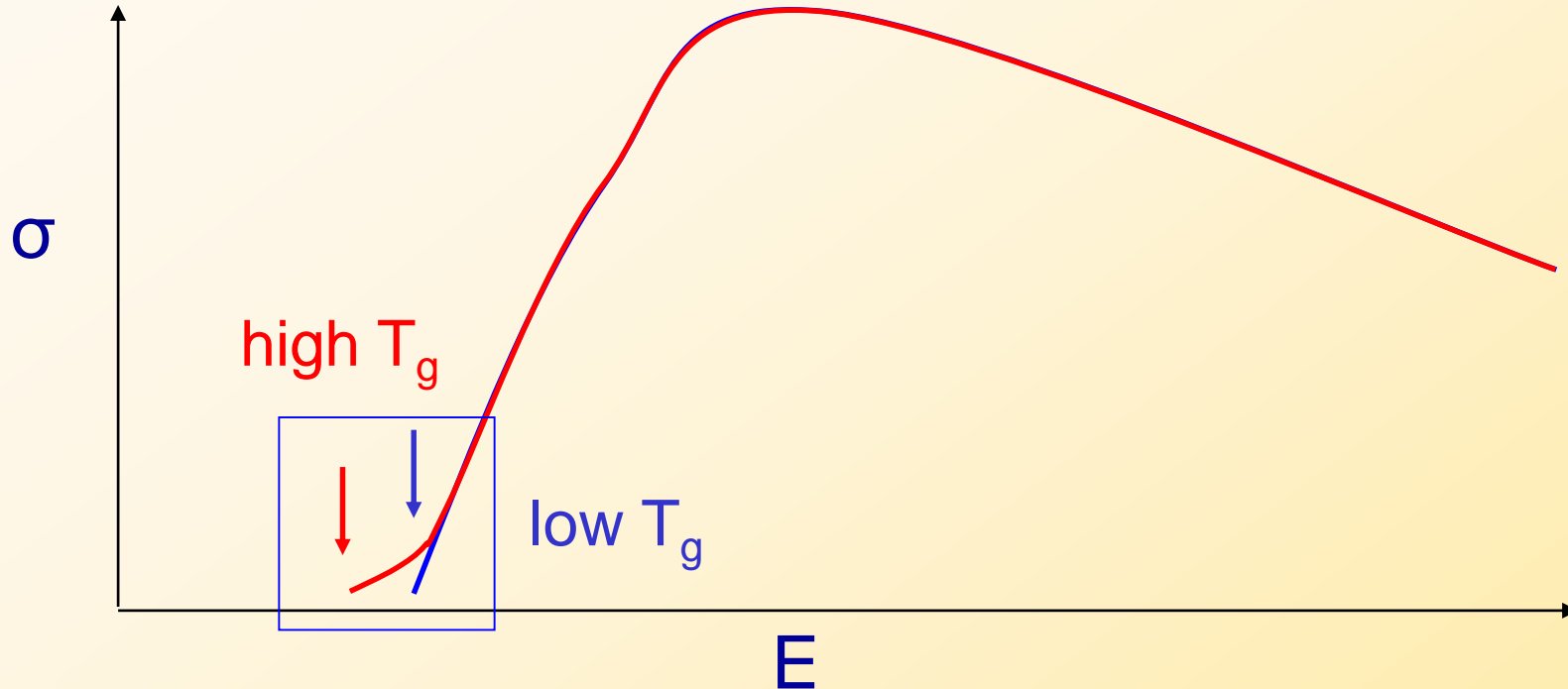
$I_e \sim 20-100 \text{ nA}$



The apparatus consists of TEM, MBS and QMS. The TEM is well known, the FWHM was about 140 meV and the $I_e \sim 100 \text{ nA}$. MBS - effusive type, the molecules in the beam have translational, vibrational and rotational temperature identical to the temperature of the MBS.

The mass selected ions are registered as a function of the electron energy.

Electron impact ionization



The EII is characterised from point of view of the kinetics by the cross section
The cross section has a monotonic character with maximum at about 100 eV
The EII is endothermic reaction with a threshold, called appearance energy of the ions
In present experiment we have focused on the estimation of the threshold behaviour of the CS,
estimation of the AE
At elevated temperatures there are changes in the ion yield in the vicinity of the threshold

Adapted from lecture of prof. Š. Matejčík

Another definition α in units cm^{-1}

Mathematical Analysis

When these n electron move through a distance dx , they produce another dn electrons due to collision. Therefore:

$$dn = \alpha n dx$$

$$\frac{dn}{n} = \alpha dx$$

$$\ln n = \alpha x + A$$

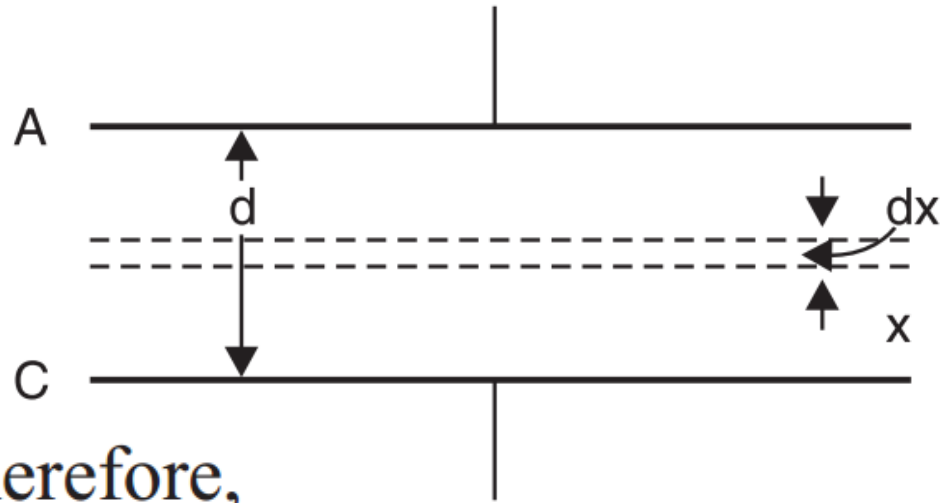
Now at $x = 0$, $n = n_0$. Therefore,

$$\ln n_0 = A$$

$$\ln n = \alpha x + \ln n_0$$

$$\ln \frac{n}{n_0} = \alpha x$$

$$n = n_0 e^{\alpha x}$$



Another definition α in units cm^{-1}

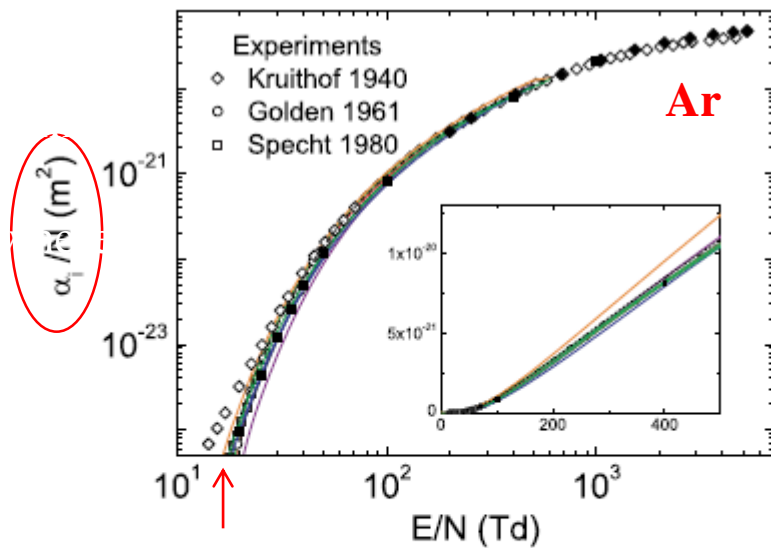


Figure 8. Measured and calculated reduced ionization coefficients. The solid lines are results from two-term Boltzmann calculations and the solid symbols (■) are from the Monte Carlo calculations using MAGBOLTZ (Biagi 2011). The colour code is BIAGI-v8.9 (—); BSR (—); HAYASHI (—); IST-LISBON (—); MORGAN (—); PHELPS (—); PUECH (—). The measurements are referenced in the text.

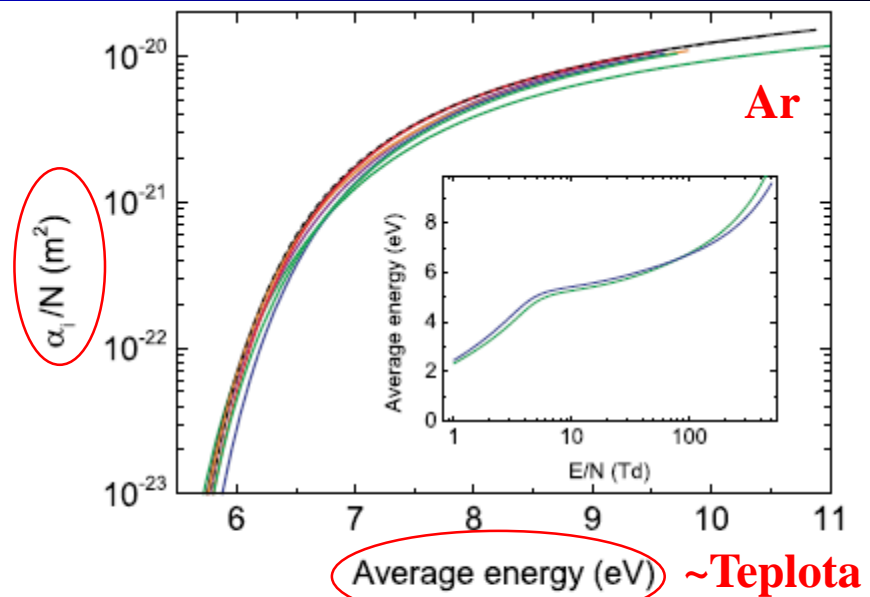


Figure 9. Reduced ionization coefficient versus average electron energy, calculated using a two-term Boltzmann solver. The inset shows the average energy versus E/N , and the colour code is BIAGI-v8.9 (—); BIAGI-v7.1 (- - -); BSR (—); HAYASHI (—); IST-LISBON (—); MORGAN (—); PHELPS (—); PUECH (—).

Approximate computed curves showing the percentage of electron energy going to various actions at a given X/p (V/cm/mmHg)

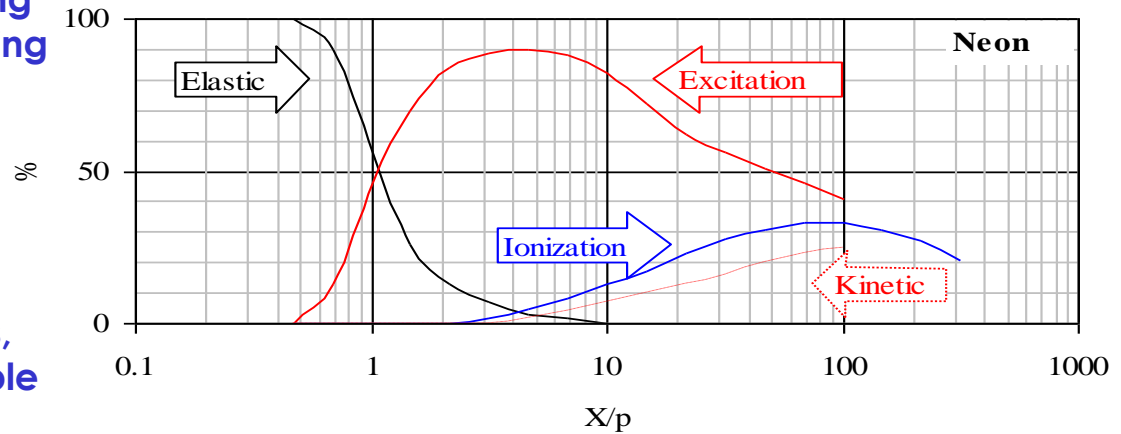
Elastic: loss to elastic impact

Excitation: excitation of electron levels, leading to light emission and metastable states

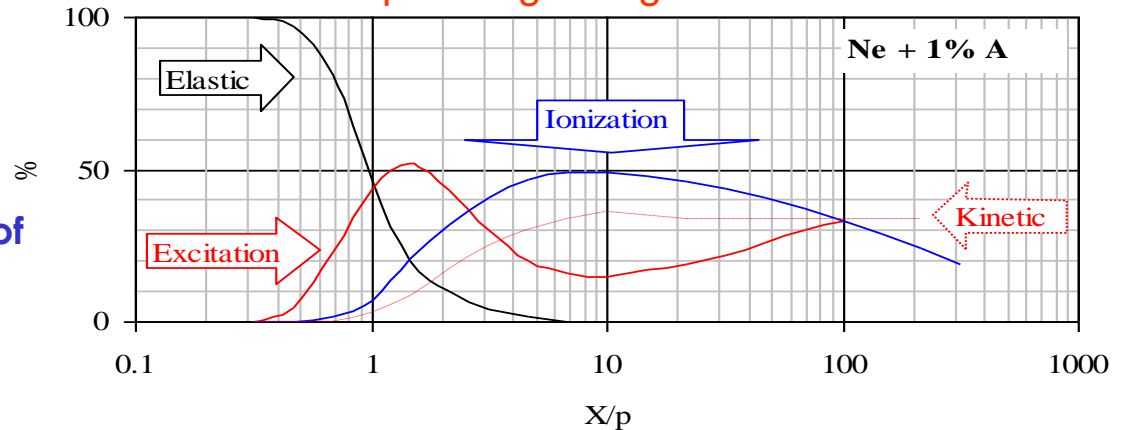
Ionization: ionization by direct impact

Kinetic: average kinetic energy divided by their "temperature"

Vibration: energy going to excitation of vibrational levels



Add a sprinkling of argon



2.3. Electron impact ionization

The electron impact ionization is the most fundamental ionization process for the operation of ion sources.

Why?

- The cross section for the impact ionization is by orders of magnitudes higher than the cross section for the photo ionization.
- The cross section depends on the mass of the colliding particle. Since the energy transfer of a heavy particle is lower, a proton needs for an identical ionization probability an ionization energy three orders of magnitudes higher than an electron

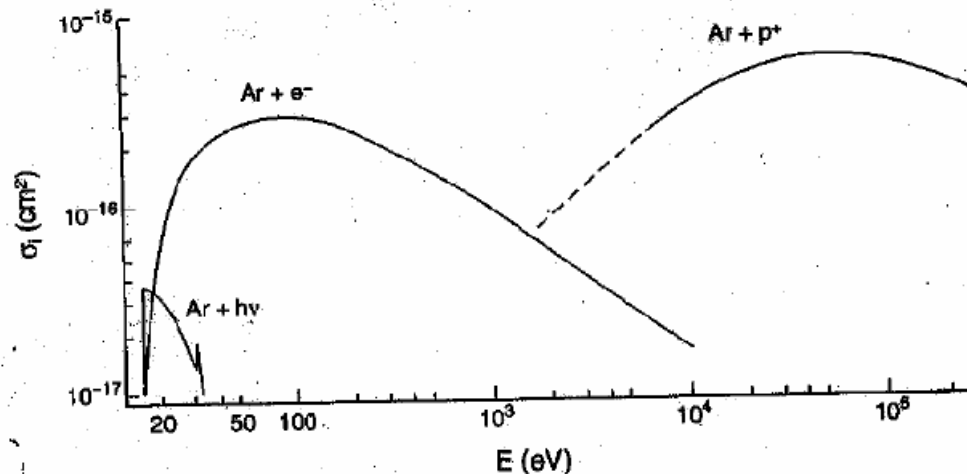
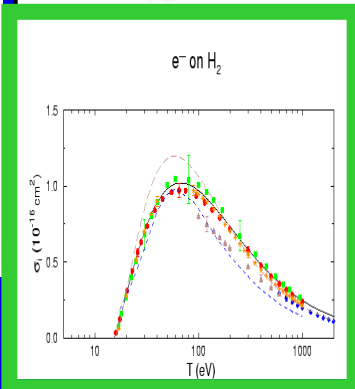
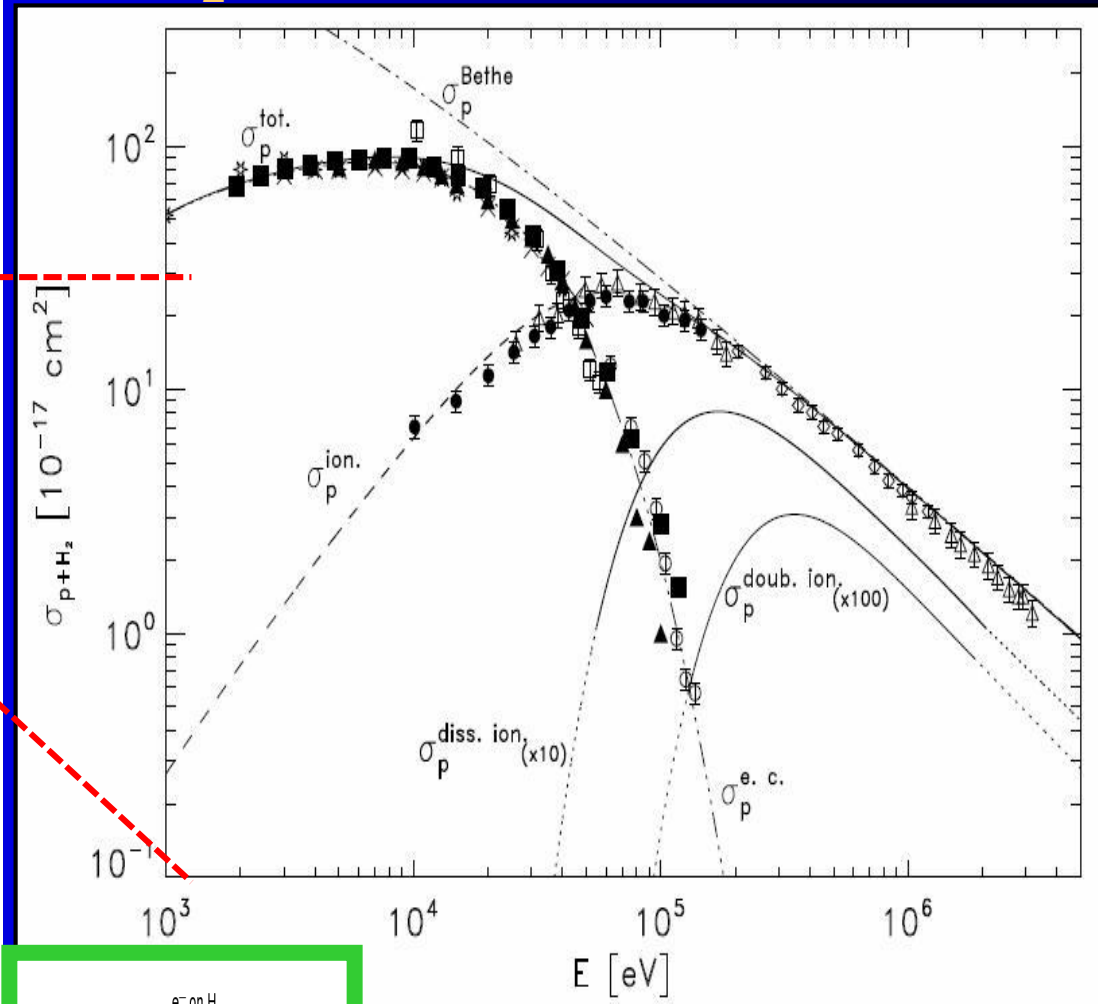
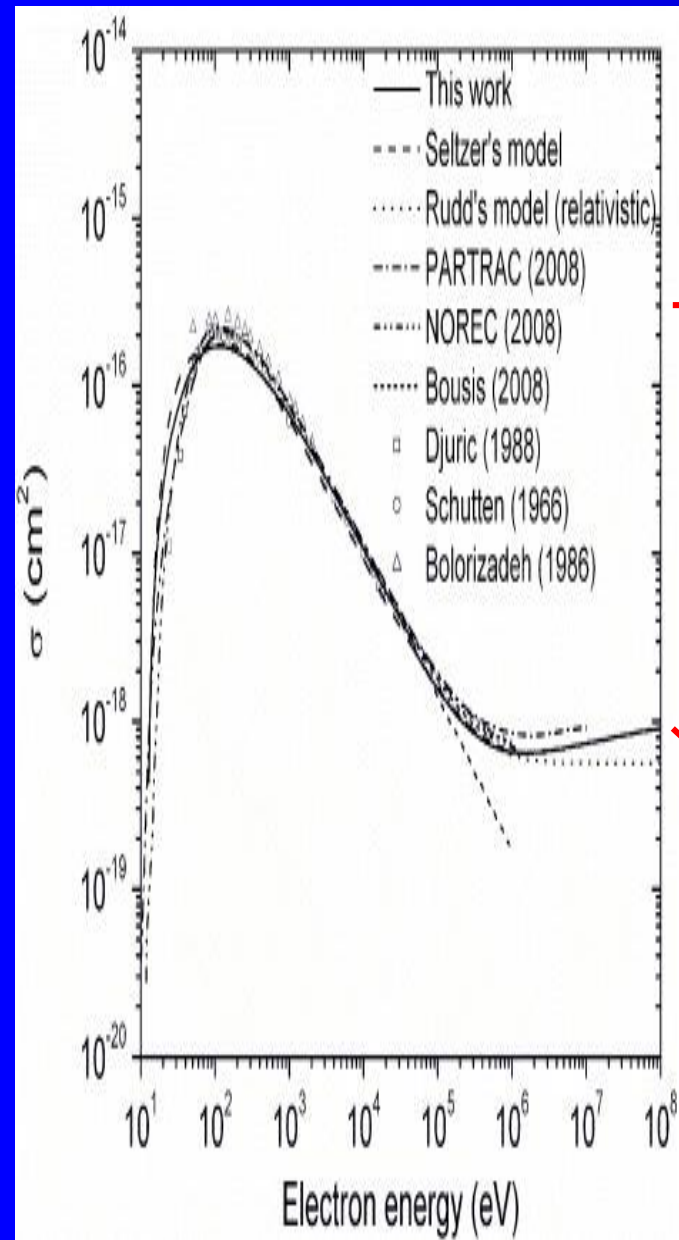
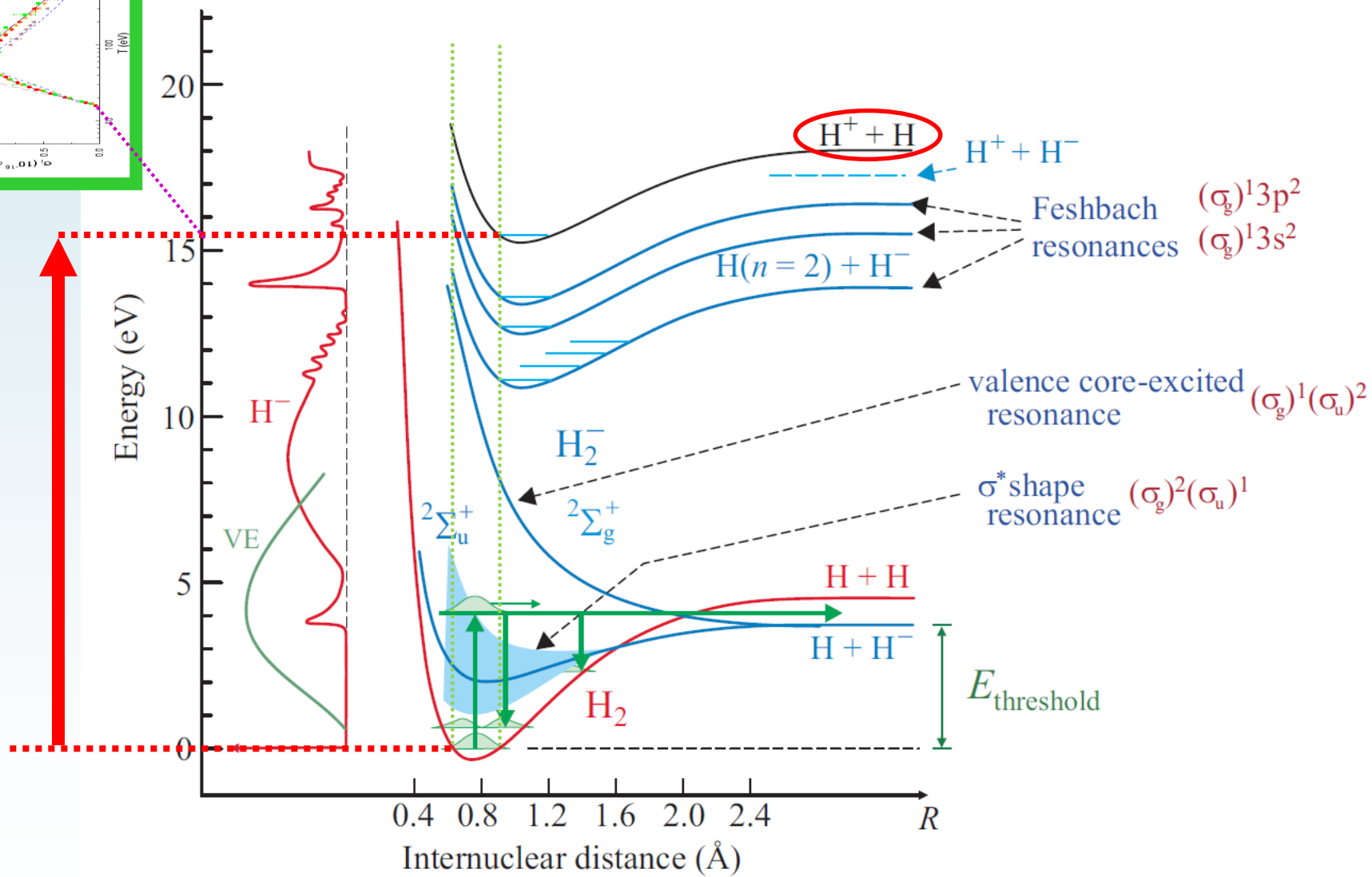
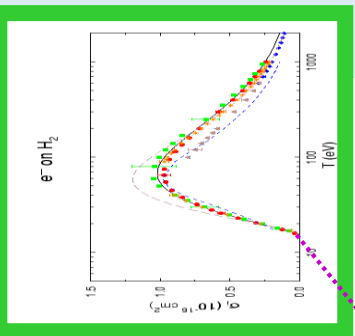


FIGURE 4
Ionization cross sections as functions of energy for ionizing collisions with fast electrons, protons, and photons. (From Winter, H., in *Experimental Methods in Heavy Ion Physics*, Springer-Verlag, 1977, p. 1099. With permission.)

p + H₂ Ionization Cross Section



Padovani et al. 2009, A&A, 501, 619



Cross sections for vibrational excitation, dissociation, ionization...H₂

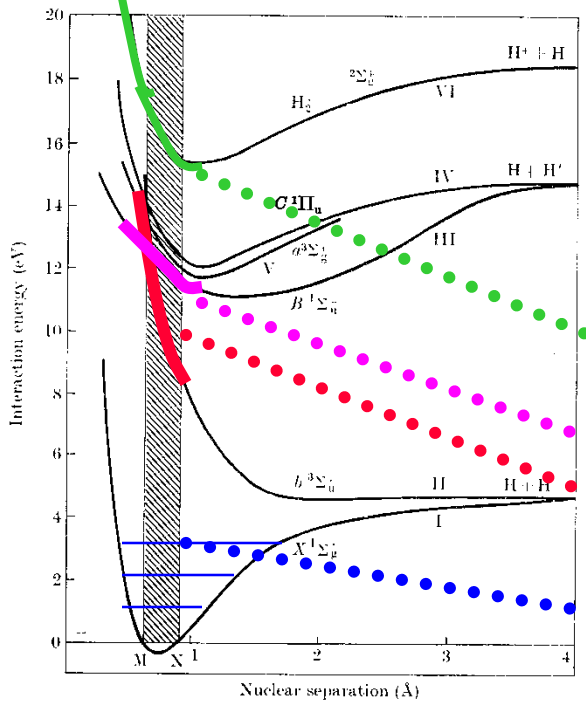


FIG. 13.1. Potential energy curves for electronic states of H₂ and H₂⁺ lying within 20 eV of the ground state.

- H₂ + e → H₂(v) + e **Vibrational excitation**
 → H + H + e **Dissociation**
 → H₂^{*} + hv + e ... **Photon excitation**
 → H₂⁺ + e + e **Ionization**
 → H⁺ + H + e + e **Dissociative Ionization**

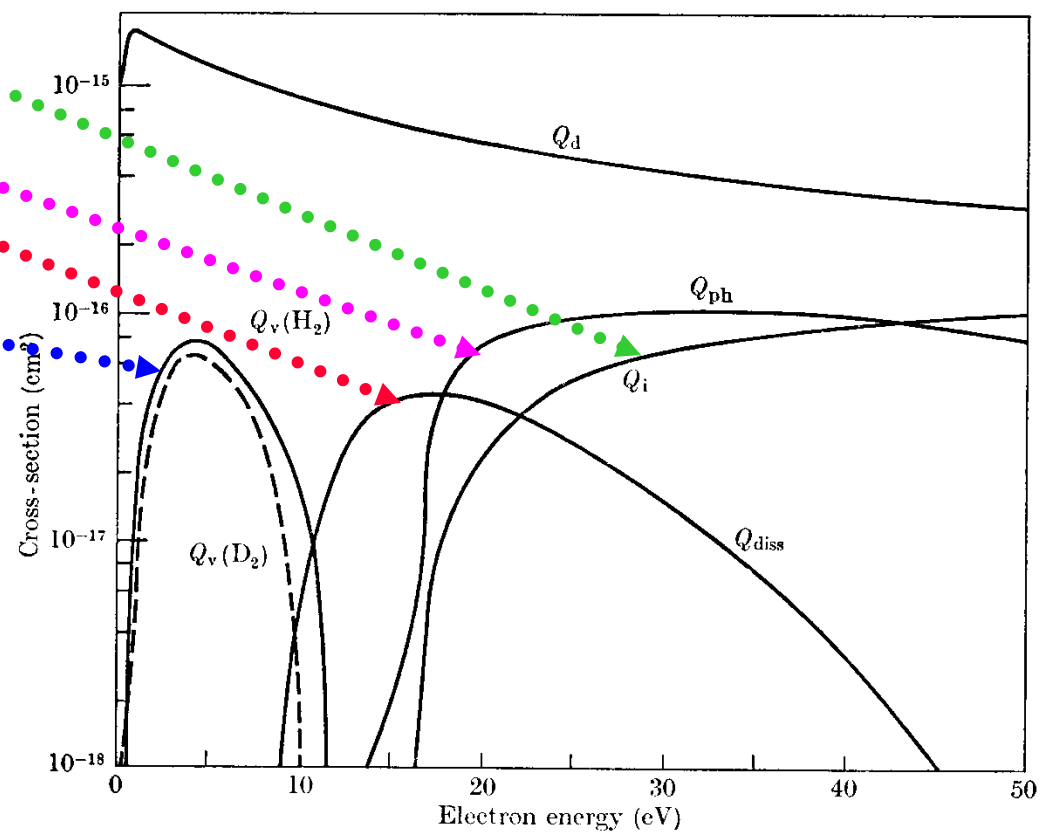


FIG. 13.37. Cross-sections assumed by Engelhardt and Phelps in their analysis of swarm data in H₂ and D₂ for electrons of characteristic energy greater than 1 eV. Q_d momentum-transfer cross-section, Q_i, ionization cross-section, Q_{diss} dissociation cross-section, Q_{ph} photon excitation cross-section, Q_v vibrational excitation cross-section (— H₂, --- D₂).

Potential Energy Surface Description of the Ionization of H₂

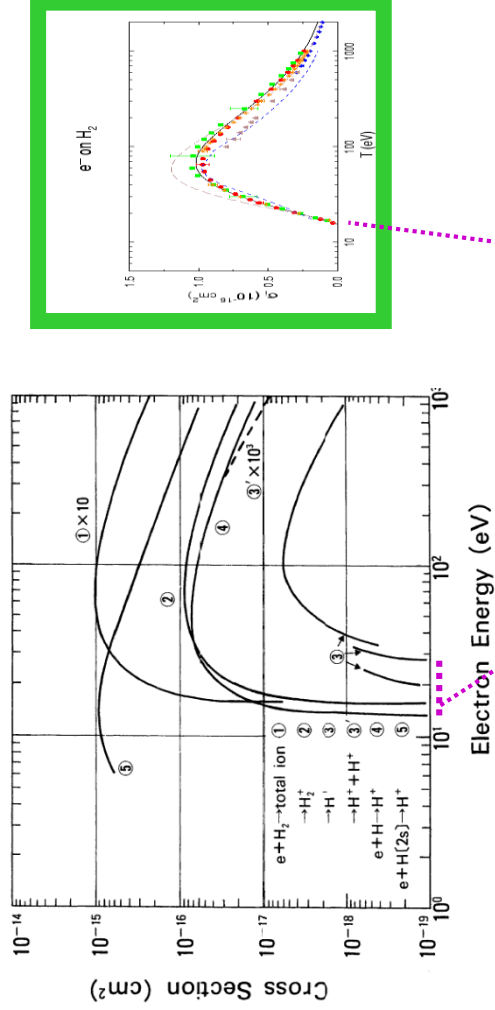
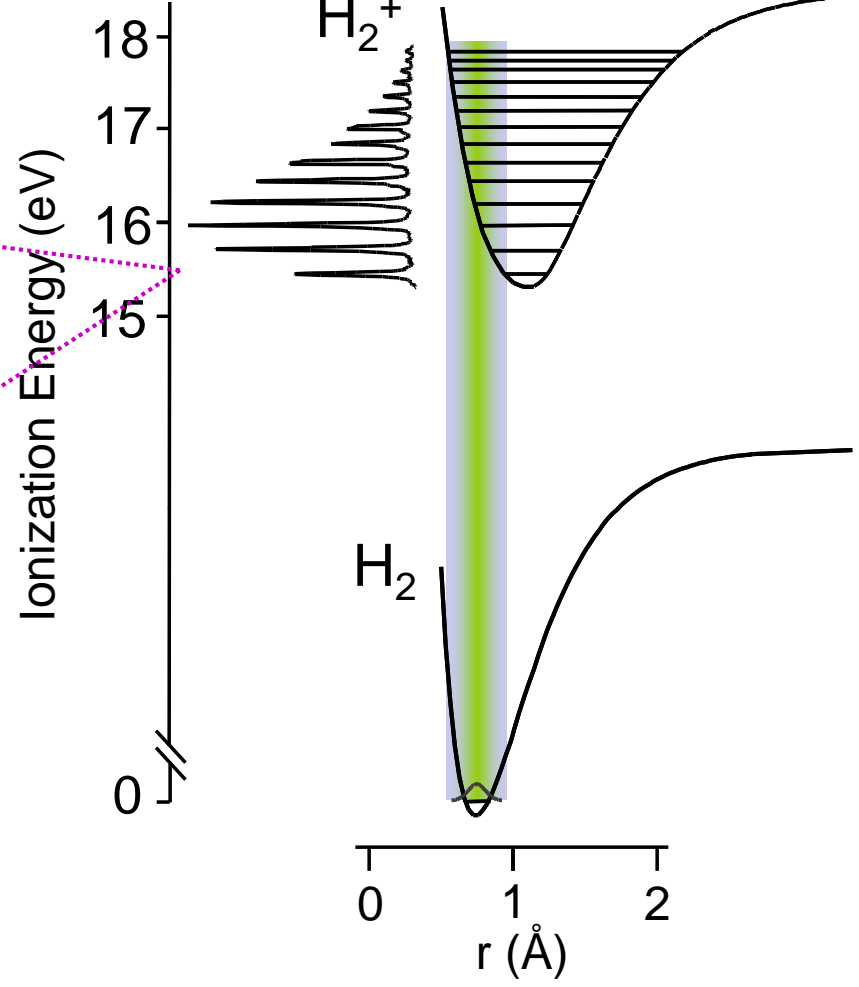
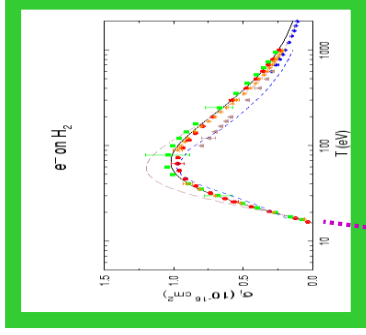


FIG. 16. Cross sections of the production for total ion, molecular hydrogen ions, protons and double protons. Those of proton production from H and H(2s) are also shown for comparison (see Ref. 1,2). Note that the short curves, for proton production at lower energies, correspond to the processes via 2_g (near-zero energy protons) and 2_u (repulsive state), respectively.



Details of interaction of electron with H₂ (1990)

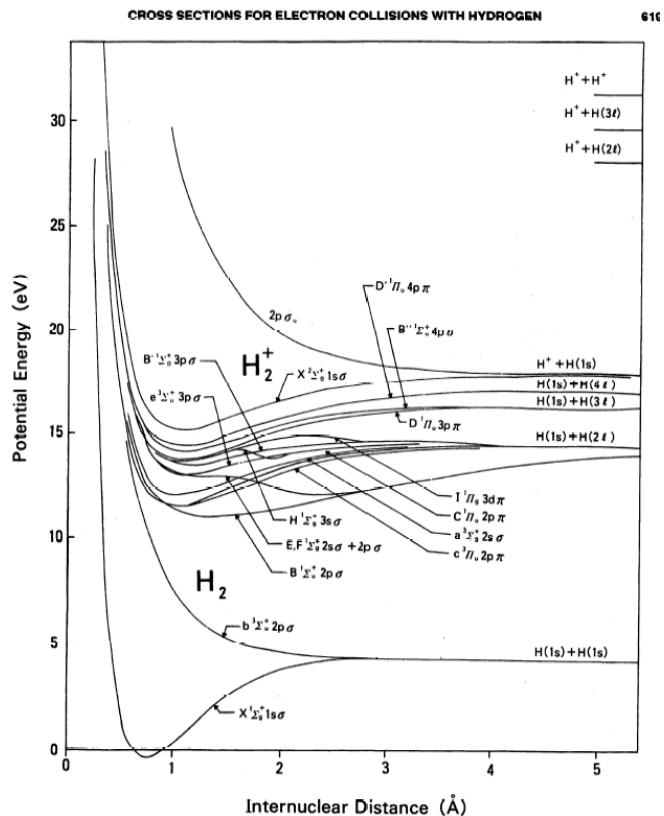


FIG. 1. Some important energy levels of molecular hydrogen and molecular ion (see Ref. 5).

Cross Sections and Related Data for Electron Collisions with Hydrogen Molecules and Molecular Ions^{a)}

H. Tawara, Y. Itikawa,^{b)} H. Nishimura,^{c)} and M. Yoshino^{d)}

National Institute for Fusion Science,^{e)} Nagoya 464-01, Japan

(Received July 5, 1989; revised manuscript received November 1, 1989)

Data are compiled and evaluated for collision processes of excitation, dissociation, ionization, attachment, and recombination of hydrogen molecules and molecular ions (H_2^+ , H_3^+) by electron impact as well as for properties of their collision products.

Key words: electron impact; hydrogen molecule; hydrogen molecular ion; scattering; elastic integral; vibrational excitation; rotational excitation; dissociation; ionization; photon emission; cross section.

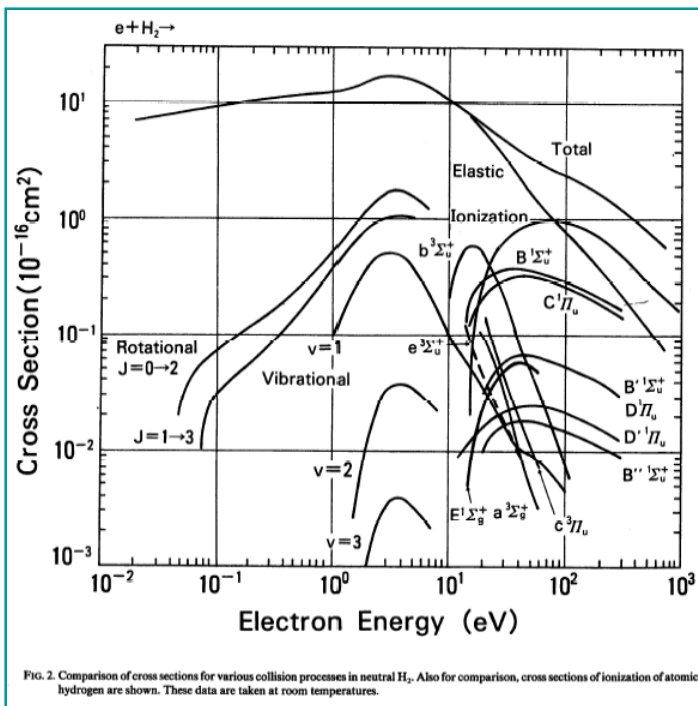


FIG. 2. Comparison of cross sections for various collision processes in neutral H₂. Also for comparison, cross sections of ionization of atomic hydrogen are shown. These data are taken at room temperatures.

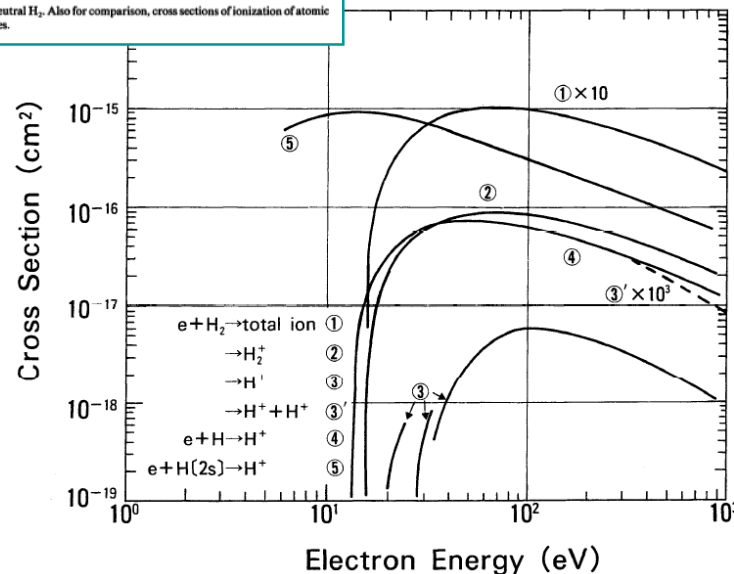


FIG. 16. Cross sections of the production for total ion, molecular hydrogen ions, protons and double protons. Those of proton production from H and H(2s) are also shown for comparison (see Ref. 125). Note that the short curves, for proton production at lower energies, correspond to the processes via $^2\Sigma_u$ (near-zero energy protons) and $^2\Sigma_u$ (repulsive state), respectively.

Partial cross section for excitation

NO

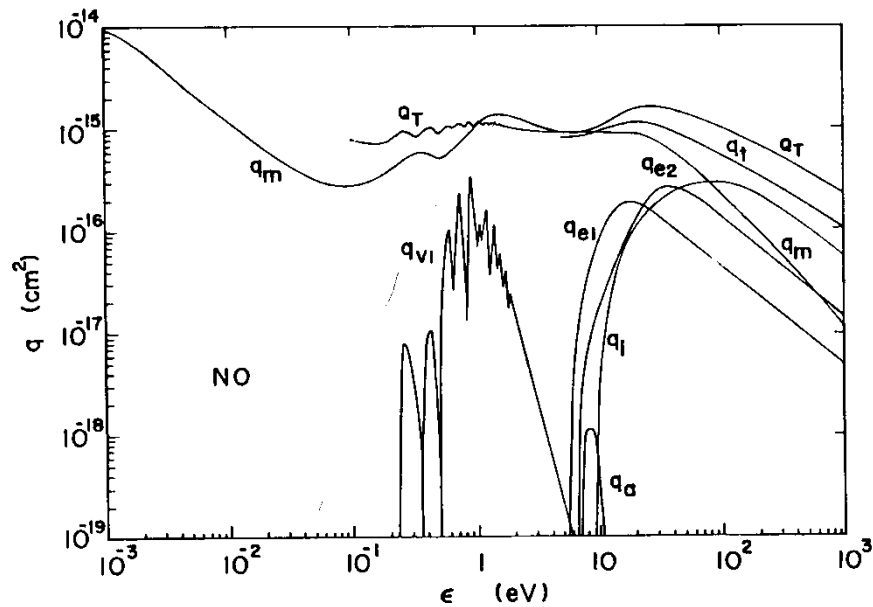


Fig. 4. Cross-section set for NO (1986).

NH₃

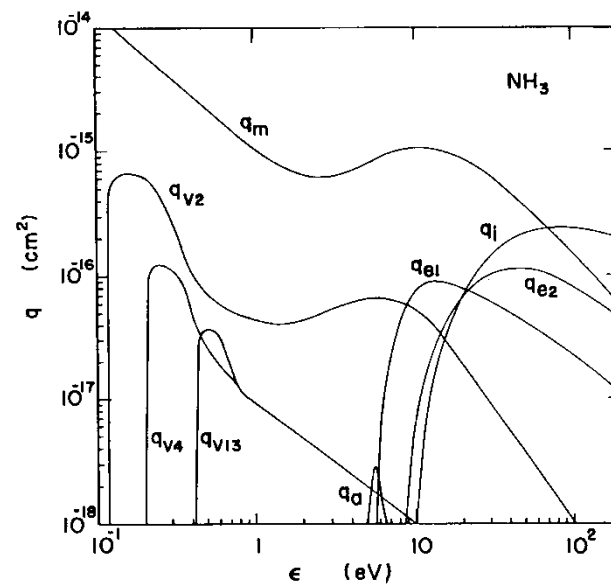
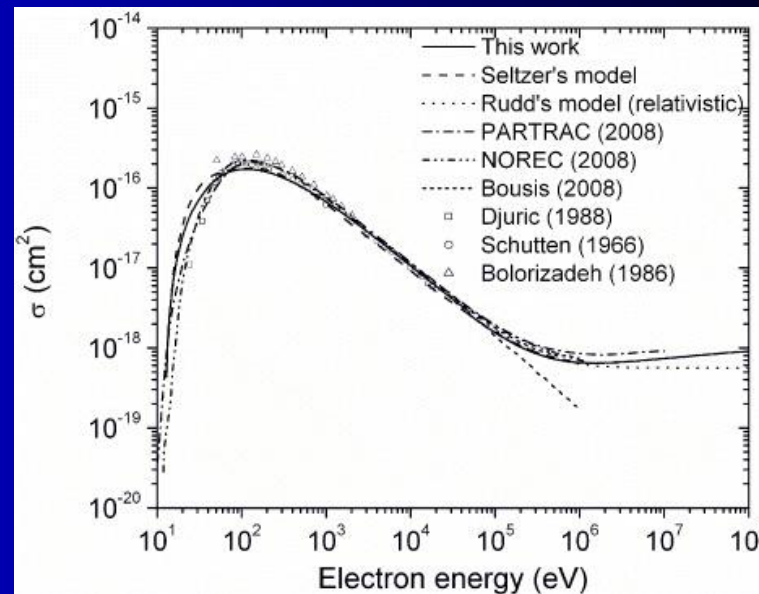
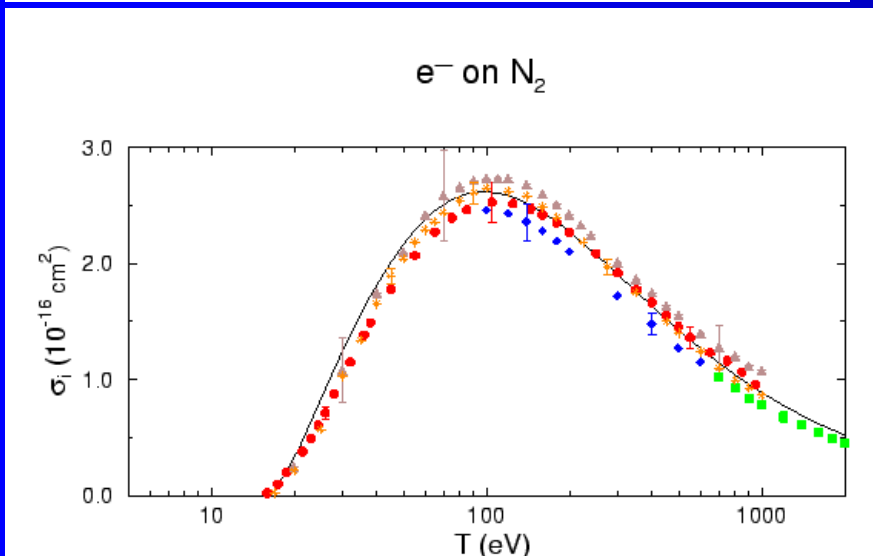
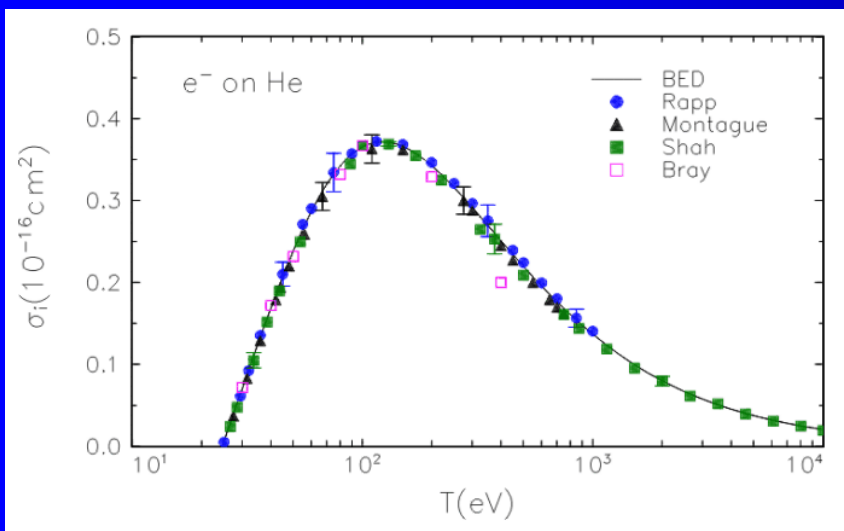


Fig. 6. Electron collision cross-section set for NH₃ (1986).

Ionization cross section He and N₂

Electron impact



BEB W. Hwang, Y.-K. Kim and M.E. Rudd,
J. Chem. Phys. **104**, 2956 (1996).

New J. Phys. **11** (2009) 063047
doi:10.1088/1367-2630/11/6/063047

Cross sections for the interactions of 1 eV–100 MeV electrons in liquid water and application to Monte-Carlo simulation of HZE radiation tracks

Ianik Plante^{1,2} and Francis A Cucinotta¹

Life is not so simple – Total ionization cross section

Electron Interactions with CF₄

L. G. Christophorou,^{a)} J. K. Olthoff, and M. V. V. S. Rao
National Institute of Standards and Technology, Gaithersburg, Maryland 20899-0001

J. Phys. Chem. Ref. Data, Vol. 25, No. 5, 1996

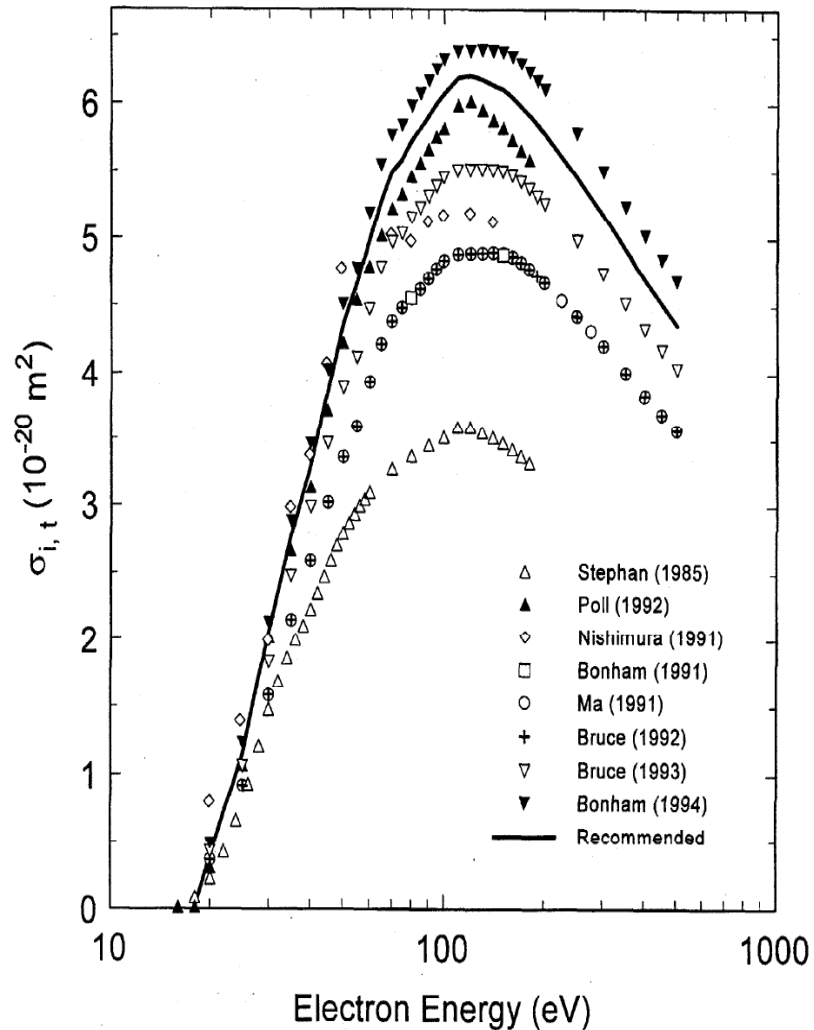


FIG. 17. Total ionization cross section $\sigma_{i,t}(\epsilon)$ as a function of electron energy for CF₄. Measured values: Δ , Ref. 43; \blacktriangle , Ref. 103; \square , Ref. 69; \circ , Ref. 98; $+$, Ref. 100; ∇ , Ref. 104; \blacktriangledown , data of Ref. 104 multiplied by 1.16 (per Bonham in Ref. 73); \diamond , Ref. 106. Recommended: —, average of \blacktriangle and \blacktriangledown (see Sec. 4.1 and Table 12).

Ionization cross section, Different channels have different cross sections and dependencies on energy

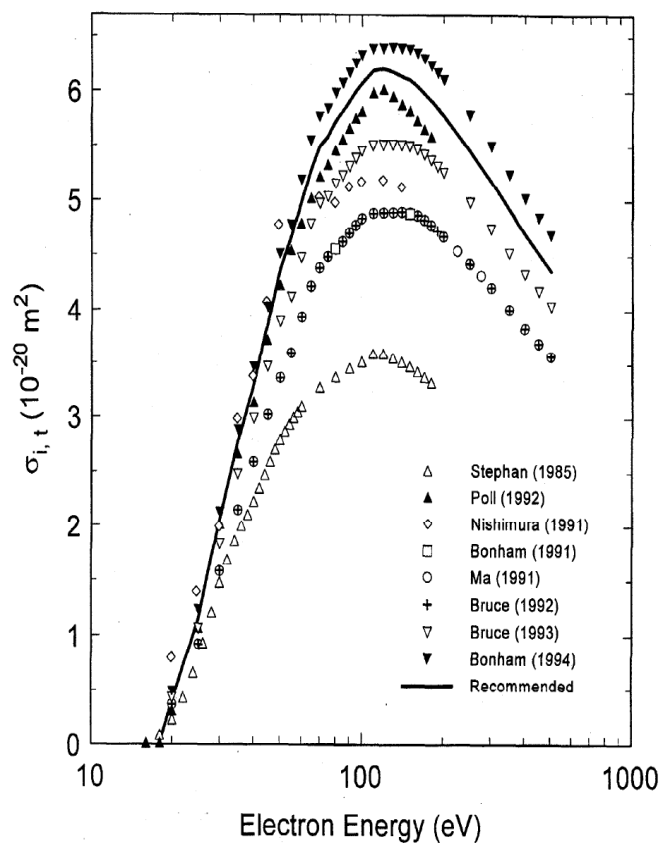


FIG. 17. Total ionization cross section $\sigma_{i,t}(\epsilon)$ as a function of electron energy for CF_4 . Measured values: Δ , Ref. 43; \blacktriangle , Ref. 103; \square , Ref. 69; \circ , Ref. 98; $+$, Ref. 100; ∇ , Ref. 104; \blacktriangledown , data of Ref. 104 multiplied by 1.16 (per Bonham in Ref. 73); \diamond , Ref. 106. Recommended: —, average of \blacktriangle and \blacktriangledown (see Sec. 4.1 and Table 12).

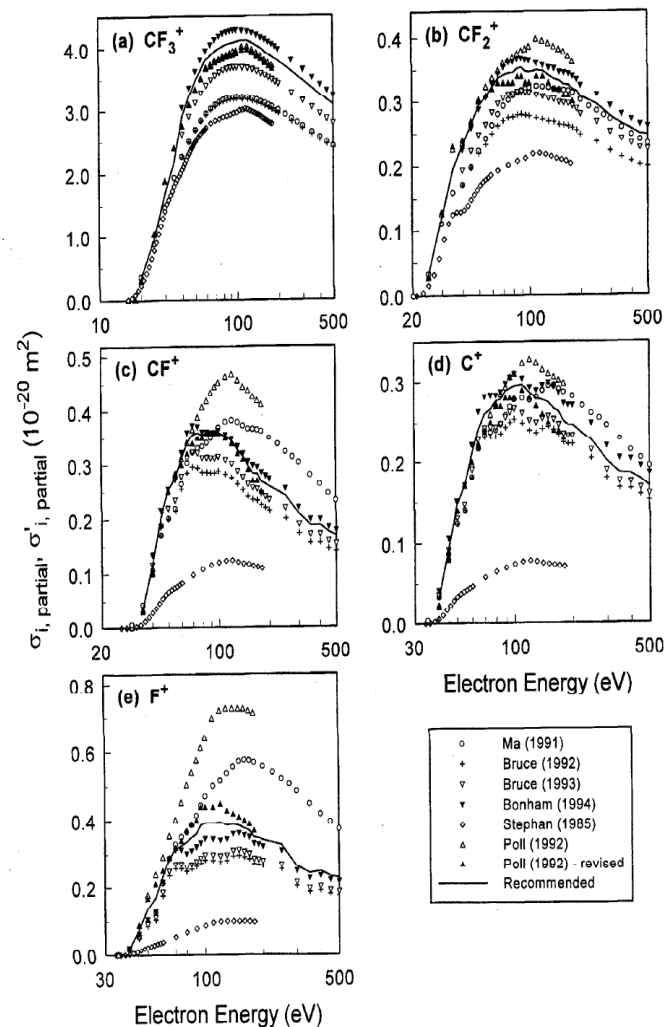


FIG. 19. Partial ionization cross section for the production of (a) CF_3^+ , (b) CF_2^+ , (c) CF^+ , (d) C^+ , and (e) F^+ by electron collision on CF_2 . $\sigma_{i,\text{partial}}(\epsilon)$: \diamond , Ref. 43; Δ , Ref. 103; \circ , Ref. 98. $\sigma_{i,\text{partial}}(\epsilon)$: $+$, Ref. 100; ∇ , Ref. 104; \blacktriangledown , Ref. 73; \blacktriangle , revised data of Ref. 103 (see text). —, average of \blacktriangledown and \blacktriangle (see Sec. 4.2 and Table 15).

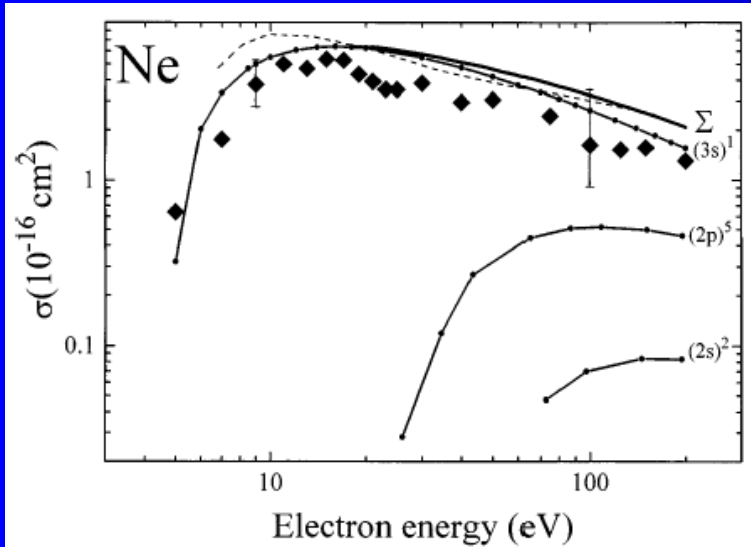
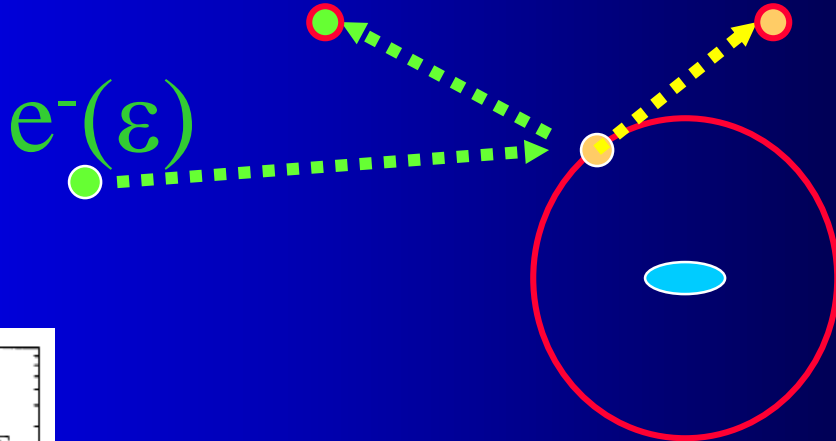
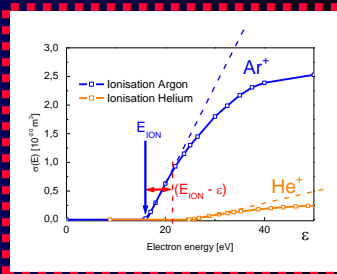
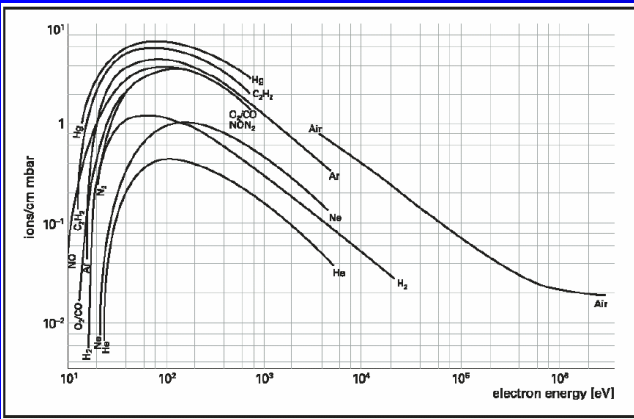
Electron Interactions with CF_4

L. G. Christophorou,^{a)} J. K. Olthoff, and M. V. V. S. Rao

National Institute of Standards and Technology, Gaithersburg, Maryland 20899-0001

Thomson's formula

$$\sigma_j = C_j (\epsilon - E_{ION})$$

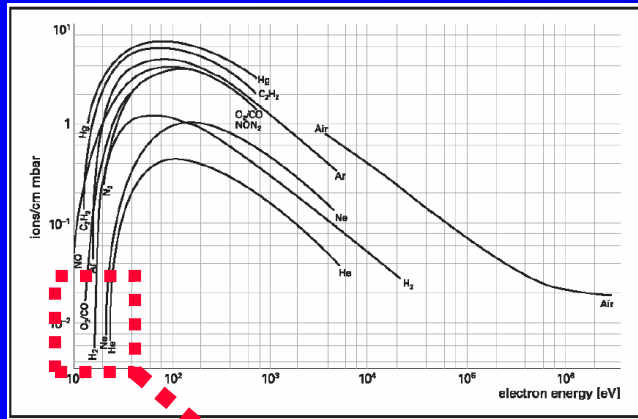


Ionization if $\Delta\epsilon > I$
 Formula of Rutherford for coulomb force
 $d\sigma = e^4 d\Theta / 4\epsilon^2 \sin^4(\phi/2) \dots \sigma_i = \pi e^4 / I \cdot (\epsilon - I) / \epsilon^3$
 $\sigma_i = 4\pi a_0^2 (I_H / \epsilon)^2 \cdot (\epsilon - I) / I$
 $\rightarrow \sigma_i = 4\pi a_0^2 (I_H / \epsilon)^2 \cdot (\epsilon / I - 1) = f_{\text{function}}(\epsilon / I)$

$$\sigma_i = \sum \sigma_{in} \quad \text{sum of the various subshell contributions}$$

Calculated ionization cross section of the 3P_0 state in Ne using the DM formalism. The full curves refer to the contributions from the various subshells and have been labeled appropriately. The sum of the various subshell contributions has been labeled by the symbol Σ . Also shown is the Born calculation of Ton-That and Flannery (broken curve, see text for details). The experimental data points (diamonds) are those of Johnston *et al.* Two typical error bars (combined systematic and statistical uncertainty) are shown for the experimental data.

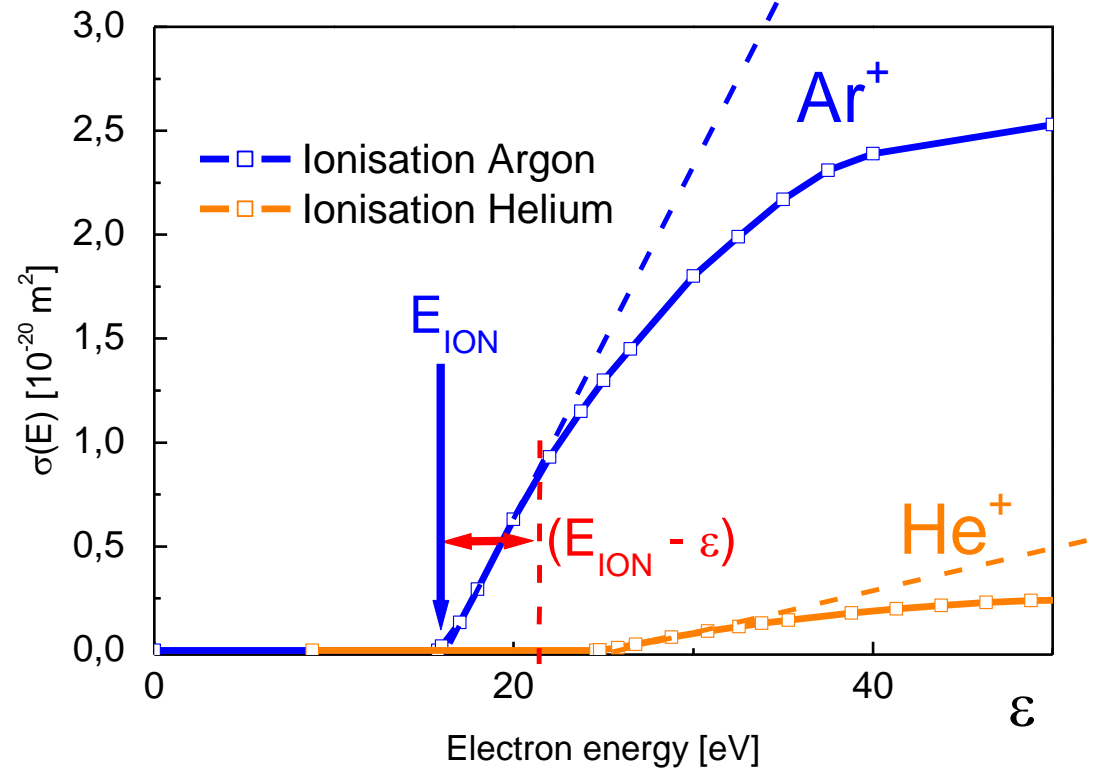
Near the threshold → linear approximation



$$\sigma_i = 4\pi a_0^2 (I_H / \varepsilon)^2 \cdot (\varepsilon - I) / I$$

$$\rightarrow \sigma_i = 4\pi a_0^2 (I_H / \varepsilon)^2 \cdot (\varepsilon / I - 1) = f_{\text{function}}(\varepsilon / I)$$

$$\sigma_j = C_j (\varepsilon - E_{\text{ION}})$$



Ionization cross section recent studies Ar - higher approximation

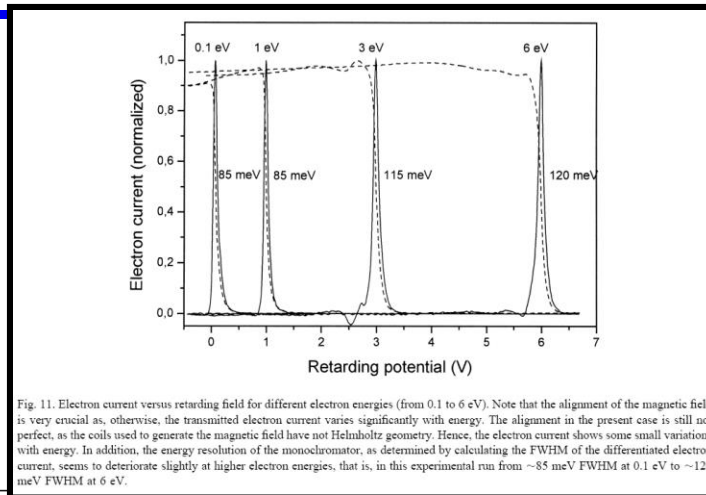
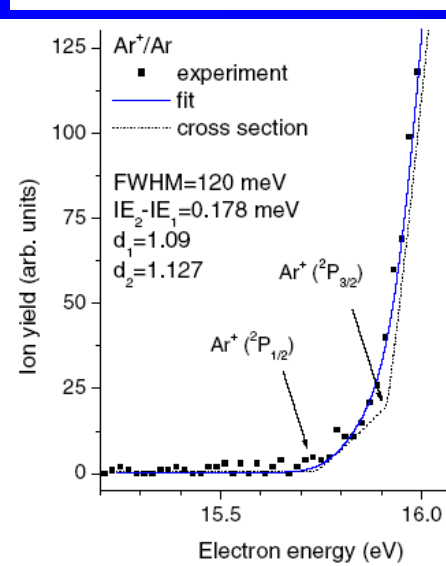


Fig. 11. Electron current versus retarding field for different electron energies (from 0.1 to 6 eV). Note that the alignment of the magnetic field is very crucial as, otherwise, the transmitted electron current varies significantly with energy. The alignment in the present case is still not perfect, as the coils used to generate the magnetic field have not Helmholtz geometry. Hence, the electron current shows some small variations with energy. In addition, the energy resolution of the monochromator, as determined by calculating the FWHM of the differentiated electron current, seems to deteriorate slightly at higher electron energies, that is, in this experimental run from ~85 meV FWHM at 0.1 eV to ~120 meV FWHM at 6 eV.

IE – ionization energy
EII – electron Impact Ionization

IE of Ar is 15.759+-0.001eV

IE₁ of Ar⁺(²P_{1/2})

IE₂ of Ar⁺(²P_{3/2})

IE₂ - IE₁ = 0.178eV

Figure 2. The ion yield curve Ar⁺/Ar as measured in the present experiment. The full curve is the result of the fitting procedure, involving a convolution of the cross section (dotted curve; the arrows indicating the thresholds for the two spin states) and an electron energy distribution function with a width of 120 meV FWHM (for details see text).

The measured Ar⁺ ion yield is fitted with a function $I(U, \mathbf{p}, s)$:

$$I(U, \mathbf{p}, s) = \sigma_w(E, \mathbf{p}) \cdot f(E, U) dE + s \quad (6)$$

where s is the background signal below the ionization threshold and the cross section σ_w for EII at the ionization threshold of Ar is assumed to have the form:

$$\begin{aligned} \sigma_w(E, \mathbf{p}) = & 0 && \text{for } E < IE_1(\text{Ar}) \\ & A_1(E - IE_1)^{d_1} && \text{for } E > IE_1 \text{ and } E < IE_2 \\ & A_1(E - IE_1)^{d_1} + A_2(E - IE_2)^{d_2} && \text{for } E > IE_2 \end{aligned}$$

Ionization cross sections H_2 – details near the threshold

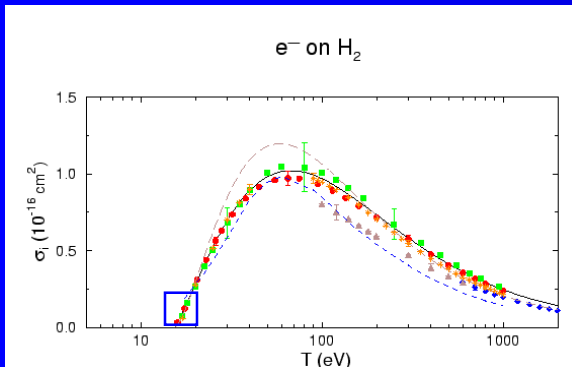


TABLE 13.6
Comparison of observed and calculated energy separation of various vibrational levels of H_2^+

	Energy separations (eV)					
Vibnl. levels	0-1	1-2	2-3	3-4	4-5	5-6
Calculated	0.269	0.254	0.238	0.223	0.208	0.192
Observed	0.272	0.263	0.233	0.237	0.21	0.20

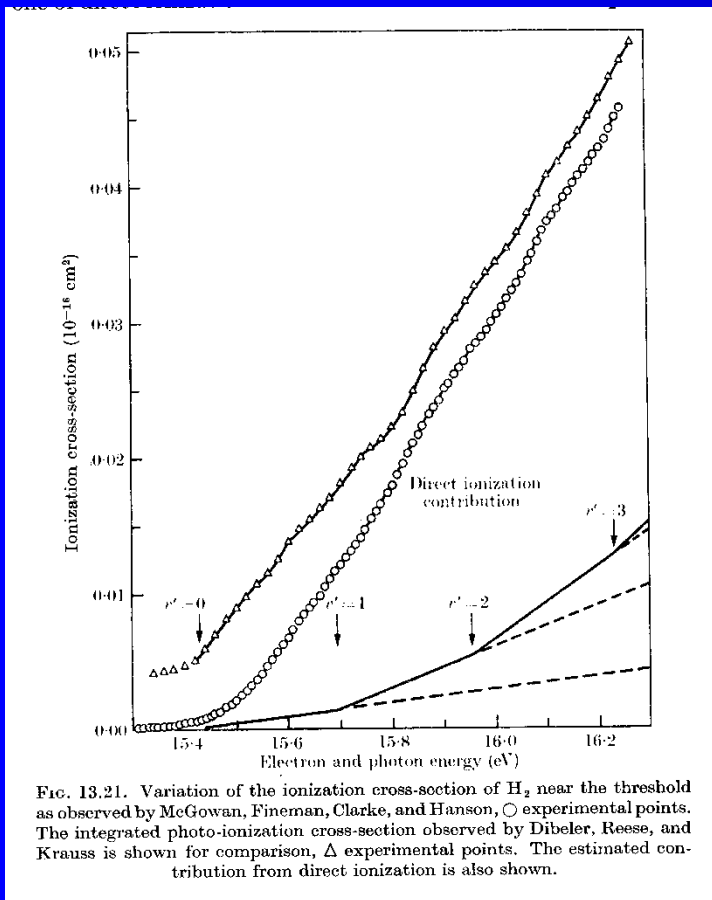


FIG. 13.21. Variation of the ionization cross-section of H_2 near the threshold as observed by McGowan, Fineman, Clarke, and Hanson, \circ experimental points. The integrated photo-ionization cross-section observed by Dibeler, Reese, and Krauss is shown for comparison, Δ experimental points. The estimated contribution from direct ionization is also shown.

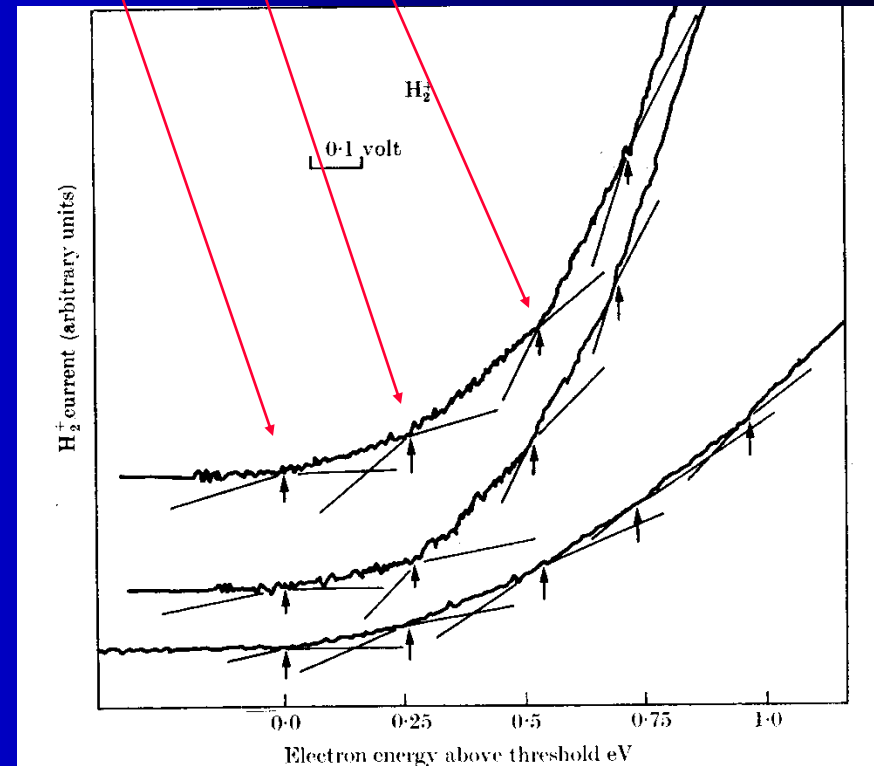


FIG. 13.19. Variation of the ionization cross-section of H_2 near the threshold as observed by Marnet and Kerwin.

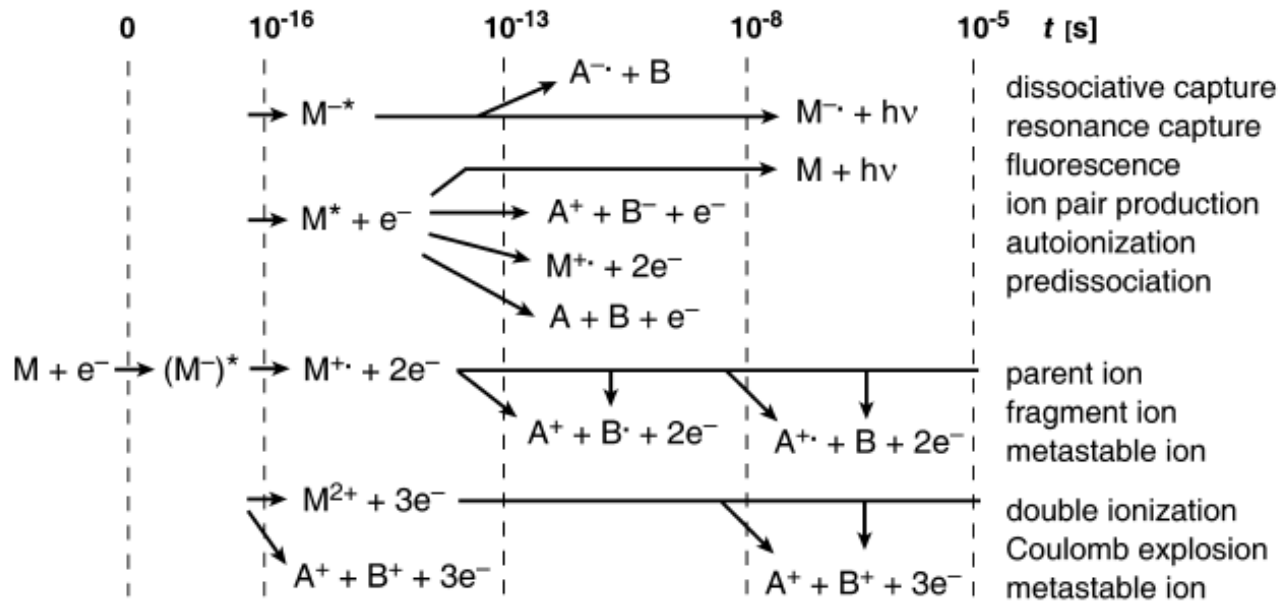
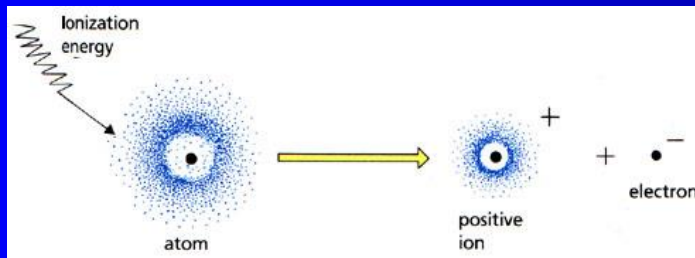
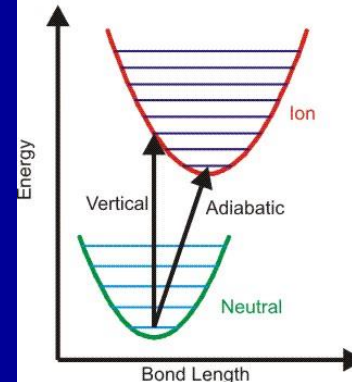


Fig. 2.10. Schematic time chart of possible electron ionization processes. Adapted from Ref. [39] with permission. © Wiley & Sons, 1986.



Potential Energy diagram for diatomic molecule.

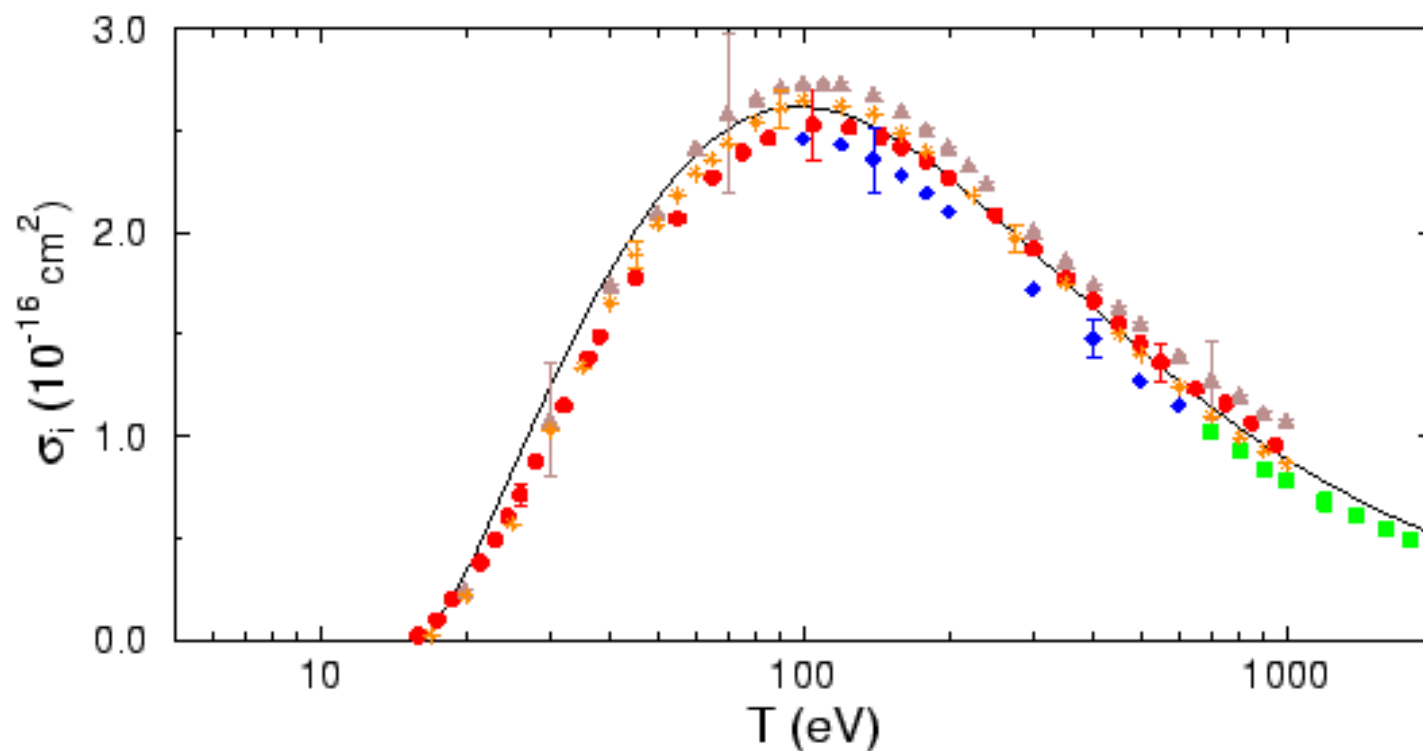


Ionization cross section N_2

BEB

W. Hwang, Y.-K. Kim and M.E. Rudd, J. Chem. Phys. **104**, 2956 (1996).

e^- on N_2



Ionization cross section -acetylene C_2H_2

Product channels

Pragmatic approach

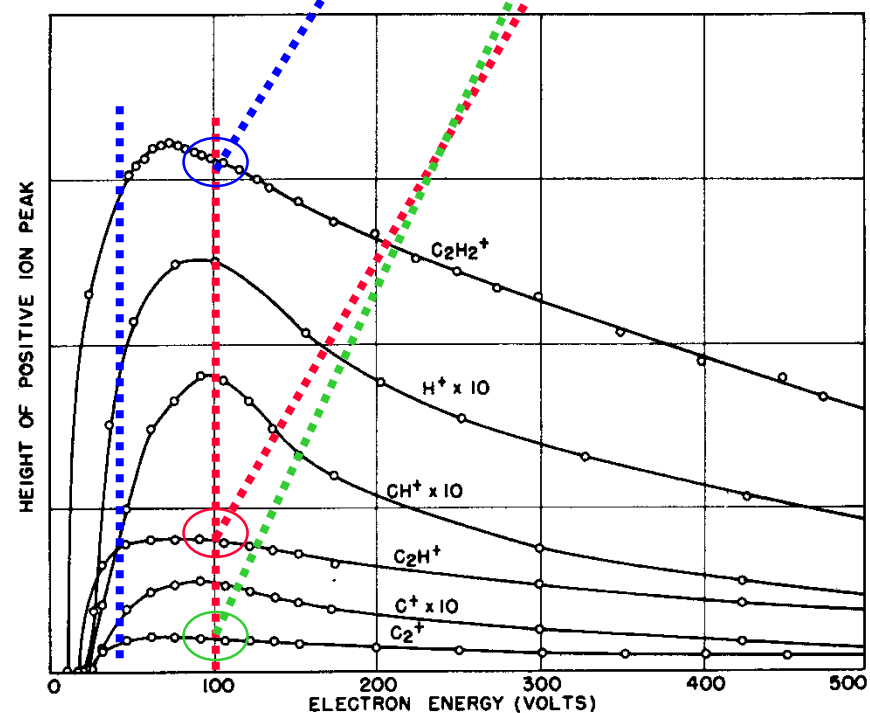
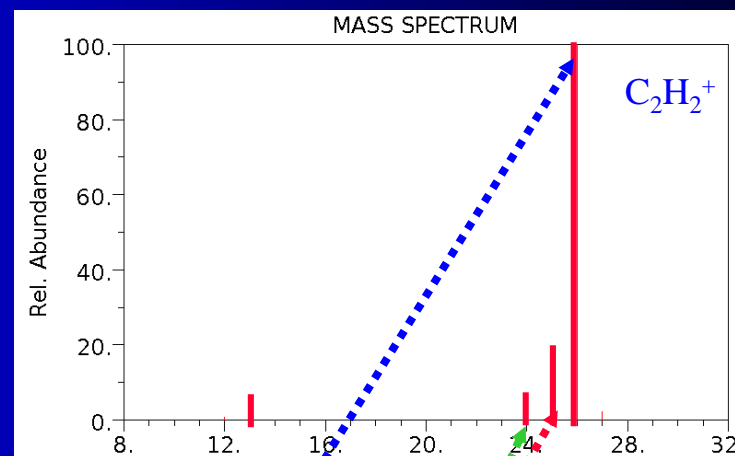
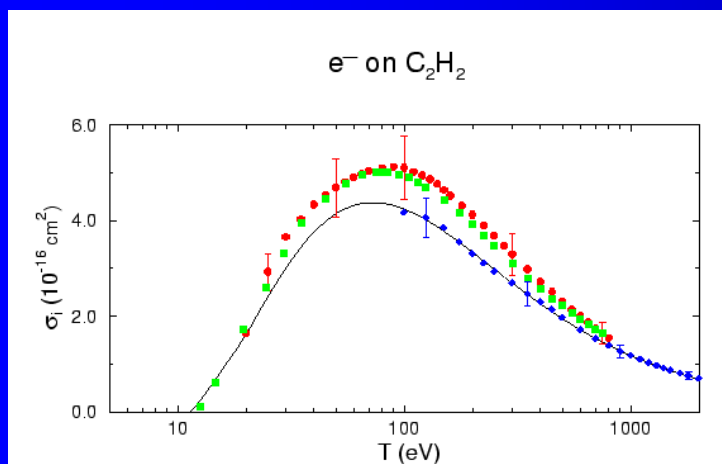
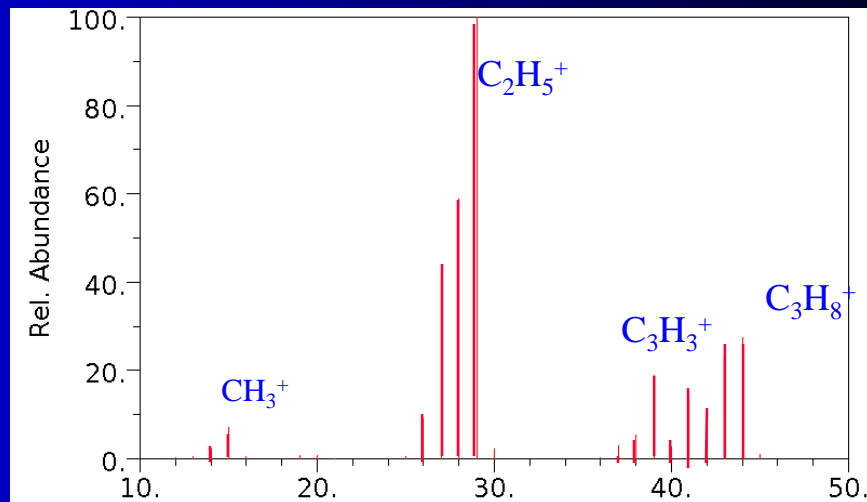
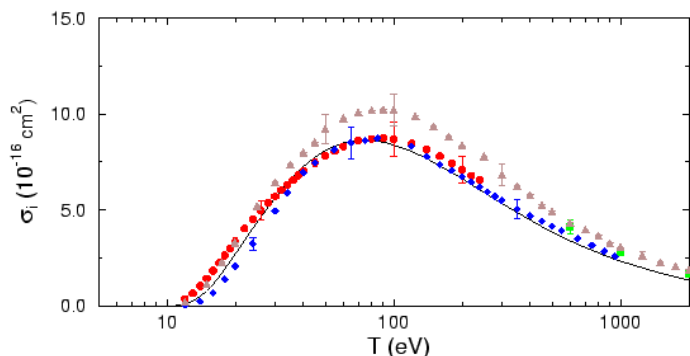


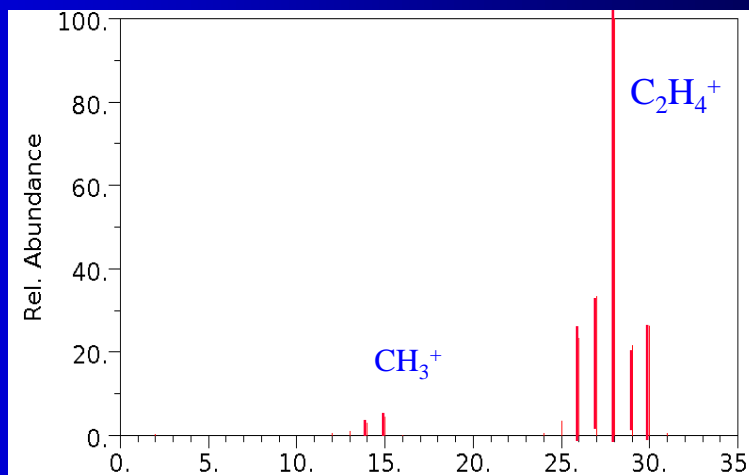
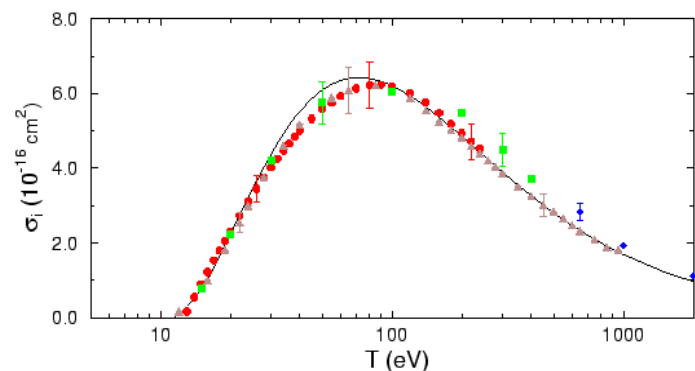
FIG. 6. Ionization efficiency curves for several ions from acetylene (493).

Ionization cross section data from <http://webbook.nist.gov>

e^- on C_3H_8



e^- on C_2H_6

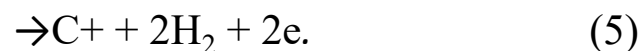
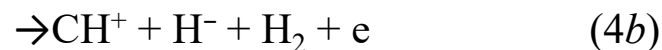
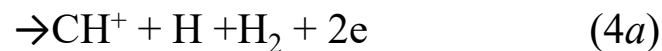
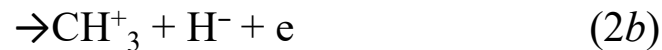


How to recognize spectra ???

Ionization - EII of CH₄

Determination of ionization energies (IEs)

for EII of CH₄ for the following reactions:



$$\sigma w(E, \rho) = 0$$

$$A_1(E - \text{IE}_1)^{d1}$$

for $E < \text{IE}_1(\text{Ar})$

for $E > \text{IE}_1$ and $E < \text{IE}_2$

$$A_1(E - \text{IE}_1)^{d1} + A_2(E - \text{IE}_2)^{d2}$$

for $E > \text{IE}_2$

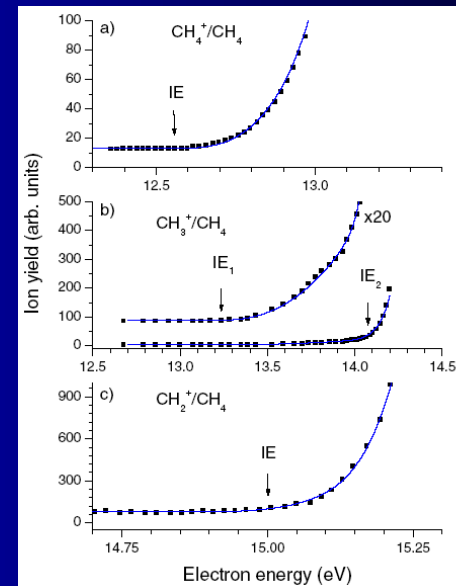


Figure A.1. Ion yield curve for CH_4^+ , CH_3^+ and CH_2^+ / CH_4 obtained through digitalization of the data from [3]. Full curves present fits through these data. Arrows indicate the estimated IEs derived by the fitting procedure.

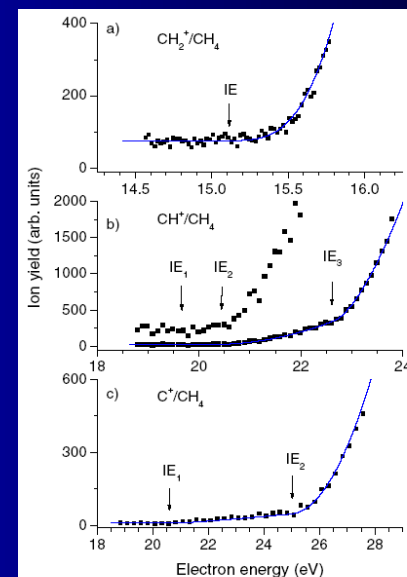


Figure 5. Ion yield curve for CH_2^+ , CH^+ and C^+ / CH_4 as measured at 293 K. Full curves present fits through the experimental data. Arrows indicate the IEs derived by the fitting procedure. Note that for the case of CH^+ only IE_2 and IE_3 have been derived from the present data; IE_1 has been calculated from the known EA of H (see text).

Ionization of He

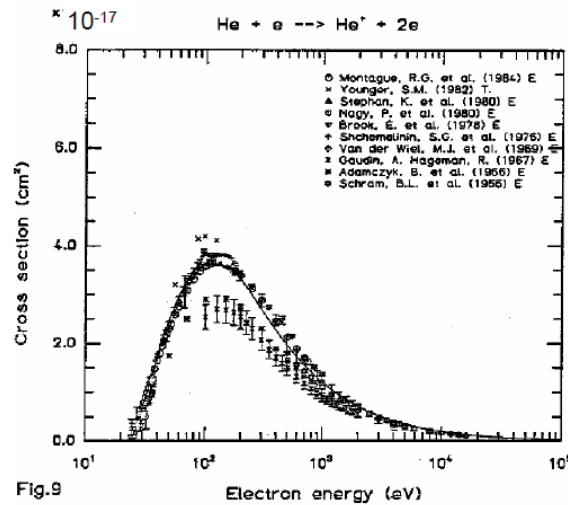
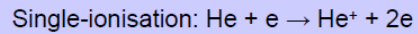


Fig.9

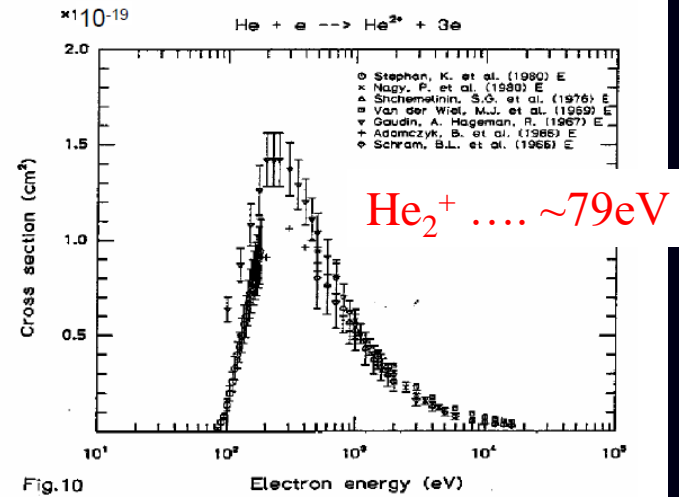
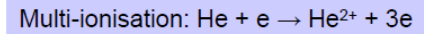


Fig.10

Ionization of the excited state

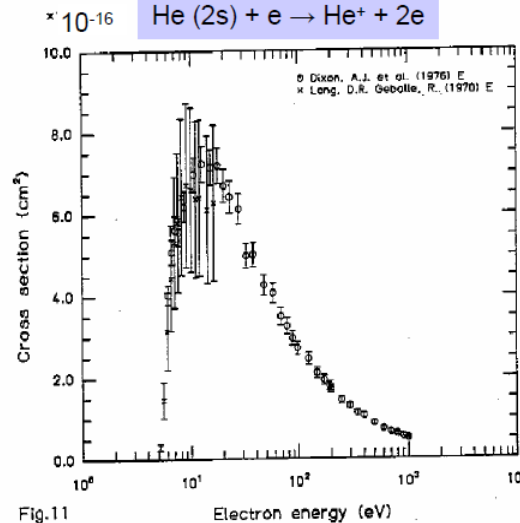
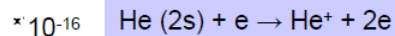


Fig.11

Ionization of singly charged He

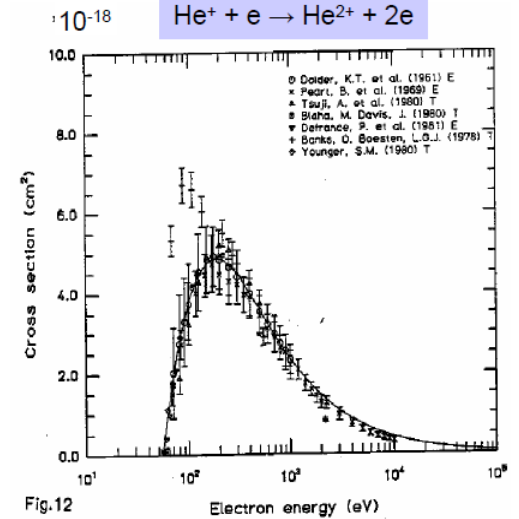
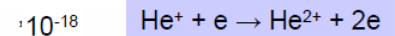
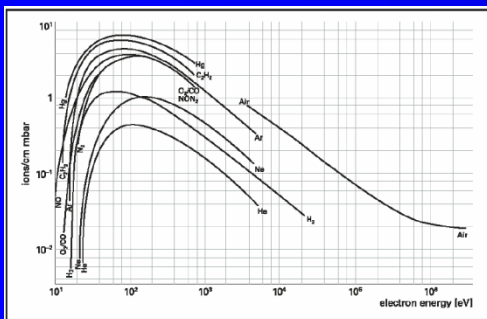


Fig.12



Multiple ionization

Multiple ionization of helium and krypton by electron impact close to threshold: appearance energies and Wannier exponents

J. Phys. B: At. Mol. Opt. Phys. **35** (2002) 4685–4694

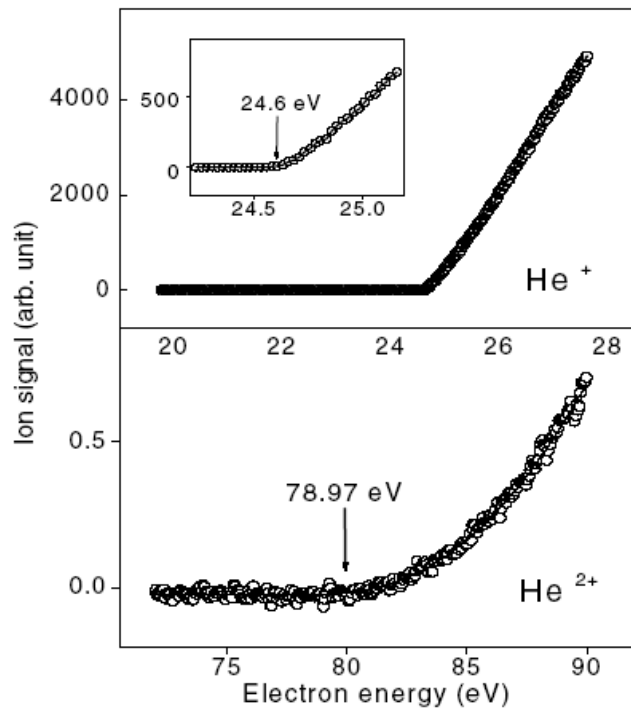


Figure 1. Ion signal as a function of electron energy for the formation of He⁺ ions (top) and He²⁺ ions (bottom) in the near-threshold region. The measured data are shown as open circles, the fits are shown as solid curves. The AEs, which are indicated, are the AEs for the individual data sets shown and may differ from the AE values listed in table 1 which were obtained from a comprehensive analysis of many individual data sets.

Table 1. AE values in eV for the formation of He⁺ and He²⁺ ions in comparison with other measured or calculated AE values.

	Spectroscopic value [1]	Redhead [45]	This work
He ⁺	24.59	—	24.6 ± 0.15
He ²⁺	79.00	77.58	79.05 ± 0.3

He²⁺ ~79eV

Multiple ionization

Multiple ionization of helium and krypton by electron impact close to threshold: appearance energies and Wannier exponents

J. Phys. B: At. Mol. Opt. Phys. **35** (2002) 4685–4694

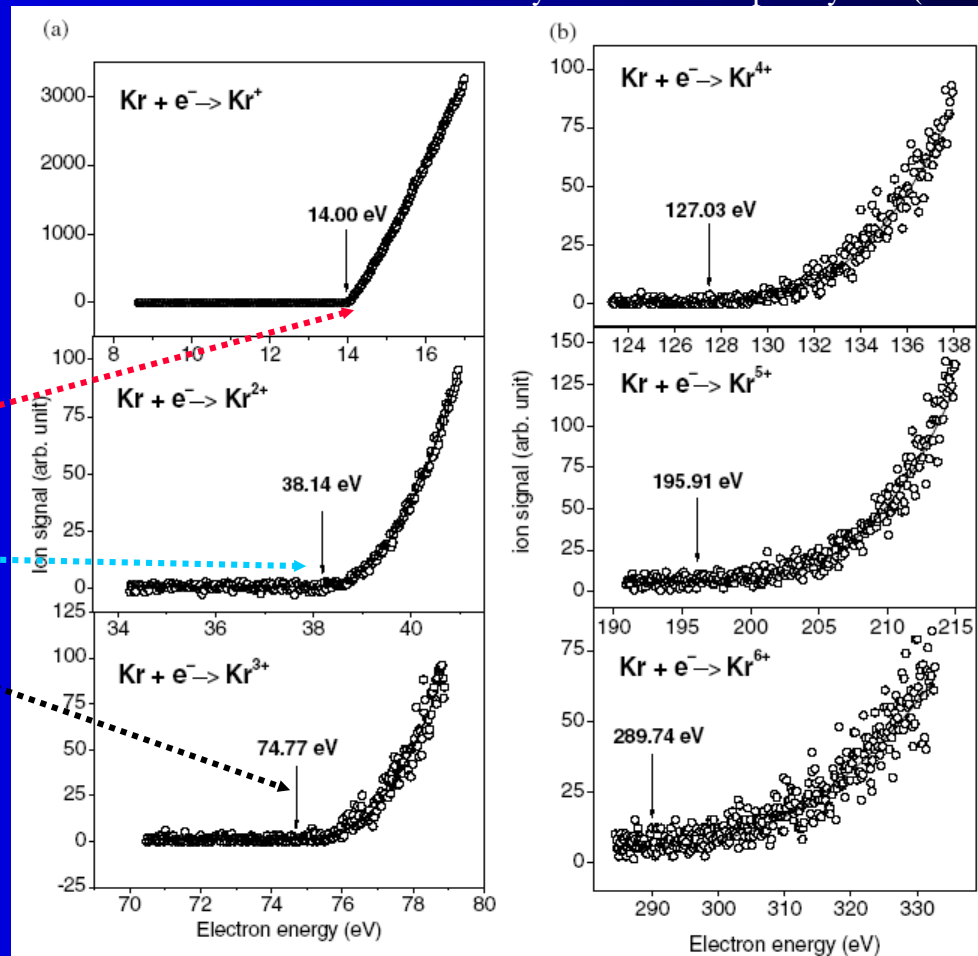
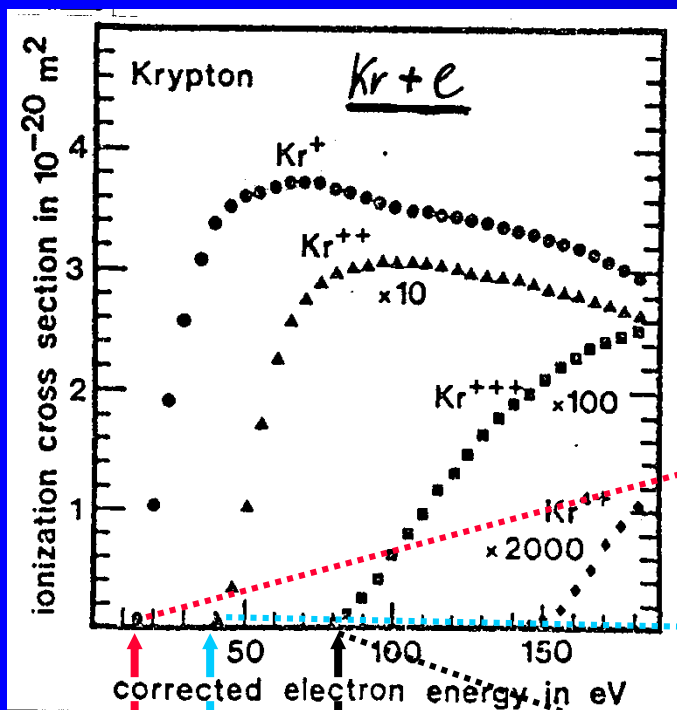
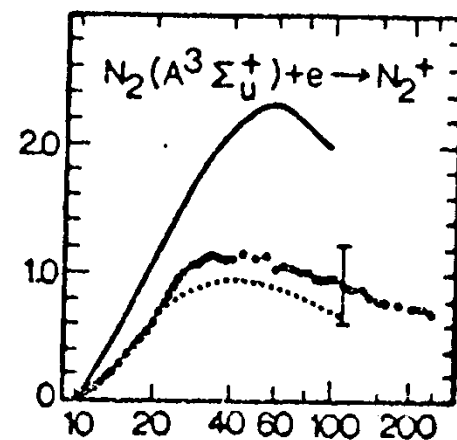
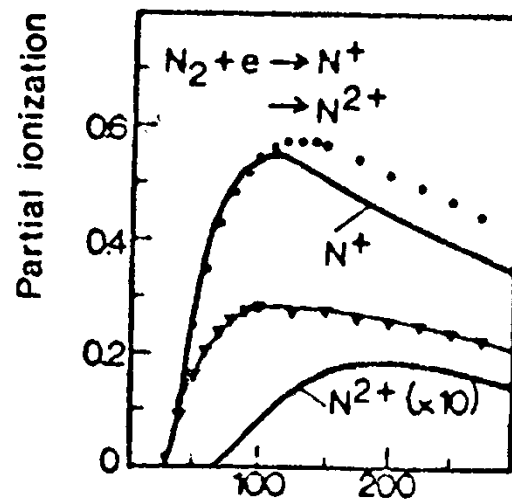
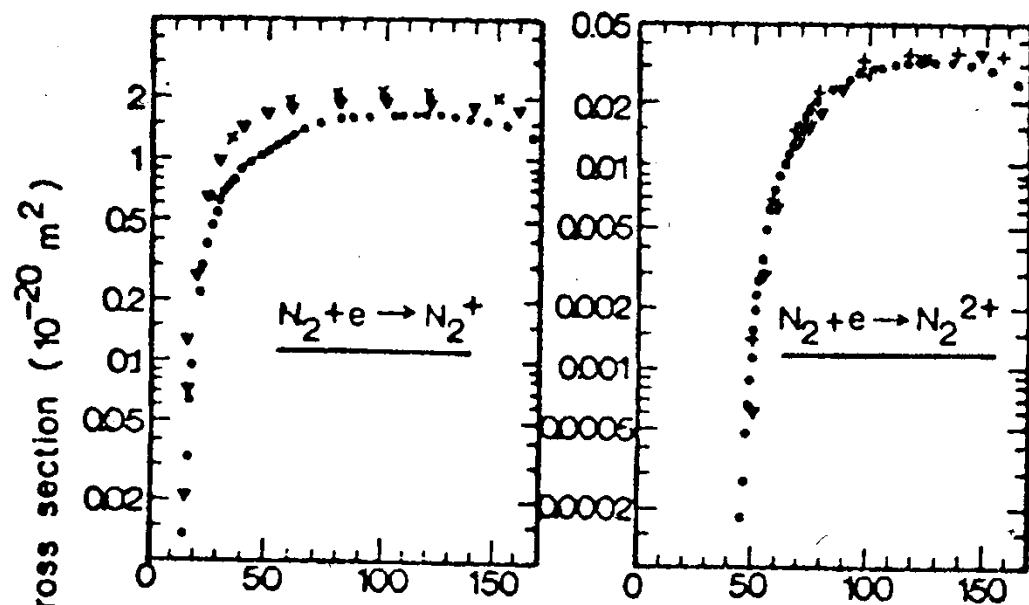
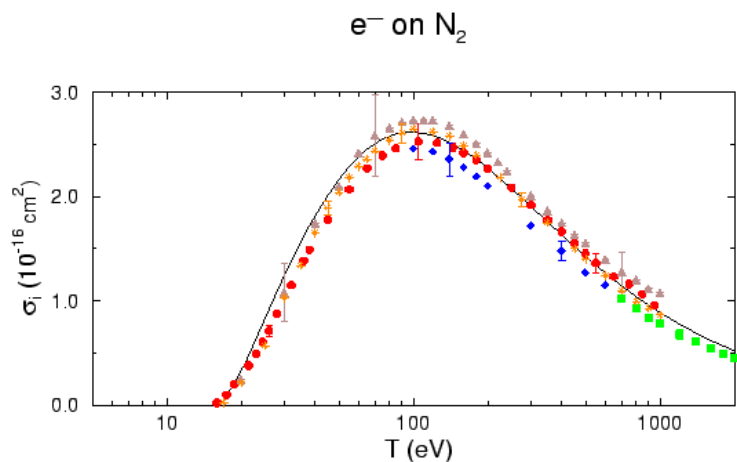


Figure 2. Ion signal as a function of electron energy for the formation of Kr^{n+} ions ($n = 1-6$) in the near-threshold region. The measured data are shown as open circles, the fits are shown as solid curves. The AEs, which are indicated, are the AEs for the individual data sets shown and may differ from the AE values listed in table 2 which were obtained from a comprehensive analysis of many individual data sets.

Multiple ionization

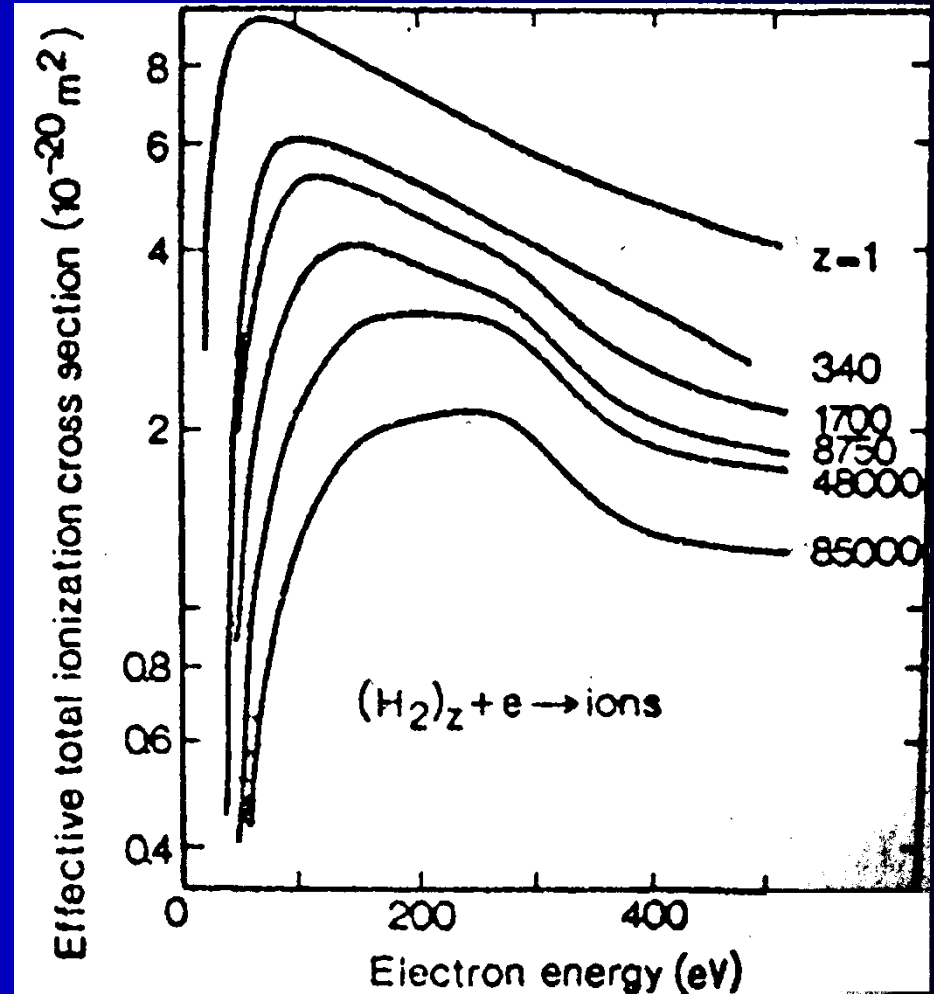


Electron energy (eV)

Ionization of clusters



$$\sigma_{\text{average total}} = Z \cdot \sigma_{\text{effective}}$$



Ionization of C60 Fulleren

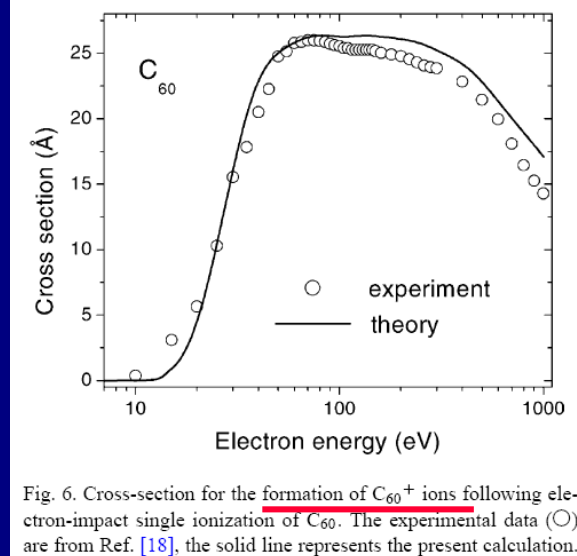
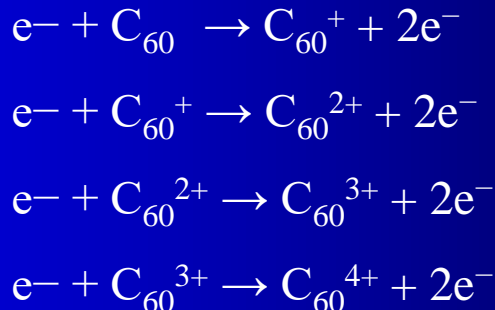
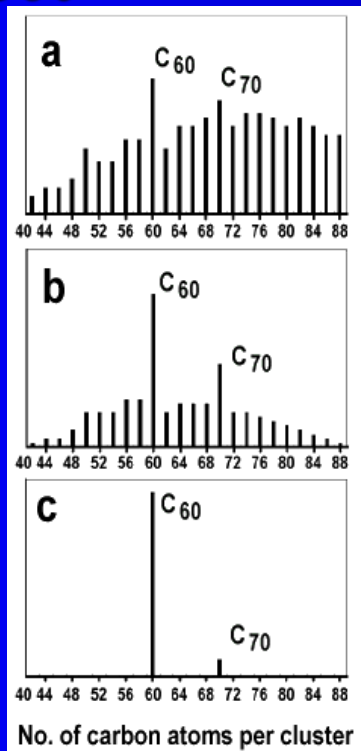
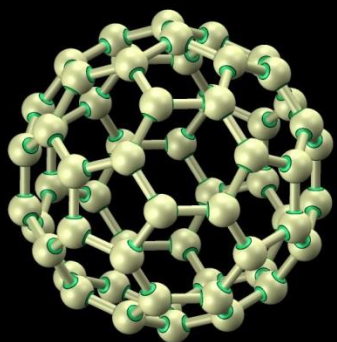


Fig. 6. Cross-section for the formation of C_{60}^+ ions following electron-impact single ionization of C_{60} . The experimental data (\circ) are from Ref. [18], the solid line represents the present calculation.

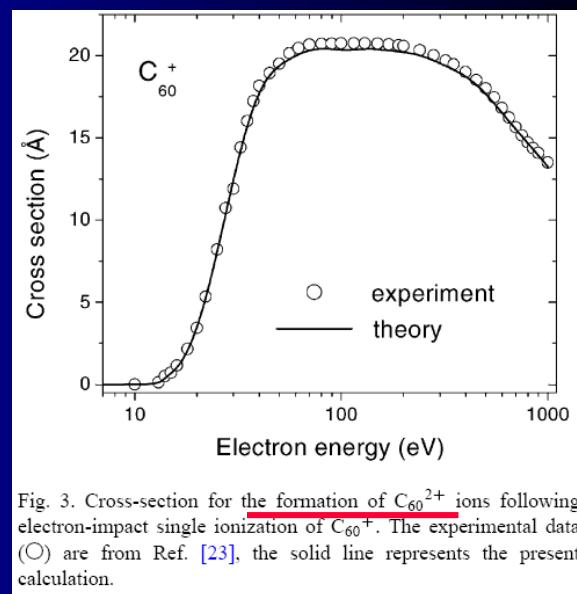
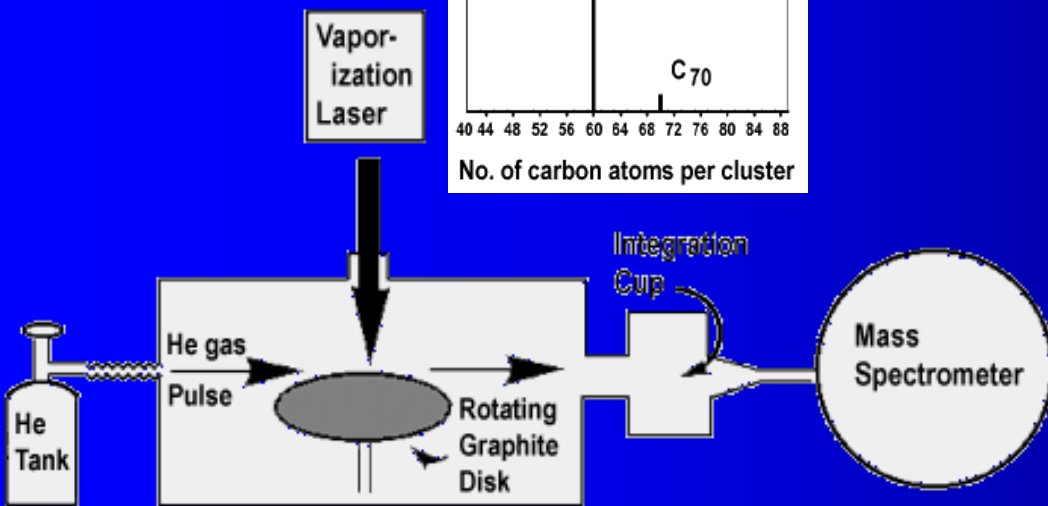


Fig. 3. Cross-section for the formation of C_{60}^{2+} ions following electron-impact single ionization of C_{60}^+ . The experimental data (\circ) are from Ref. [23], the solid line represents the present calculation.



Distribution of carbon clusters produced under various experimental conditions.

- a) Low helium density over graphite target at time of laser vaporization.
- b) High helium density over graphite target at time of laser vaporization.
- c) Same as b), but with addition of "integration cup" to increase time between vaporization and cluster analysis.

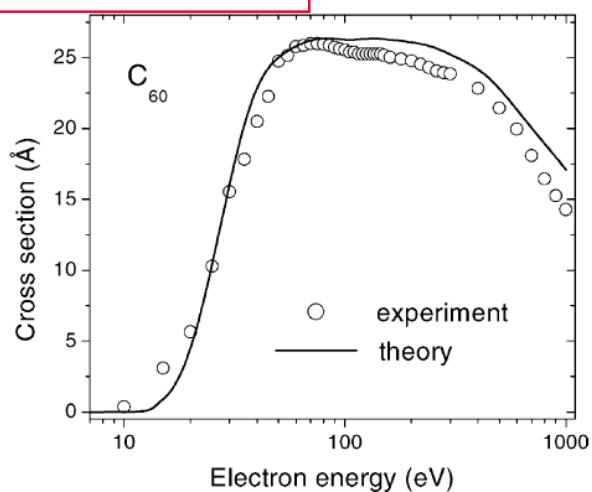
Electron-Impact Induced Fragmentation of Fullerene Ions

The measurements were performed employing the electron-ion crossed-beam setup. A commercially available powder of fullerenes was evaporated with an electrically heated oven. The neutral vapor was introduced into a 10 GHz Electron Cyclotron Resonance Ion Source (ECRIS). The extracted ion beam was collimated to $2 \times 2 \text{ mm}^2$ after mass to charge analysis and crossed with an intense electron beam. The energy of the electrons can be varied between 10 and 1000 eV. After the electron-ion interaction the fragment ions C_{58}^{q+} were separated from the incident ion beam of C_{60}^{q+} by a 90° magnet and detected by a single-particle detector. The flight time between the interaction of the C_{60}^{q+} ions and the analysis of the product ions is in the order of $10 \mu\text{s}$. The current of the parent ion beam was measured simultaneously in a Faraday cup.

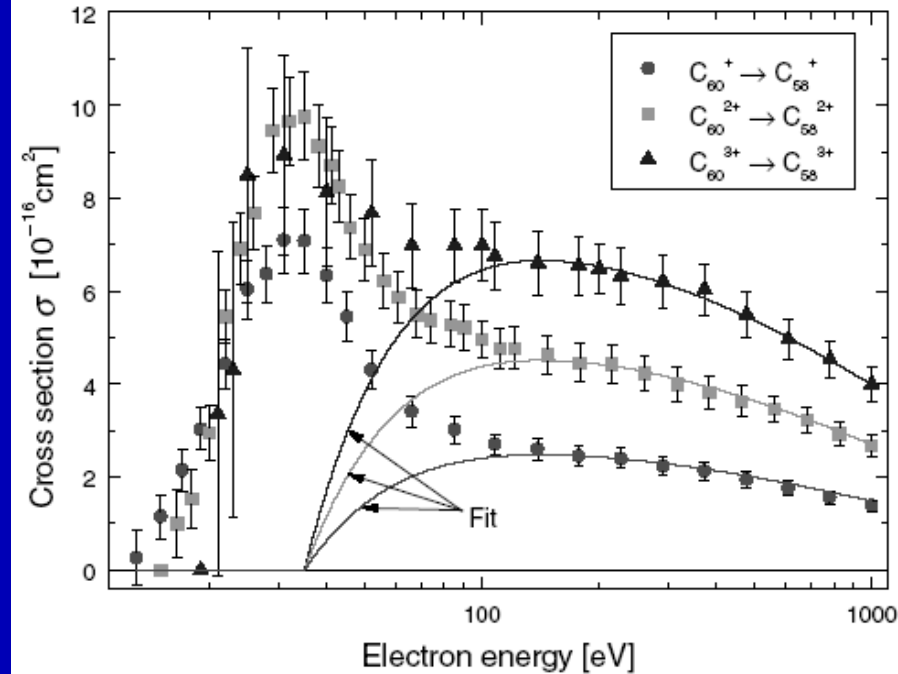
Binding energy value of about 11 eV



IONIZATION



FRAGMENTATION



Absolute cross sections σ for the electron-impact induced C_2 fragmentation of C_{60}^{q+} ions.

Electron-Impact Induced Ionization of Fullerene Ions

IONIZATION

A semi-empirical concept for the calculation of electron-impact ionization cross-sections of neutral and ionized fullerenes

International Journal of Mass Spectrometry 223–224 (2003) 1–8

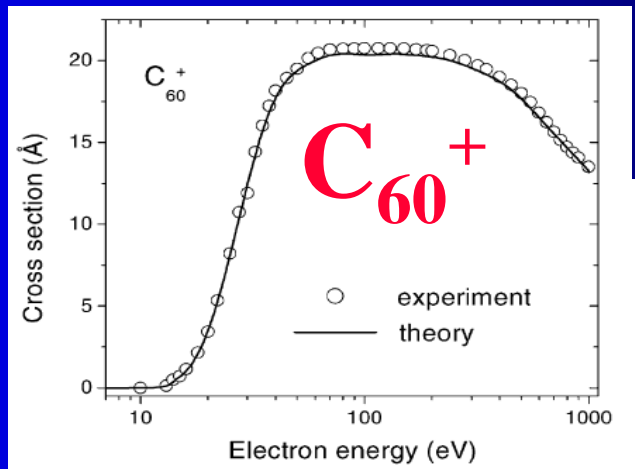
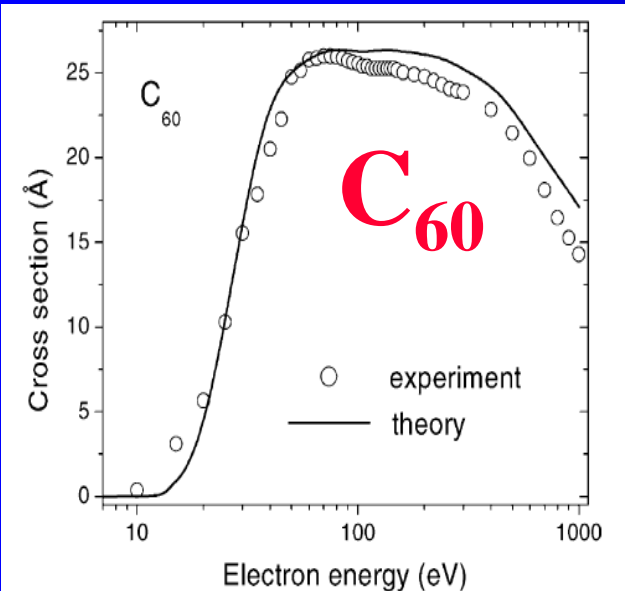


Fig. 3. Cross-section for the formation of C_{60}^{2+} ions following electron-impact single ionization of C_{60}^+ . The experimental data (○) are from Ref. [23], the solid line represents the present calculation.

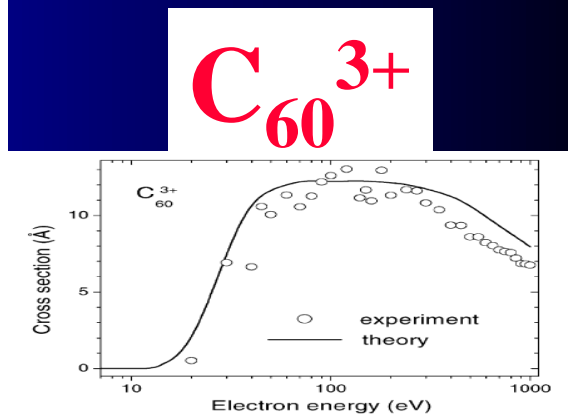
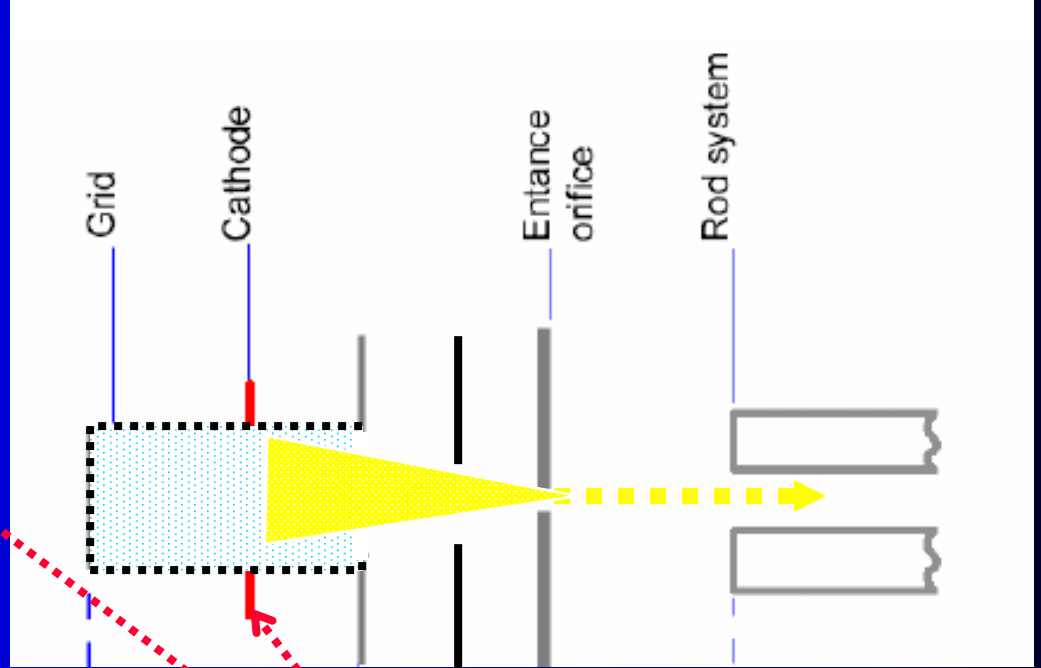
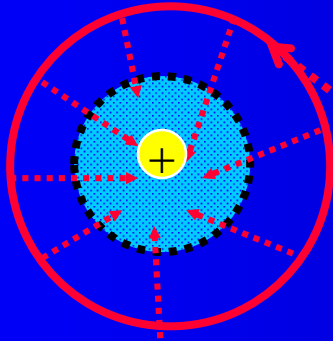


Fig. 4. Cross-section for the formation of C_{60}^{2+} ions following electron-impact single ionization of C_{60}^{3+} . The experimental data (○) are from Ref. [23], the solid line represents the present calculation.

High efficiency Grid ion source



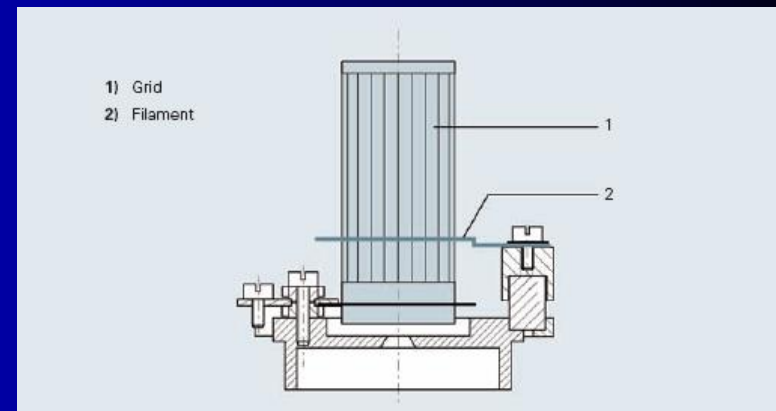
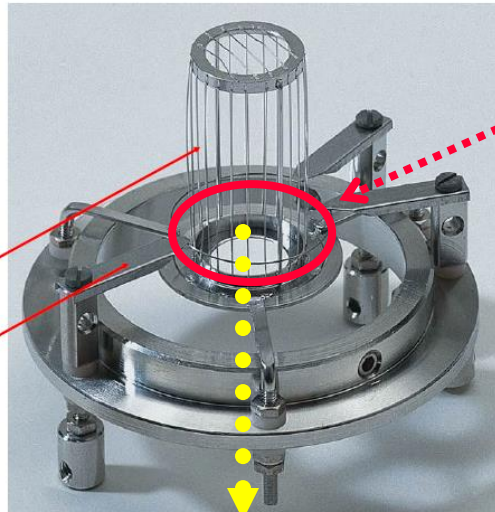
Ion optics

Mass filter

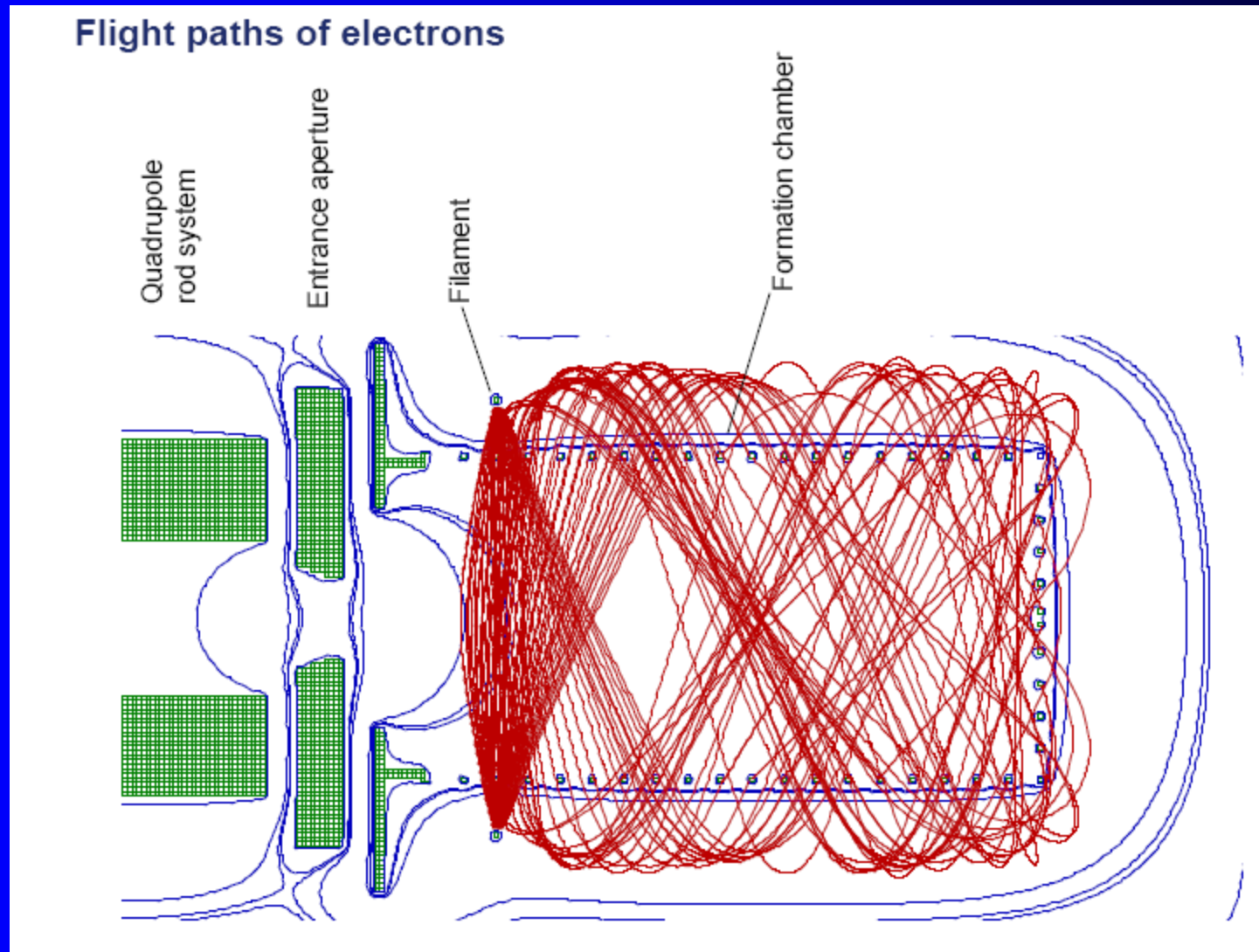
Filament

Grid ion source

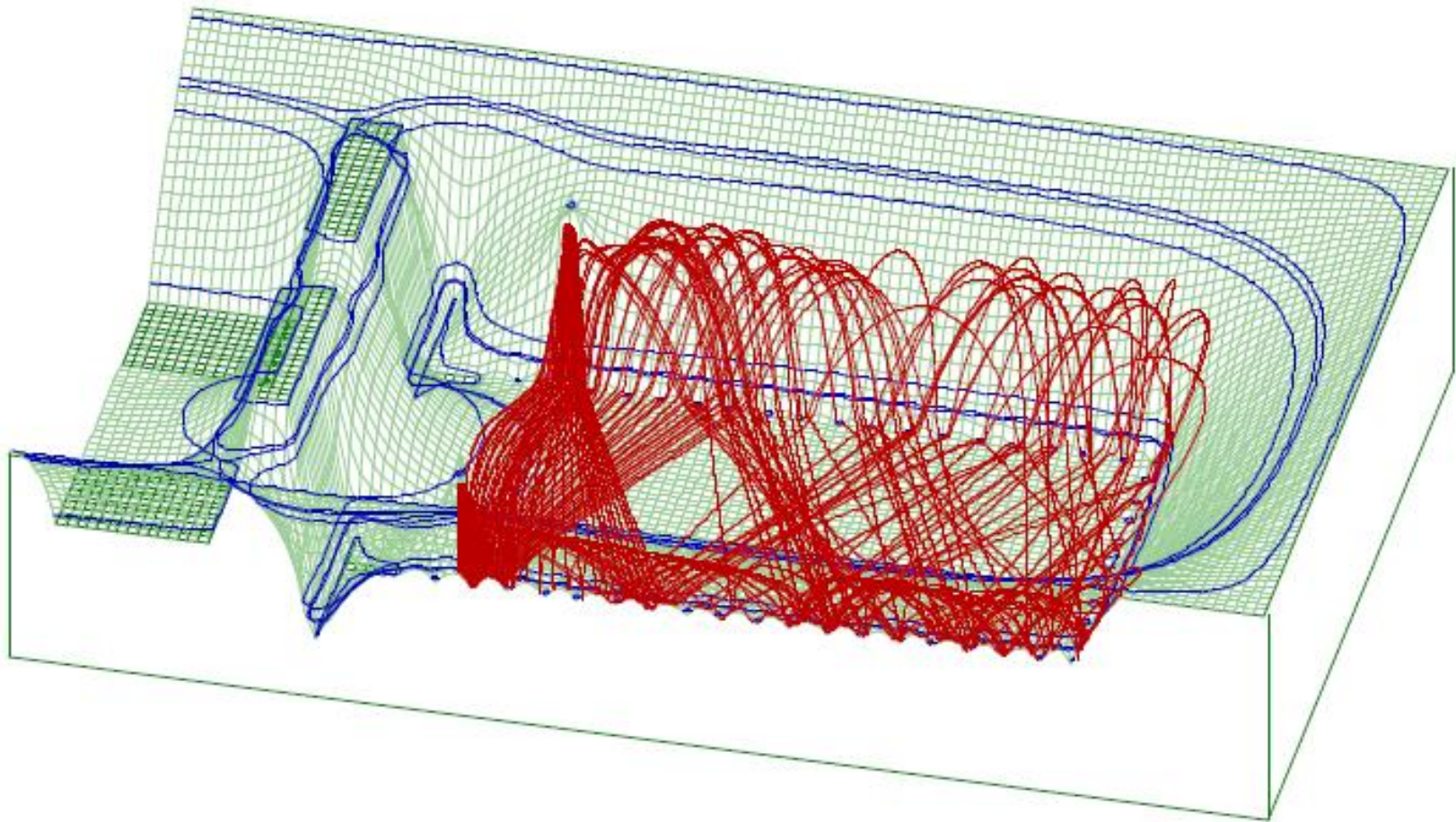
- Open design
- Two filaments (W)
- Low degassing rate
 - minimum amount of material
 - Pt-Ir wires for formation chamber
 - Molybdenum filament holders
- Easy to degas via electron bombardment
- Filaments on positive potential



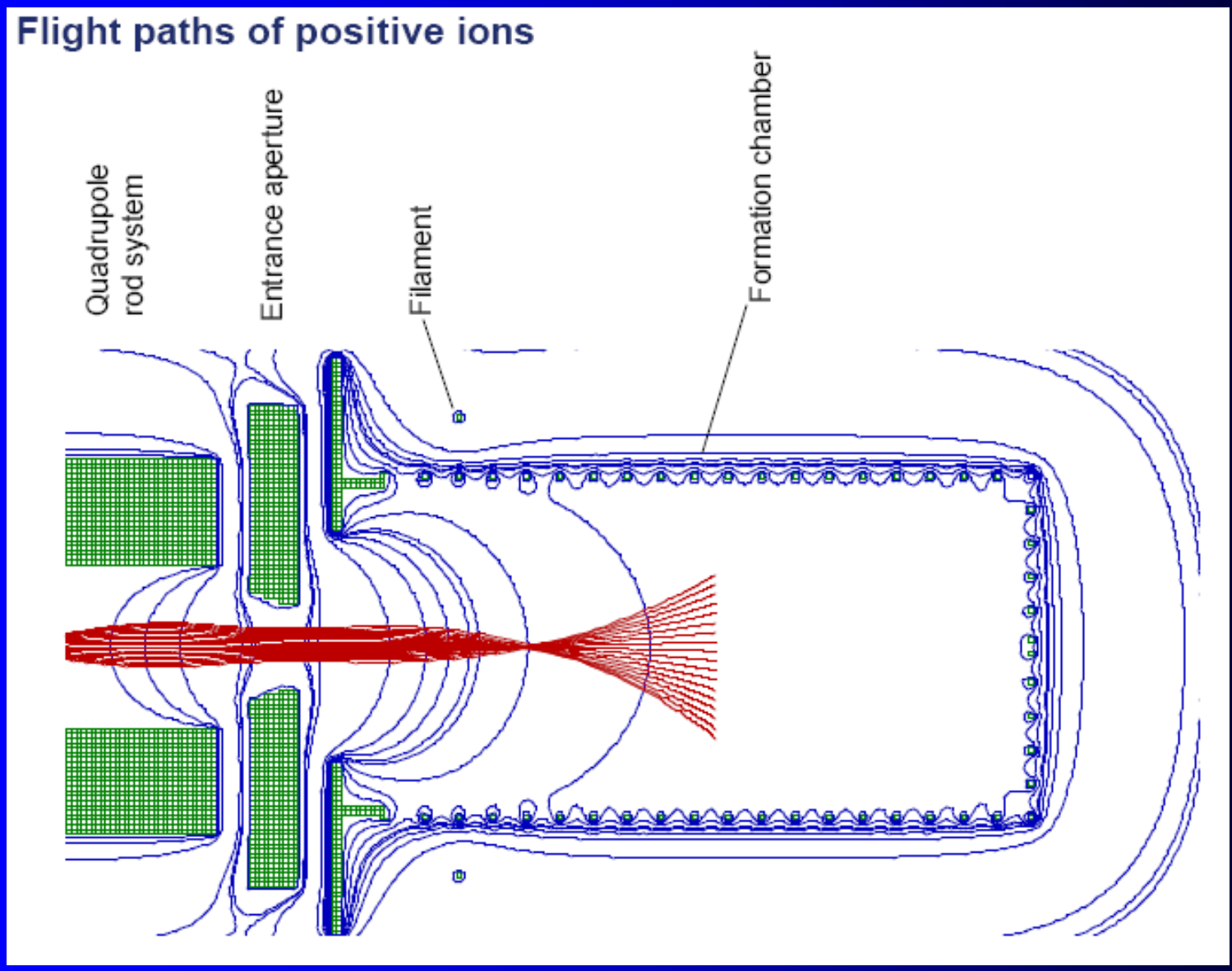
Flight paths of electrons



Flight paths of electrons 3D

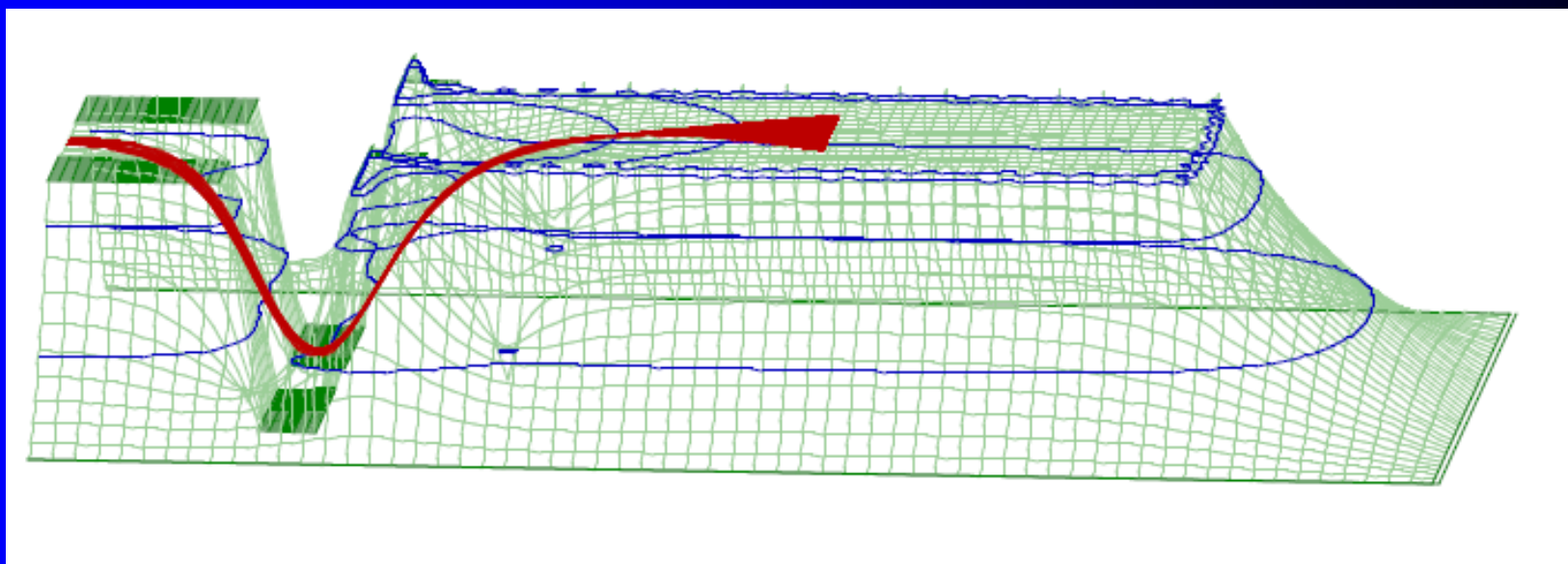
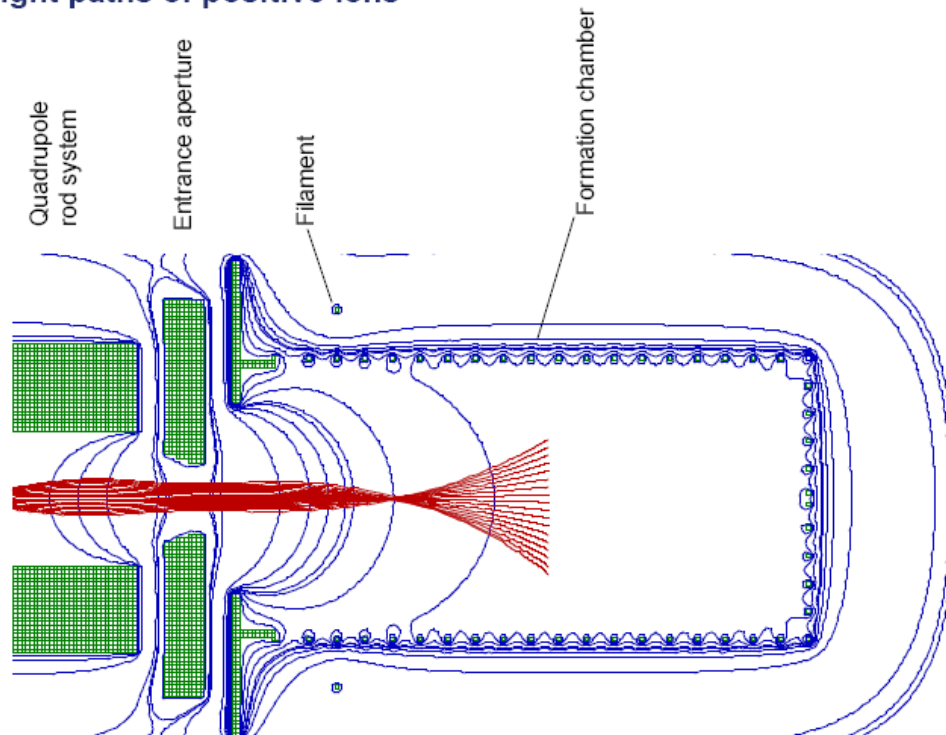


Flight paths of positive ions

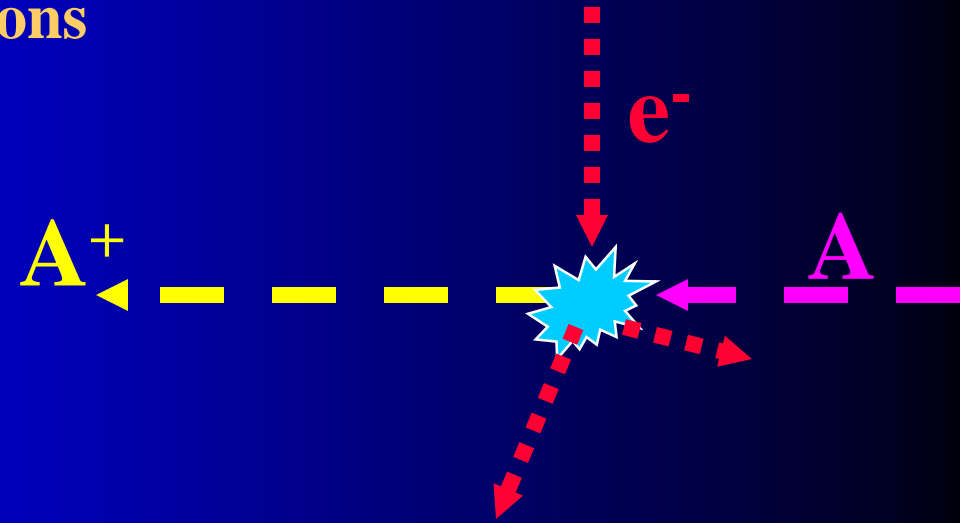
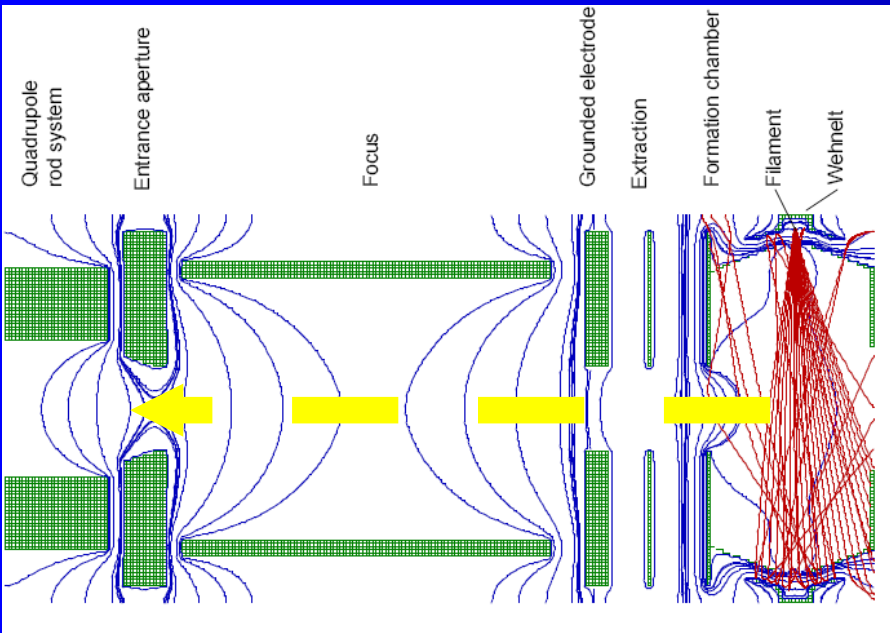


Flight paths of ions 3D

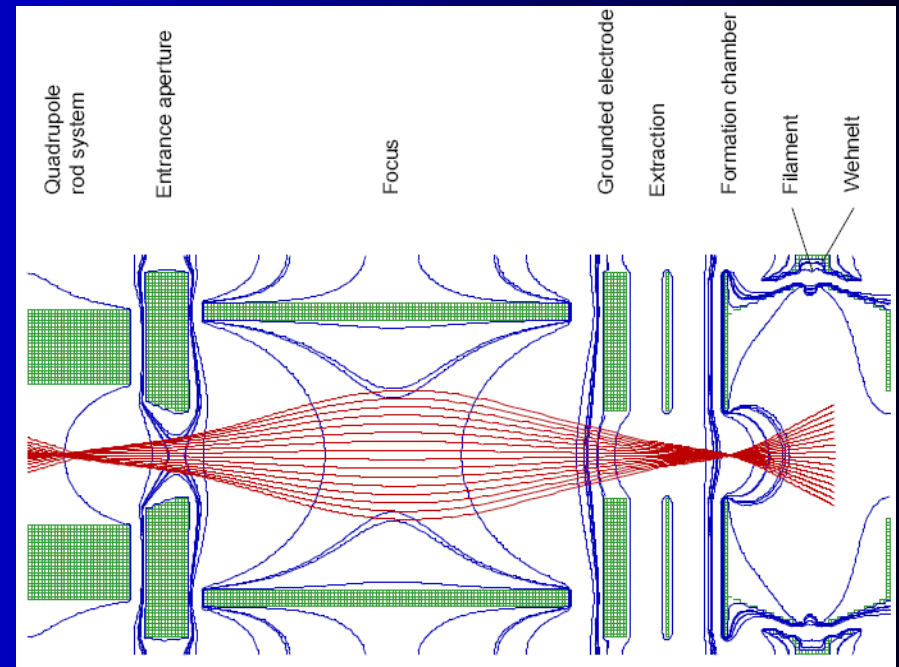
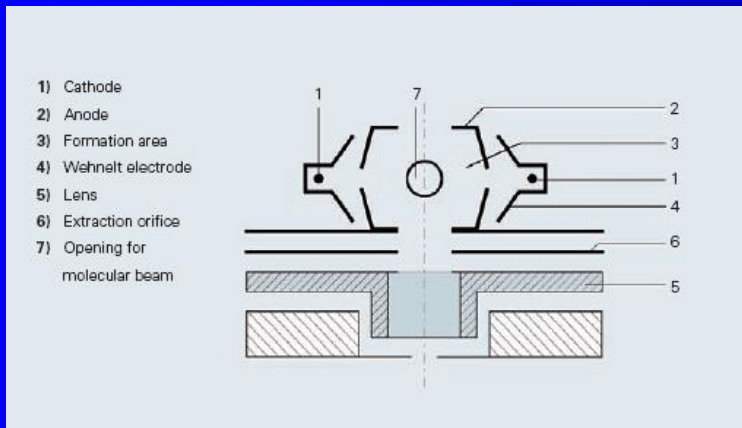
Flight paths of positive ions



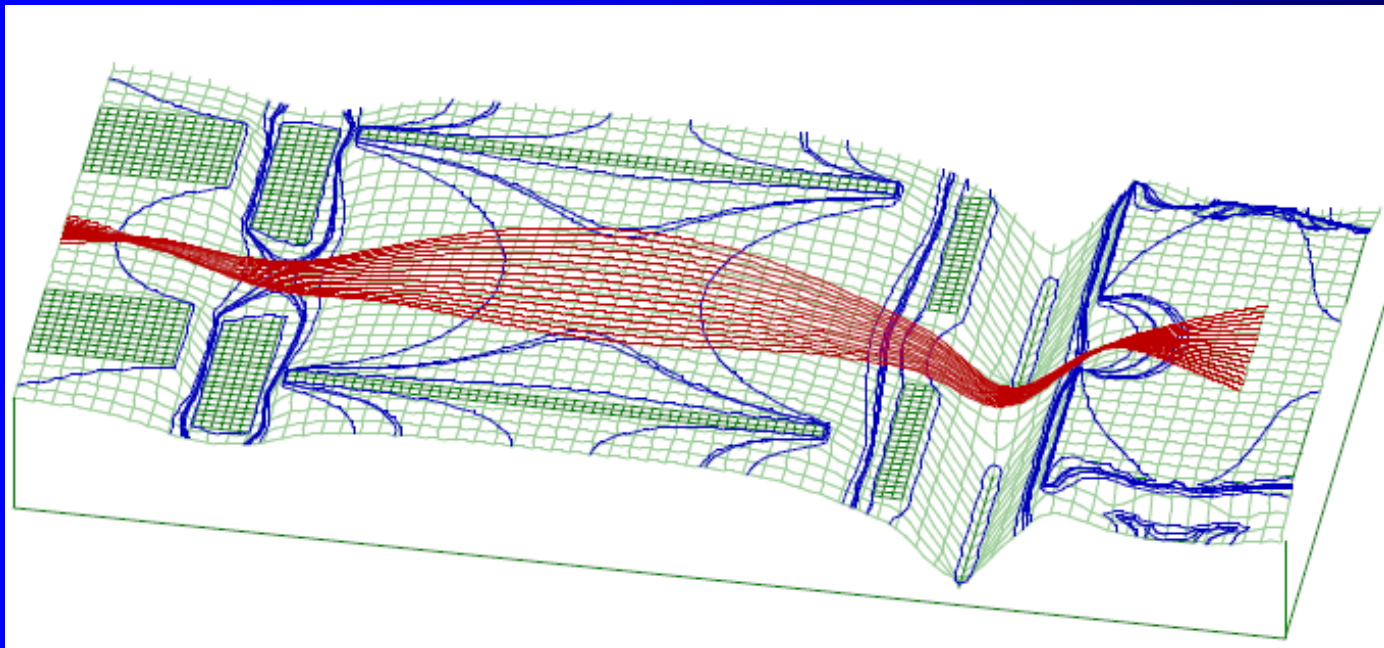
Cross Beam ion Source, calculations



Crossbeam ion source



Cross Beam ion Source



Cross Beam ion source
with magnets

- Two filaments
- Easy to degas
- Good ion focussing
- Bakeable to 300°C



Mass spectrometer



16 mm rod system for highest resolution, stability and transmission (e.g. He/D₂ separation)

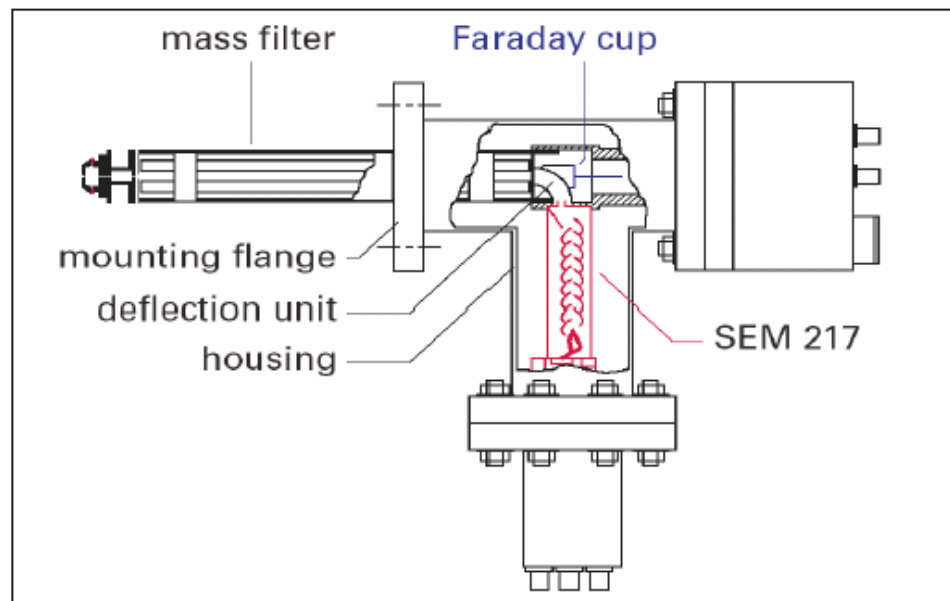
8 mm rod system for High-End RGA and analytical applications

6 mm rod system for common RGA

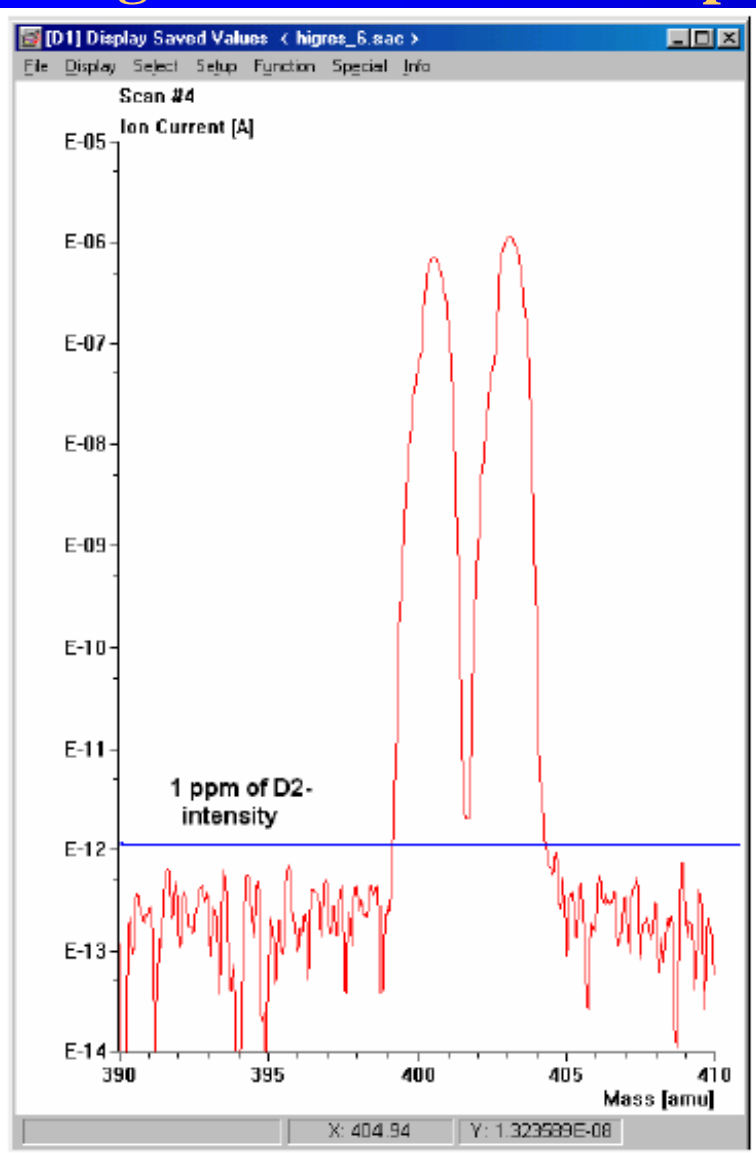
90° off axis arrangement

efficient suppression of

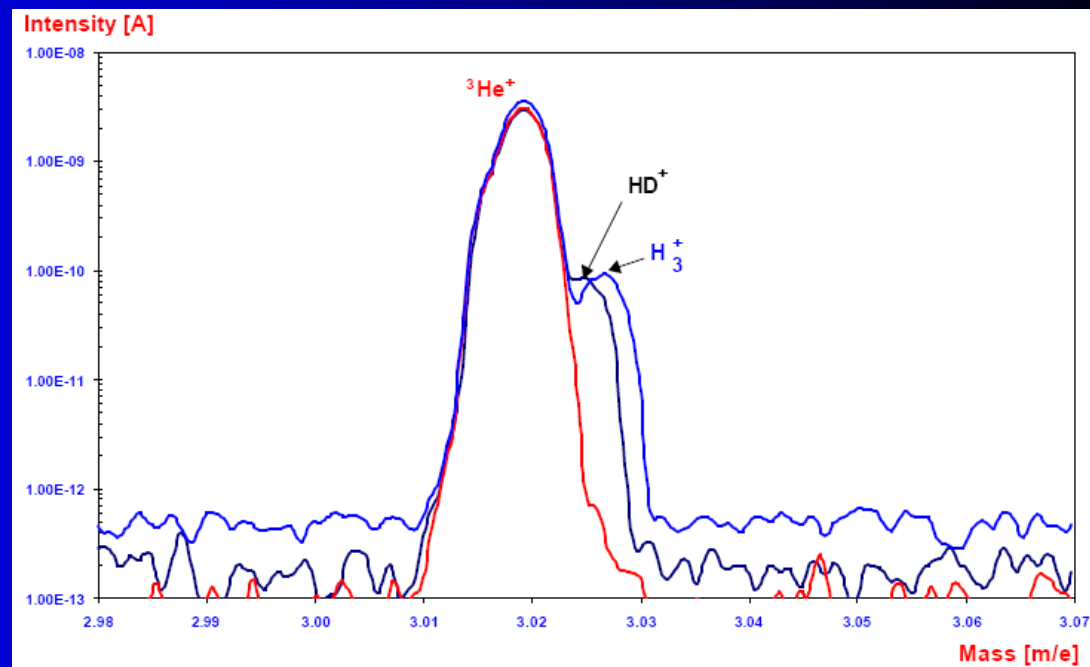
- photons
- fast neutral particles
- stray ions



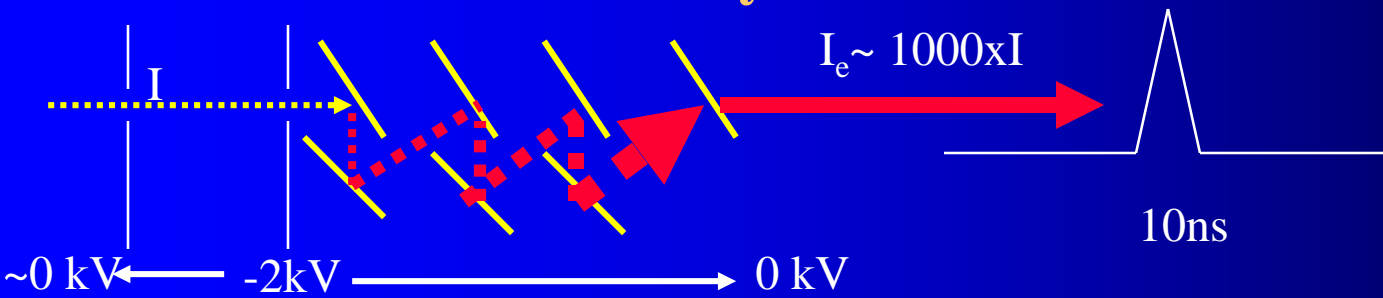
High Resolution Mass Spectrum



3	3He+	3.016030
	T+	3.016050
	HD+	3.021825
	H3+	3.023475
4	4He+	4.002600
	HT+	4.023875
	D2+	4.028204
	H2D+	4.029650

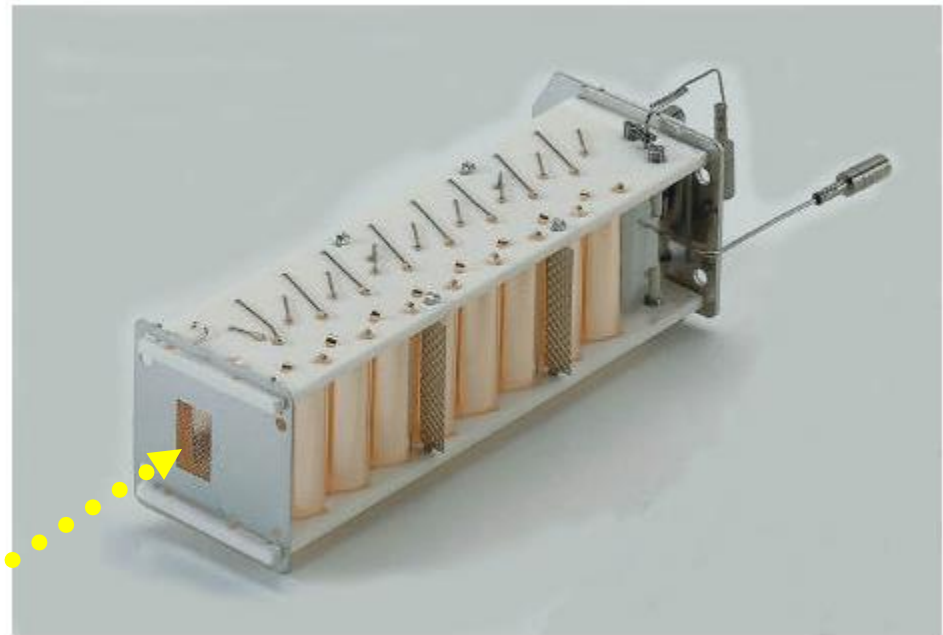


Ion detector – Discrete dynode SEM

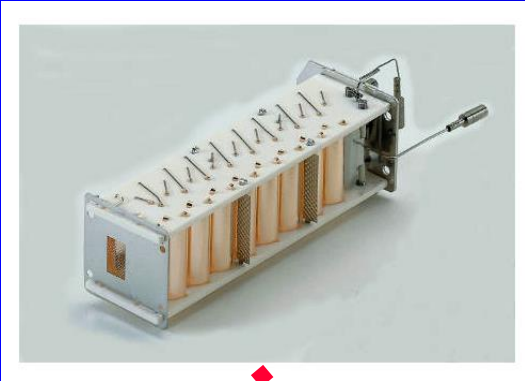


■ Ion Detection

- Discrete Dynode SEM
- Bakeable to 400°C
- for analog amplification and for pulse counting
- Low noise (< 0.1 cps)



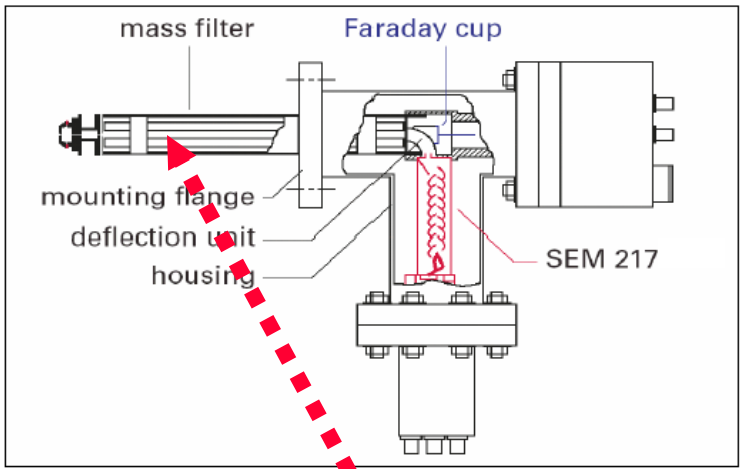
IONS



90° off axis arrangement

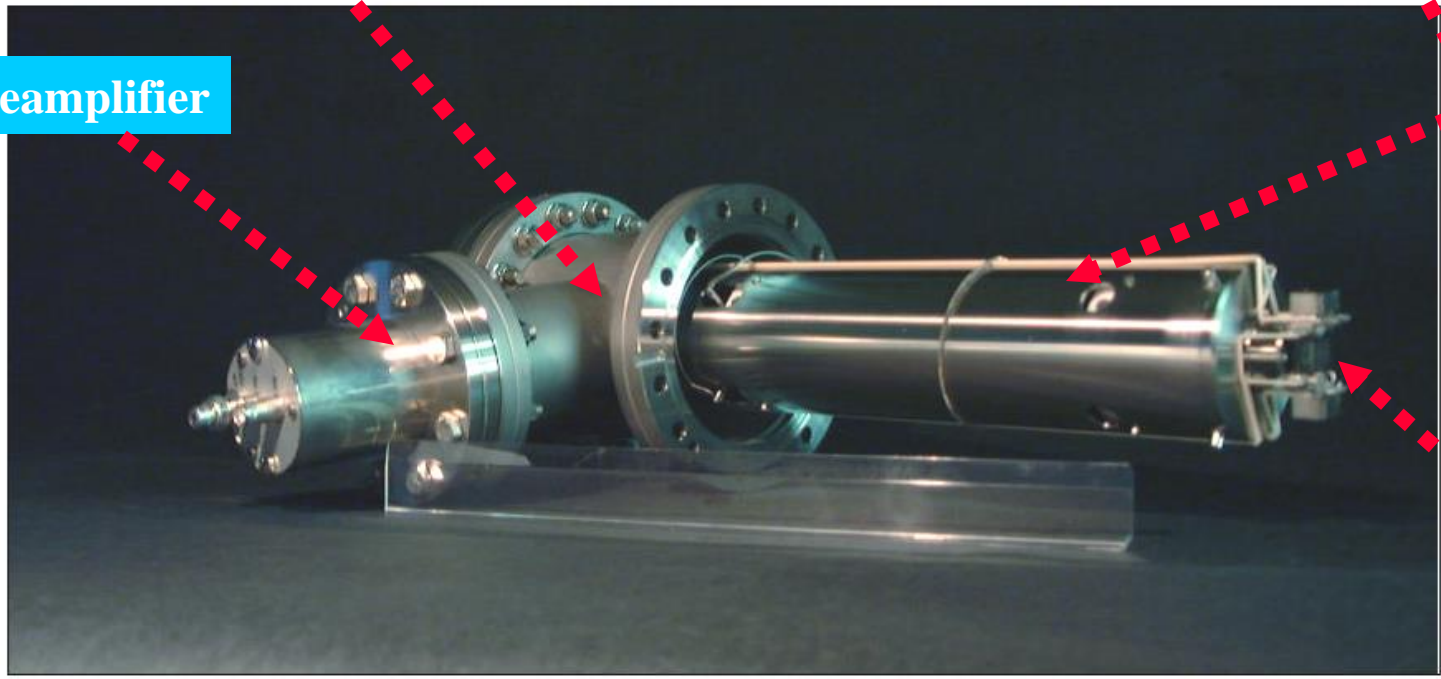
efficient suppression of

- photons
- fast neutral particles
- stray ions



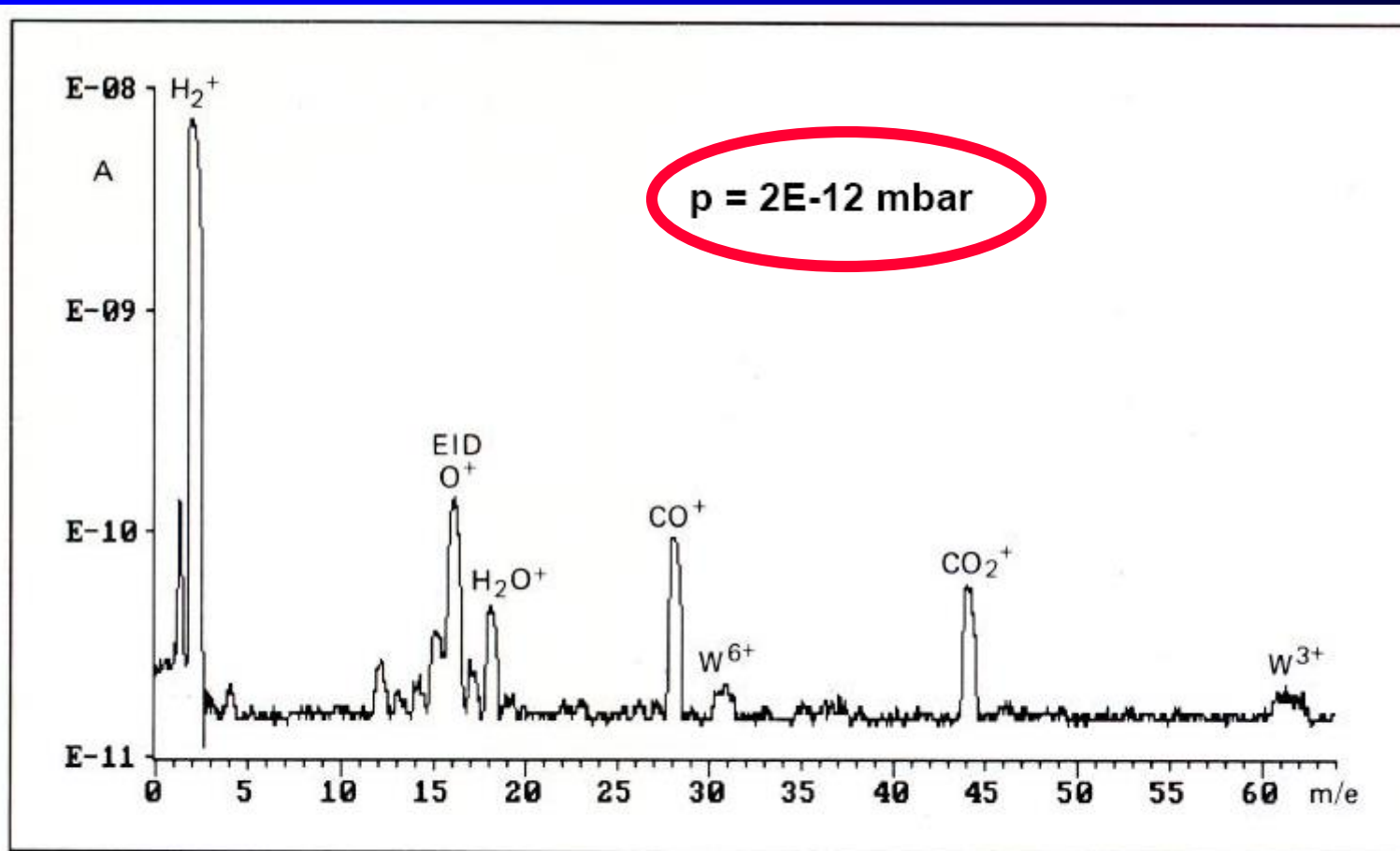
QMA 410 with Cross Beam ion source and 90° off axis SEM

Preamplifier



Cross Beam SOURCE

Mass spectrum



W.K. Huber, N. Müller, and G. Rettinghaus, *Vacuum*, 41, 2103 (1990)

Typical UHV spectrum

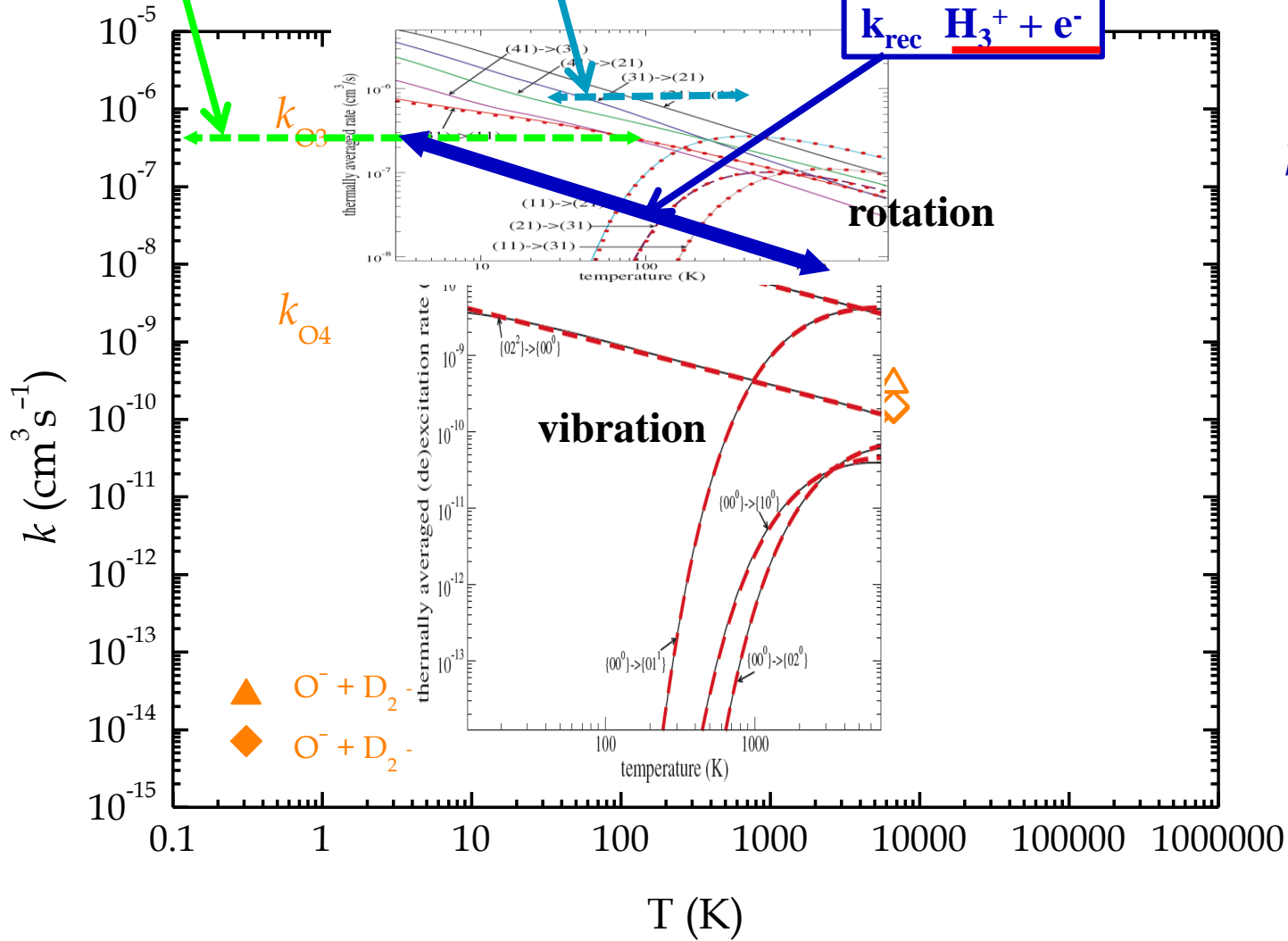
$E/k \leftrightarrow T$
 1eV ~ 11 400 K
 1K ~ 9×10^{-5} eV

Electron impact rot. vibr. excitation/deexcitation H_3^+

$k = \langle v\sigma \rangle \sim 4 \times 10^{-7} \text{ cm}^3 \text{ s}^{-1} \text{ SF}_6$

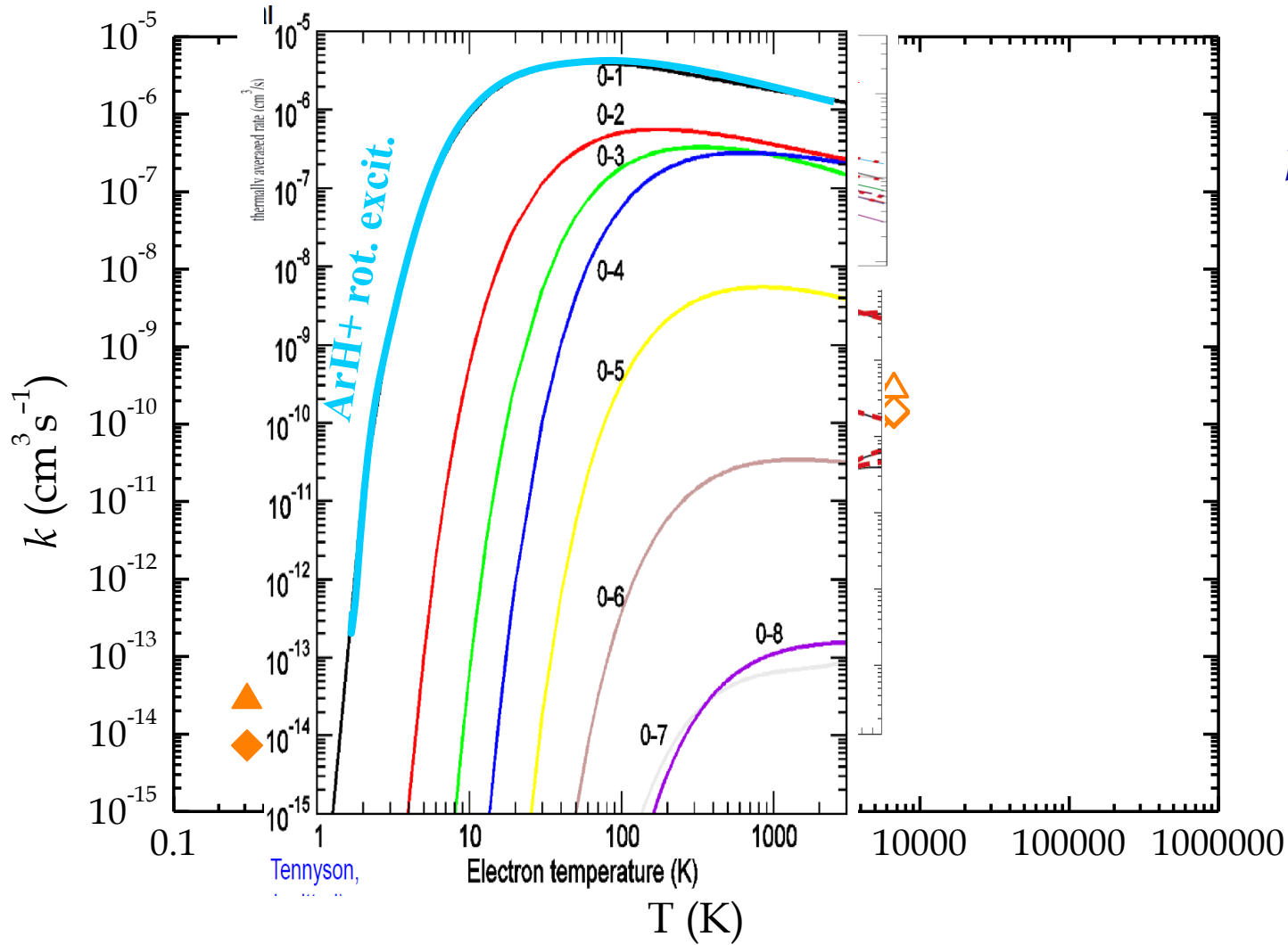
$k \sim 4 \times 10^{-6} \text{ cm}^3 \text{ s}^{-1} \text{ H}_5^+ + \text{e}^-$

$k_{\text{rec}} \text{ H}_3^+ + \text{e}^-$



$E/k \leftrightarrow T$
1eV ~ 11 400 K
1K ~ 9×10^{-5} eV

Electron impact rotational excitation of ArH⁺



$E/k \leftrightarrow T$
 1eV ~ 11 400 K
 1K ~ 9×10^{-5} eV

Electron impact rot. vibr. excitation/deexcitation H_3^+

$k = \langle v\sigma \rangle \sim 4 \times 10^{-7} \text{ cm}^3 \text{ s}^{-1} \text{ SF}_6$

$k \sim 4 \times 10^{-6} \text{ cm}^3 \text{ s}^{-1} H_5^+ + e^-$

$k_{\text{rec}} H_3^+ + e^-$

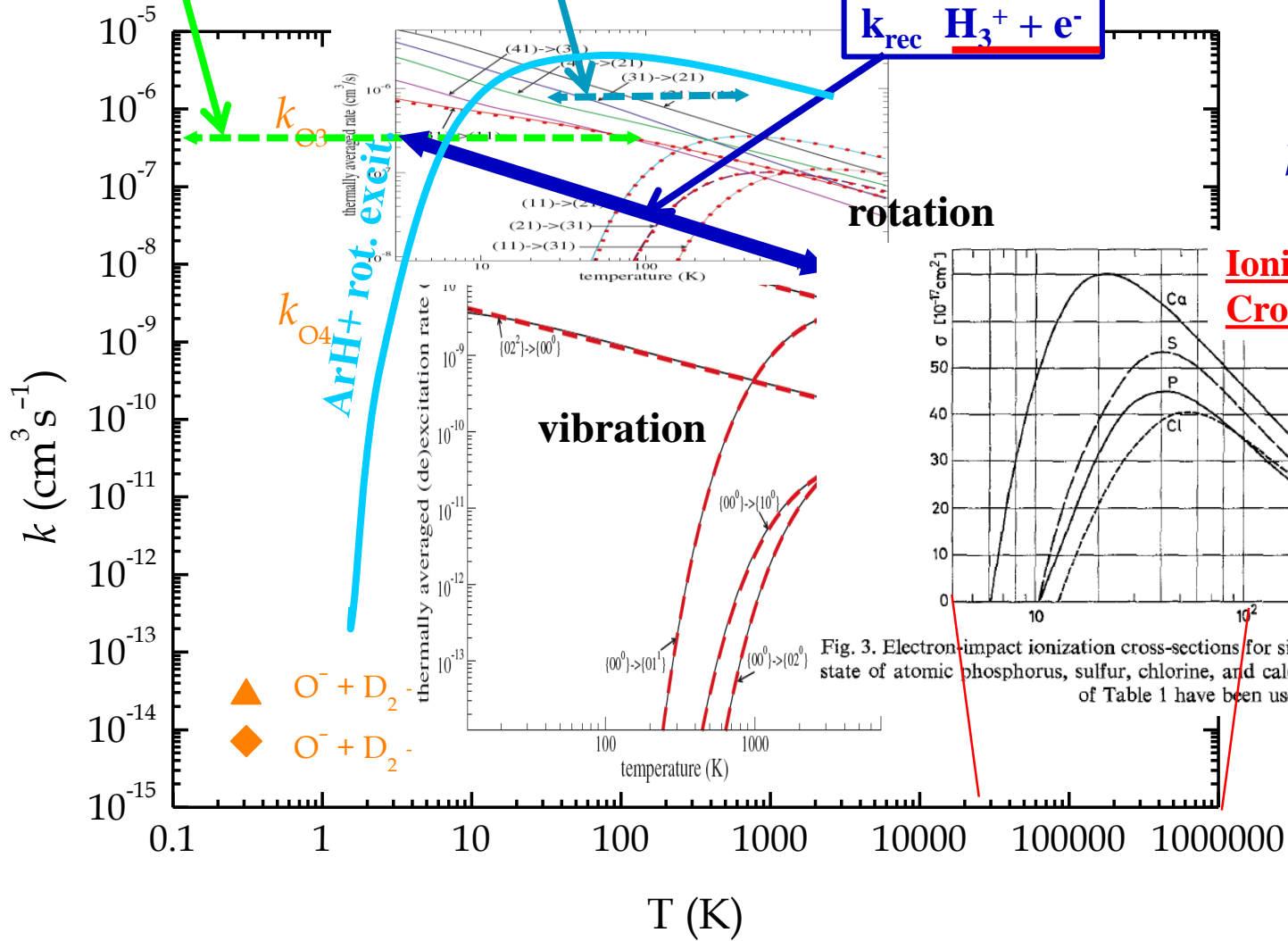


Fig. 3. Electron-impact ionization cross-sections for single ionization from the ground state of atomic phosphorus, sulfur, chlorine, and calcium. Formula (1) and the data of Table 1 have been used

$E/k \leftrightarrow T$
 1eV ~ 11 400 K
 1K ~ 9×10^{-5} eV

Electron impact rot. vibr. excitation/deexcitation H_3^+

$k = \langle v\sigma \rangle \sim 4 \times 10^{-7} \text{ cm}^3 \text{ s}^{-1} \text{ SF}_6$

$k \sim 4 \times 10^{-6} \text{ cm}^3 \text{ s}^{-1} \text{ H}_5^+ + e^-$

$k_{\text{rec}} \text{ H}_3^+ + e^-$

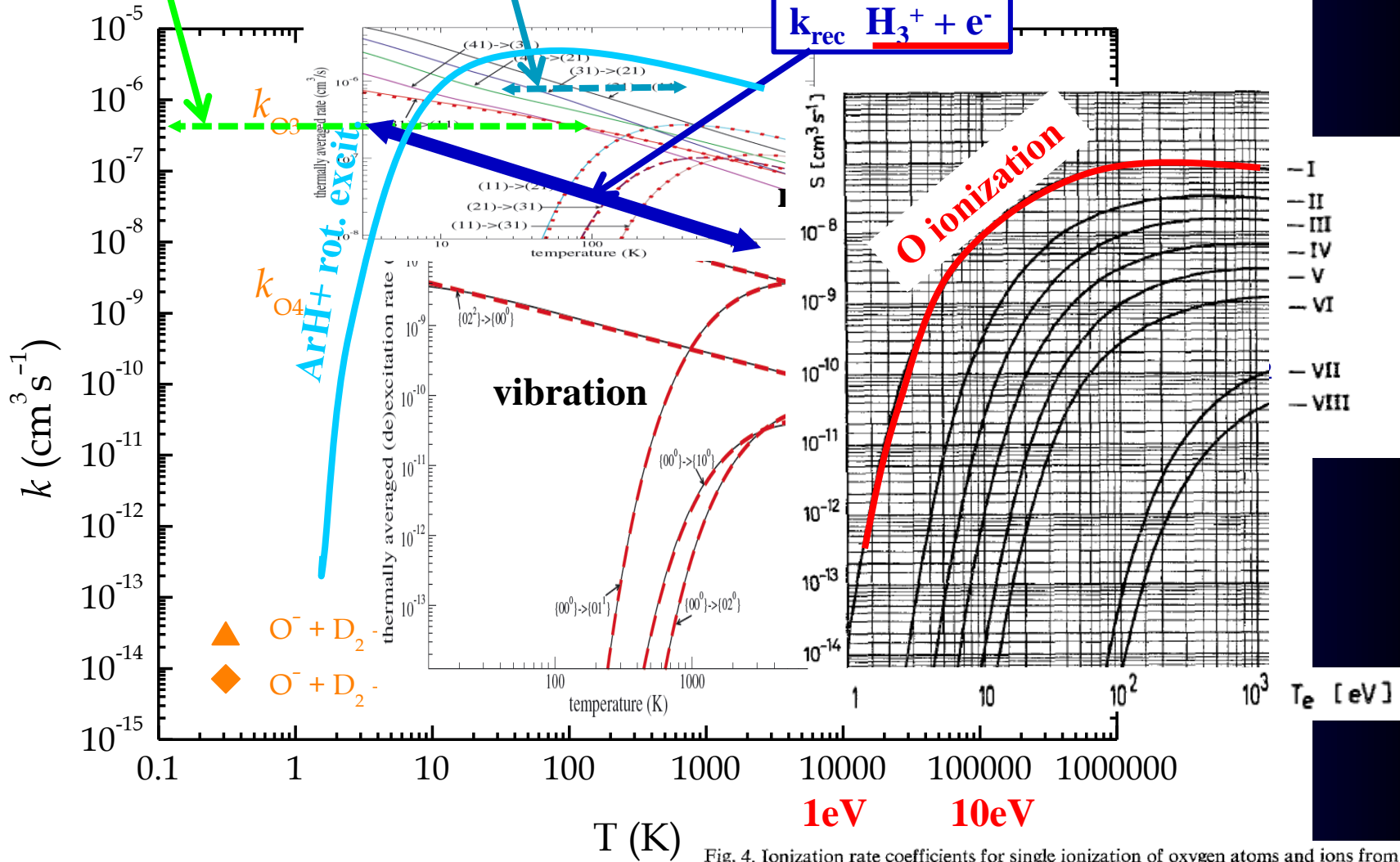


Fig. 4. Ionization rate coefficients for single ionization of oxygen atoms and ions from the ground state by electron-impact in a tenuous plasma (Maxwellian distribution, no lowering of ionization potential, no collision limit)

See You next week

